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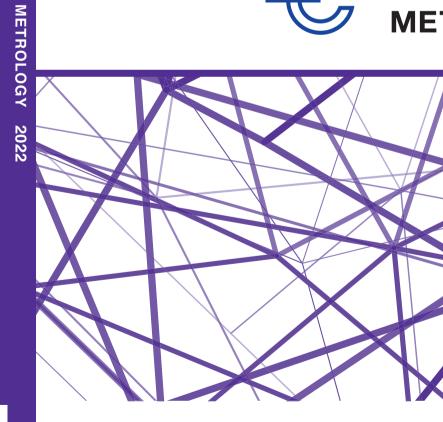
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Precision and Advanced Metrology Quality Assurance Always







www.cairnhill.com

CAIRNHILL **METROLOGY**



Cairnhill Metrology is an industrial metrology solutions provider established on 16 August 1983. Working long-term, we partner with principals who are global leaders in their fields, whose strengths in technology and innovation, we complement with up-to-date uniform high standards of service delivery through our network of offices in Singapore, Malaysia, Indonesia, the Philippines and Thailand.

Our Vision is to be the trusted industrial metrology solutions provider of choice to our customers.

Our **Mission** is to support our customers' quests for production efficiencies and quality via appropriate and reliable metrology solutions, supported throughout the solutions' useful lives.

Our Values are summed up in the Golden rule, "What you wish that others do to you, do so to them".

Our Solutions are focussed by groups:

- Food, Pharmaceutical Industrial Solutions (FPIS)
- Portable Metrology (PMT)
- Industrial Metrology (IMT)
- Industrial X-Ray Computed Tomography (XCT)
- Software for Visualization, Analysis, Metrology, Process Control and Reverse Engineering

Precision and Advanced Metrology (IMT and XCT)

Our precision and advanced metrology solutions include X-Ray CT for inspection, analysis and metrology; latest CMMs equipped with tactile, optical and laser sensors, Micro CMMs for 2D/3D feature measurements and surface profiling, Surface, Form and Geometry metrology solutions, length metrology measurement, handheld tools and Software that supports and complements all of the above.

Productivity

Reliable precision and advanced dimensional metrology facilitate innovation, creativity and productivity for manufacturers by reducing first article set-up times, allowing complex new designs to be measured and inspected and via at the line monitoring which supports yields enhancements and process control. These solutions can also be applied for research and development and for advanced analysis.

Reliability

Our solutions are from our long term partnerships with Osaka Seimitsu, Tokyo Seimitsu, Starrett and Nikon as well as newer principals such as GE Phoenix and Volume Graphics. These leaders in their respective fields, offer reliable and innovative leading-edge, sometimes breakthrough solutions.

Traceability

We are accredited by SAC-Singlas for Singapore, Malaysia, Thailand and the Philippines and by KAN for Indonesia, for field calibration activities to ISO IEC 17025; to ensure the traceability of measurements performed by the calibrated instruments to the primary SI units within expressed uncertainties.

Quality is a continuous learning process quest and journey, as we continually add on to our scope of test procedures and range of instruments as well as constantly strive to improve our calibration measurement capabilities and accuracies, for the benefit of our customers and industry partners.



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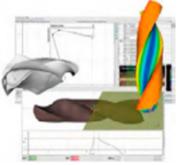
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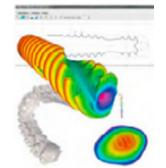
ALICONA Key Markets & Applications

Alicona hi-resolution automated and traceable 3D optical metrology supports laboratories and production in verifying accuracies for higher reproducibility and reliability of processes and standardization.



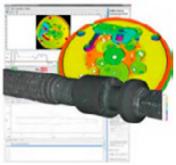
Tool Industry

Verify cutting edge preparation, bevel geometry, define correct machining parameters, surface finish of cutting quality, edge chipping throughout profile roughness measurement, full form measurement with Real3D technology and Reverse Engineering.



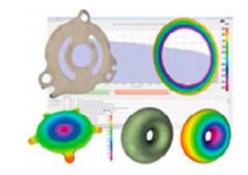
Medical Technology & Pharmaceutics

High surface finish roughness of dental, Automatic measurement of micro gears, knee, hip and spinal disc implants, pills complex shapes with small radii, high capsules, orthodontic brackets, or packaging products and materials, reflective properties, dies, stamping and surgical instruments, needle protection for syringes, fusion tubes and others produced by plastic injection molding.



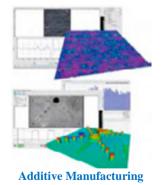
Micro Precision Manufacturing

volume angles, composites with forming parts, shape and roughness within one single measurement, dimensional accuracy, finish quality, failure analysis.

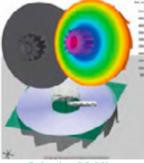


Automotive Industry

Evaluation of fuel injection nozzles, valves, connecting rods, envelopes, valve seat roundness, cam, engine and transmission components, pump systems, car body, steel and honed surfaces, optical and haptic characteristics of car seats and dashboards.

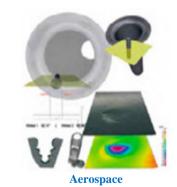


Optimize 3D printing process, quality Quality assurance and measurement of Automated measurement of cooling achieve optimum finishing process, e.g. throughout polishing



Injection Molding

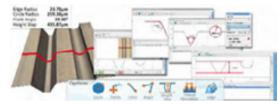
assurance of additive manufactured parts, precision molds, micro molds, eroded holes, turbine blade edges, milling and porosity analysis, 3D measurements to molds, electrodes including surface finish cutting processes of hard-to-machine surface areal measurement, process optimization



texture materials, edge and geometry of turbine discs plus inspections, failure analysis and quality assurance of various materials and geometries.

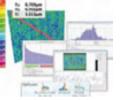
InfiniteFocus[®] Measurement Modules

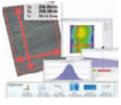
Accurate and repeatable form, surface and geometry measurement including edge measurements.



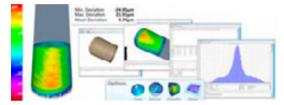
Profile-Form – Radii, angle, height steps, distances, circum- and in-circle profiles, thread parameters, cutting edges, basket arch form, wedge angles and bevel lengths

2D Roughness – Ra, Rq, Rz per ISO 4287/4288, waviness, frequency, statistical bearing ratio curve or spectral analysis graphically visualized.

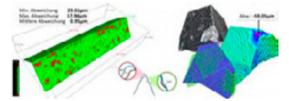




Areal Surface Texture – Sa, Sq, Sz per ISO25178 with statistics, fractal dimension, gradient, spectral distribution, local homogeneity, Roughness filtered from 3D waviness.



3D Form Module – Automatic fitting of spheres, cones and cylinders to measured geometries and curved surfaces for visualization with analysis of form deviation from nominal.



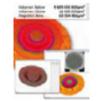
Difference – Compares form deviations or two geometries, e.g. wear before and after cutting tool use to a CAD-dataset



Multi-Measurement – Users define measurements automatically or merged. Settings are saved for fully automatic repeat measurements



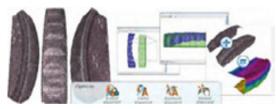
Automation – Customisable repeat measurements with script-language



Volume – Pits and peaks. Easy positioning of cutting layers as a universal tool



Contour Module – Measures angles, distances, circles, thread pitch etc. from every position. Handles complex profiles for e.g. along a helix with roughness also measured.



Fusion – Merge individual measurements at various positions into 3D data set for visualization from different angles



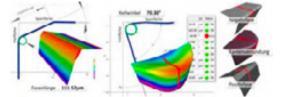
MetMeX – Perform robust measurements with the µCMM users do not need any specific metrology knowledge



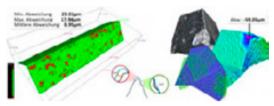
2D Image – Circles, lines, angles, distances, ellipses, rectangles etc.

InfiniteFocus[®] Tool Measurement

Used by leading manufacturers for visual, traceable, repeatable high-resolution quality assurance of cutting tools edges, geometries and elliptical-fit roughness, edge break and ridges, etc.



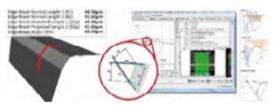
Measurement of Radius and Form – Radius-fit, clearance angle (α), wedge angle (β), rake/chipping angle (γ), edge symmetry (K), \pm ve projected / true bevel lengths and angles



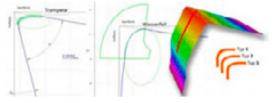
Form Deviation with Difference Measurement – 3D measurements compared to CAD with min/max/mean deviations visualised graphically in colour



Chipping Measurement – High res measurement of ISO 4287 parameters (Ra, Rq, Rz, Rp, Rv) to view defects along edge



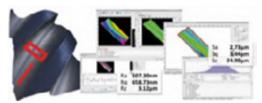
Chamfer Measurement – Measures edge break, chamfer width, angles, normal distances and other ISO 1375 parameters



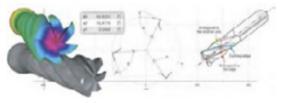
"True" Contour Through Elliptic Fit – Waterfall or Trumpet fit into edge region describes shape by two radial parameters. Compares edge to basket arch files of arbitrary shape



Flash (Burr) Measurement – Flash Width and Height to predict potential wear of molding tools in inserts



Tool Roughness Measurement – Measure tool roughness both profile and areal based in addition to chipping along the edge



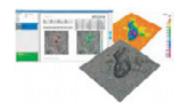
Angle Measurement – Measure clearance/wedge/rake angles of inserts, drills, end mills and other round tools.

Applications for the Aerospace Industry

Non-contact Measurement of Critical Turbine Engine Components



Automatic Measurement of Cooling Holes – Automatically verifying angle, size, and shape of up to 500 cooling holes, some of them with different shapes



Automatic Defect Measurement – Quantitatively detect defects on larger surfaces as well as component edges with Area-based 3D measurements.

Variable Focus 3D Form & Surface Measurement

Bruker alicona

Focus Variation The Technical Principle

Focus-Variation combines the small depth of focus of an optical system with vertical scanning to provide topographical and color information from the variation of focus. The main component of the system is a precision optics containing various lens systems that can be equipped with different objectives, allowing measurements with different resolution.

In contrast to other optical techniques that are limited to coaxial illumination, the max. measurable slope angle is not only dependent on the numerical aperture of the objective. Focus-Variation can be used with a large range of different illumination sources (such as a ring light) which allows the measurement of slope angles exceeding 87°



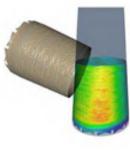
Focus Variation

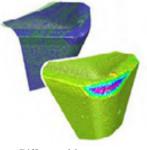
Real3D Technology Full Form Measurement



Using Real3D, users measure surfaces from numerous perspectives. Single measurements are then automatically merged into a full 3D dataset. High-precision and calibrated rotation and tilt axes ensure automated, repeatable and traceable measurement of form and roughness on the whole measurement object. Users are able to visualize and measure surface features such as diverse flank angles, thread pitch and undercuts.







Fusion Measurement

Contour Measurement

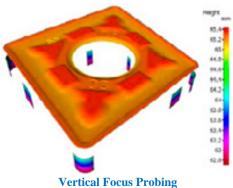
3D Form Measurement

Difference Measurement

Vertical Focus Probing Lateral Probing of Components

Vertical Focus Probing, an extension of Focus-Variation technology, allows the measurement of geometries such as bore holes of injection valves in the automotive industry, and steep flanks $>90^{\circ}$ with high accuracy in high resolution and short measuring times.

Vertical Focus Probing can be used for a wide range of applications in dimensional metrology such as tooling, precision manufacturing, automotive, aerospace industries etc.



Application of InfiniteFocus Systems



PTB traceable Roughness Standard for optical and tactile roughness

PTB traceable Cal Tool with 1000µm step height and chess patterns for lateral verification

PTB traceable Form Verification Tool with steep slopes, angles and cylinder artefacts

International Standardization

ÖNORM 1388	Geometrical product specification and verification (GPS) - Guide for operation and definition of the competence of operators of optical surface topography measurement devices
ISO 25178-6	Geometrical product specifications (GPS) – Surface texture: Areal – Part 6: Classification of methods for measuring surface texture
ISO 25178-606	Geometrical product specification (GPS) Surface texture: Areal Part 606: Nominal characteristics of non-contact (focus variation) instruments
VDI/VDE 2617, 12.2 (draft)	Accuracy of coordinate measuring machines – Characteristics and their testing – Acceptance and reverification tests for optical CMM measuring microgeometries

InfiniteFocus[®] G6 ^{NEW!} Unrivaled Measurement Performance

- Advanced Focus-Variation combines the functionalities of a roughness measuring system and a coordinate measuring machine with vibration-insensitive design for high-resolution and repeatable results, that is ideal for manufacturing
- Expansion from 3 to 5 axes allows measurements of geometries that are otherwise difficult or impossible to access
- High-precision tilting and rotating axes enable the measurement of GD&T and roughness parameters on the entire measured object
- Integrated **SmartFlash 2.0** technology ensures high-resolution measurement of smooth, reflective and highly polished surfaces
- Real3D turns individual measurements into a complete 360° data set
- MetMaX user software allows users to specify measurements already in the CAD model of a component
- Single-button solutions and automated measurement sequences ensure efficient workflows and measurements without user interaction
- Digital Twin combined with a virtual measurement simulation enables safe operation of the measuring instrument
- Vertical Focus Probing enables the optical, lateral probing of components. Users measure holes and vertical flanks (>90°)
- Applications: complex tools, drills, milling cutters, micro-electronics, die casts, paper, forensics, airfoil blades, etc.



InfiniteFocus® G6

	InfiniteFocus G6					
Measure	ement Principal	Non-contact, optical, three-dimensional Technologies: Advanced Focus-Variation (SmartFlash 2.0), Vertical Focus Probing, Real3D				
Number of measurement points		Single measurement: X: 2160, Y: 2160, X x Y: 4.6 million mageField: up to 500 million				
Positioni	ing Volume X x Y x Z	$00x200x180mm = 7,200,000 mm^3$				
Positioning Volume (R x T)		Optional AdvancedReal3D Rotation Unit: Motorized rotation: 360° /Motorized tilt: -15 to +90°				
Coaxial illumination		LED coaxial illumination (color), high-power, electronically controllable; optional wireless white LED ring light illumination				
System r	monitoring	Automatic self-diagnosis due to temperature sensors, internal current and voltage monitoring				
ControlS	ServerSF	6 Core, 32GB DDR4, SSD 512GB, Win 10 IoT Enterprise 64-bit, 2x27" Full HD LED Monitor				
:	Surface texture	Any surface, including polished metals; no preparation required				
Sample	Dimensions	Up to 315mm height and 30kg weight (more on request) / 5-axes: Up to 4kg				
]	Measurable Slope Angle	Advanced Focus-Variation: 87° / Vertical Focus Probing: > 90°				

Objectives ¹	3000 WD8	1900 WD30	800 WD37 ²	800 WD17	400 WD30 ²	400 WD19	150 WD11	80 WD4
Working Distance	8.8mm	30mm	37mm	17.5mm	30mm	19mm	11mm	4.5
Lateral Measurement Range (X,Y)	5.3mm	3.8mm	1.6mm	1.6mm	0.8mm	0.8mm	0.3mm	0.16mm
Measurement Point Distance	2.88µm	1.77µm	0.72µm	0.72µm	0.36µm	0.36µm	0.14µm	0.07µm
Measurement Noise	800nm	80nm	40nm	15nm	20nm	5nm	2nm	1nm
Vertical Resolution	2300nm	250nm	130nm	50nm	80nm	30nm	15nm	10nm

¹ Objectives with longer working distance available upon request. ² Objective available in special objective configuration.

Resolution and Application Specifications

				—				
Objectives	3000 WD8	1900 WD30	800 WD37	800 WD17	400 WD30 ²	400 WD19	150 WD11	80 WD4
Min Measurable Roughness (Ra)	-	-	0.7µm	0.18µm	0.24µm	0.12µm	0.05µm	0.03µm
Min Measurable Roughness (Sa)	-	-	0.35µm	0.09µm	0.12µm	0.06µm	0.025µm	0.015µm
Min Measurable Radius	20µm	12µm	5µm	5µm	3µm	3µm	2µm	1µm

InfiniteFocusSL / IF-Sensor R25 Cost-Efficient Measurement





InfiniteFocusSL

- Compact Focus-Variation head with machining centre
 Measures large bevel length
 Special coarse drive for easy focusing on the insert
- Measure flanks up to 90°

Common for both InfiniteFocusSL and IF-Sensor R25

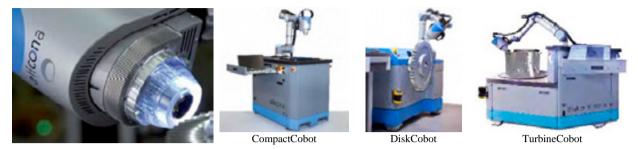
- Very fast, easy to use, high resolution, traceable and repeatible
- · Form and finish measurement on micro structured surfaces
- Robust frame. Intelligent adjustable optimized illumination for hi-res laboratory and production measurements. Insensitive to ambient light, temperature fluctuations and vibrations
- · Registered true colour high contrast high depth-of-focus images
- Up to 33mm working distance and 50x50mm FOV
- · Measure within seconds. Coaxial laser for intuitive positioning and quick and easy focusing
- For cutting edge tool measurement to quality assurance and surface finish of micro components and hard-to-access surface positions for eg, steep flanks and surfaces on gear tooth root. Miscellaneous export and print options

	InfiniteFocusSL	IF-Sensor R25			
Measurement Principle	Non-contact, optical, three-dimensional, based on Focus-Variation				
Ring Light Illumination	White LED high-power ring light, 24segments				
Positioning Help	Coaxial laserbeam				
Machine Dimensions W x D x H / Weight	195 x 340 x 485mm / 15kg	134 x 153 x 220mm / 4kg			
Measurement Object	Surface topography Ra $\geq 0.009 \mu m$ with $\lambda c 2\mu m$; depending on surface structure				

Objectives	10X	20X	50X	2XSX	5XAX	10XAX	20XAX	50XSX
Min Measurable Radius	5µm	3µm	2µm	20µm	10µm	5µm	3µm	2µm
Measurable Min Wedge / Max Slope Angle				20° .	/ 87°			
Min Measurable Roughness Ra	0.3µm	0.15µm	0.08µm	N	/A	0.45µm	0.25µm	0.15µm
Min Measurable Roughness Sa	0.15µm	0.075µm	0.05µm	N	/A	0.25µm	0.1µm	0.08µm
Objectives Working Distance	17.5mm	13mm	10.1mm	341	nm	33.5mm	20mm	13mm
Lateral Measurement X, Y	2mm	1mm	0.4mm	10mm	3.61mm	2mm	1mm	0.4mm
Lateral Measurement X x Y	4mm ²	1mm ²	0.16 mm ²	100mm ²	13.03mm ²	4mm ²	1mm ²	0.16 mm ²
Measurement Point Distance	1µm	0.5µm	0.2µm	5µm	2µm	1µm	0.5µm	0.2µm
Measurement Noise	40nm	20nm	10nm	1240nm	165nm	45nm	25nm	15nm
Vertical Resolution	100nm	50nm	20nm	3500nm	460nm	130nm	70nm	45nm
Vertical Measurement Range	16mm	12mm	9mm	nm 25mm			19mm	12mm
Max Extended FOV	2500mm ² 11		1100mm ²	2500mm ²				1100mm ²
Max Uni-Directional Measurement	50mm							

* Objectives with higher working distance available upon request.

Cobot Collaborative systems enable modern production strategies



- · Combine a collaborative 6-Axis robot with IF-Sensor R25 for hi-resolution, traceable and repeatable measurements
- Tailored to individual application. Programming, measuring and handling of pre-defined measurement programs require no prior metrology knowledge. Manual or automatic mode. Can be integrated into production line.
- DiscCobot to measure turbine discs. ToolCobot to measure tools directly in the machine. CompactCobot, a universal solution applicable in all industries to measure micro structured surfaces of large components

	CompactCobot	DiscCobot	TurbineCobot			
Dimensions H x W x L	0.95 x 0.79 x 1.35m	1 x 1 x 0.9m	1.5 x 0.95 x 2.15m			
Machine Weight	400kg	1,500kg	900kg			
Additional Axes	N/A	Rotation axis	Rotation table; Lifting axis with 400mm travel range			
Max Sample Weight	100kg	100kg 150kg				
Operation	Drawer with 10.5" touchscreen	brawer with 10.5" touchscreen N/A				
Interface	Hold grid plate for mounting different sample holders	Flexible perforated plate for mounting of grips	Taper50 interface/other options plus flexible perforated plate			
Additional Features	Integrated status lights; 4 emergency stops each corner	Laser scanner for additional monitoring of operating range	Height-adjustable casters for flexible use			
Robot Type		UR-10				
Specimen Radius		1300mm				
Safety	Collaborative – stops at co	Illision with an object; Certified by	y TÜV Nord and TÜV Süd			
Axes / Repeatability		6 rotating joints / ±0.1mm				
Operation	Manual coarse positionin	g of the sensor; Fine positioning p	recise joystick movement			
Display	Integrated touchscreen to	display the live view and 3D view	w of the measured dataset			
Software Compatibility	AutomationManager: Easy measurement sequence teach-in by adding robot positions, SingleField and ImageField measurement. CADCAM: Virtual planning of measurement sequence on CAD model including simulation of the measurement task.					

Industry 4.0 Support - From Production Measurement to Smart Manufacturing



Production measurements must be highly accurate, fast and easy to use and automatable for fast ROI

Industry 4.0 industrial revolution factory concept connects machines with sensors as a system to visualize the entire production line to control and make decisions on its own for automation and data exchange that include cyber-physical systems, the industrial internet of things (IIOT), cloud computing, cognitive computing and artificial intelligence.

The result is reduced measuring set up time to ensure component and process quality and efficient production by integrating production strategies for self-controlling production.

Measuring sensors are usually optical and tactile. Requirements include Cg and Cgk capability, repeatability, traceability to SI units, good measurement uncertainties, stability in tough environmental conditions, ease of use and of automation, short set-up times, flexibility for redeployment, future-proof easy connection and integration into existing systems and costs.



Bruker alicona

EdgeMaster Automatic Cutting-Edge Measurement





EdgeMasterX

• Easy to use traceable micro-structure surface form and finish measurement • Specific

- Robust frame; intelligent optimized illumination for hi-res applications. Insensitive to ambient light, temperature fluctuations and vibrations
- Registered true colour high contrast and high depth-of-focus images
- Up to 33mm working distance and 50x50mm FOV
- · Coaxial laser for intuitive positioning and quick focusing
- Measures in seconds! Edges of inserts, drills, millers and other round tools regardless of type, size, material or surface finish



EdgeMasterHOB

- Specific adaption of Optical Cutting Edge metrology device
- Large 33mm working distance for effortless measurement of cutting edges even in deep recessed areas
- Measures hob cutters at every stage of manufacture, regardless of surface finish or coating

	EdgeMaster / EdgeMasterX	EdgeMasterHOB Specifications
Positioning Volume	RL objectives: 50 x 50 x 155mm (Z: 25mm motorized; 130mm manual) SXRL/AXRL objectives: 50 x 50 x 120mm (Z: 25mm motorized; 95mm manual)	Z: 25mm motorized; 92mm manual /
Machine Dimensions W x D x H	195 x 340 x 485mm	555 x 400 x 502mm
Machine Weight	15kg	30kg
Max Sample Weight	4kg, more on request	30kg, more on request

EdgeMaster / EdgeMasterX / EdgeMasterHOB Objectives Features

8	0		0		•			
Objectives ¹	10X	20X	50X	2xSX	5xAX	10xAX	20xAX	50xSX
Working Distance	17.5mm	16mm	10.1mm	34mm	34mm	33.5mm	20mm	13mm
Lateral Measurement X,Y	2mm	1mm	0.4mm	10mm	3.61mm	2mm	1mm	0.4mm
Lateral Measurement X x Y	4mm ²	1mm^2	0.16mm ²	100mm^2	13.03mm ²	4mm^2	1mm ²	0.16mm ²
Measurement Point Distance	1µm	0.5µm	0.2µm	5µm	2µm	1µm	0.5µm	0.2µm
Calculated Lateral Optical Resolution		N	/A		2.33µm	1.17µm	0.78µm	N/A
Best Lateral Topographic Resolution		IN,	A		4µm	2µm	1µm	
Measurement Noise	40nm	20nm	10nm	1240nm	165nm	45nm	25nm	15nm
Vertical Resolution	100nm	50nm	20nm	3500nm	460nm	130nm	70nm	45nm
Vertical Measurement Range	16mm	15mm	9mm	25mm	25mm	25mm	19mm	12mm
Accessibility	31°	29°	19°	40°	51°	51°	39°	26°

* For EdgeMasterHOB, only Objectives: 5xAX, 10xAX and 20xAX apply. ¹ Objectives with longer working distance available upon request.

EdgeMaster / EdgeMasterX Resolution and Application Specifications

-	-				-			
Objectives	10X	20X	50X	2xSX	5xAX	10xAX	20xAX	50xSX
Min Measurable Radius	5µm	3µm	2µm	20µm	10µm	5µm	3µm	2µm
Min Wedge Angle / Max Slope Angle	20° / 87°							
Min Measurable Roughness Ra	0.3µm	0.15µm	0.08µm	N	/ •	0.45µm	0.25µm	0.15µm
Min Measurable Roughness Sa	0.15µm	0.075µm	0.05µm	N/A		0.25µm	0.1µm	0.08µm
Max Bevel Length	800µm	400µm	160µm	4000µm	2000µm	800µm	400µm	160µm

InfiniteFocus[®] XL Extra Large Stage



InfiniteFocus® XL1000

Alicona's X-Large InfiniteFocus are used for high resolution, optical 3D measurement of large and heavy components. Max sample travel ranges of 500 x 500mm and 1000 x 1000mm and max weight of up to 200kg, more on request. For automatic defect analysis of large measurement fields or dimensional measurement of laser structured geometries on printing plates. Automation interface allows full auto measurement in production.

	InfiniteFocusXL500	InfiniteFocusXL1000		
Measurement Principle	Non-contact, optical, 3D,	based on Focus-Variation		
Positioning Volume X x Y x Z	500 x 500 x 100mm	1000 x 1000 x 100mm		
Maintenance	Maintena	ance free		
Coaxial Illumination	white LED coaxial illumination, hig	h-power, electronically controllable		
Ring Light Illumination Option	white LED high-power ring light, 24	segments, wireless, snap-on system		
Dimensions W x D x H / Weight	900 x 1100 x 800mm / 500kg	1680 x 785 x 1700mm / 3080kg		
Objectives	2.5x, 5x, 10x, 20x, 50x, 100x	2.5x, 5x, 10x, 20x, 50x, 100x		
Ambient Temperature Range	Measurement Instrument: 18 to 28°C; calibrated for: 18 to 22°C (can be calibrated for ot temperature ranges); ControlServerHP: 0 to 30°C			
Temperature Gradient	Less that	n 1°C/h		
Relative Humidity	Recommended: 45% (±5%	%); Possible: 45% (±15%)		
Power Supply / Consumption	AC 100 to 240V,	50/60Hz / 2000W		
ControlServerHP Dimensions	200 x 485 x 4	40mm / 19kg		
ControlServerHP Specifications	4-Core, 32GB DDR4, 2TB, Windows [®] 10 IoT Enterprise, 27" LED Monitor, integrated USI			
Sample Surface Texture	Surface topography Ra above $0.009\mu m$ with $\lambda c 2\mu m$; depending on surface structure			
Sample Max Height	100mm; more on request			
Sample Max Size / Weight	500mm x 500mm / 10kg	1000mm x 1000mm / 200kg		

IF-Profiler Mobile 3D Surface Profilometry

- Flexible, handheld, surface roughness verification near or in production for large and heavy components
- Ergonomic lightweight sensor with mechanically rigid frame
- Flexible position change and fast measurement speed
- · Ideal for turbine or rotor blades, steel and body type surfaces



IF-Profiler

Objectives	10X	20X	50X	
Sampling Distance	1µm	0.5µm	0.2µm	
Min Vertical Repeatability	40nm	20nm	25nm	
Max Scan Height (Approx.)	16mm	12mm	9mm	
Best Vertical Resolution	100nm	80nm	60nm	
Working Distance	17.5mm	13mm	10.1mm	
Lateral Measurement X, Y / X x Y	2mm / 4mm ²	1mm / 1mm ²	$0.4 mm / 0.16 mm^2$	
Min Measurable Radius	5µm	3µm	2μm	
Min Wedge Angle / Max Slope Angle		20° / 87°		
Min Measurable Roughness Ra / Sa	0.3µm / 0.15µm	0.24µm / 0.12µm	0.18µm / 0.09µm	
Z Travel Range / Illumination	26mm (motorized) / 24 segment LED ring light			
Machine Dimensions W x D x H / Weight	157 x 300 x 344mm / 6.5kg			

Variable Focus 3D Form & Surface Measurement

Bruker alicona That's metrology!

IF-PortableRL Mobile High-Resolution Measurement

- Verify measurement fields of up to 50 x 50 x 26mm
- · Battery pack for flexible use and mobile positioning
- Large vertical scanning range for various geometry types and forms
- Applications: Plate inspection, asphalt measurement, turbine or rotor blades, 3D measurement of steel & body parts, etc.



Measurement on Racetrack





Battery Pack

IF-PortableRL



IF-PortableRL

Positioning Volume X x Y x Z

Objectives	10X	20X	50X	2xSX	5xAX	10xAX	20xAX	50xSX
Numerical Aperture	0.3	0.4	0.6	0.055	0.14	0.28	0.42	0.55
Working Distance	17.5mm	16mm	10.1mm	34mm	34mm	33.5mm	20mm	13mm
Lateral Measurement X, Y	2mm	1mm	0.4mm	10mm	3.61mm	2mm	1mm	0.4mm
Lateral Measurement X x Y	4mm ²	1mm ²	0.16mm ²	100mm ²	13.03mm ²	4mm ²	1mm ²	0.16mm ²
Measurement Point Distance	1µm	0.5µm	0.2µm	5µm	2µm	1µm	0.5µm	0.2µm
Lateral Optical Limiting Resolution	1.09µm	0.82µm	0.54µm	5.93µm	2.33µm	1.17µm	0.78µm	0.59µm
Finest Lateral Topographic Resolution	2µm	1µm	0.64µm	10µm	4µm	2µm	1µm	0.64µm
Measurement Noise	60nm	30nm	20nm	1240nm	165nm	60nm	30nm	25nm
Vertical Resolution	150nm	75nm	50nm	3500nm	460nm	170nm	90nm	70nm
Vertical Measurement Range	16mm	15mm	9mm	25mm	25mm	25mm	19mm	12mm
Measurement Speed	≤1.7 million measurement points/sec							
Accessibility	31°	29°	19°	40°	51°	51°	39°	26°

¹Objectives with longer working distance available upon request.

Resolution and Application Specifications

Objectives	10X	20X	50X	2xSX	5xAX	10xAX	20xAX	50xSX
Height Step Accuracy (1mm)	0.1%							
Min Measurable Roughness Ra	0.55µm	0.25µm	0.2µm	N	/ •	0.65µm	0.3µm	0.25µm
Min Measurable Roughness Sa	0.30µm	0.15µm	0.1µm	N/A		0.35µm	0.15µm	0.13µm
Min Measurable Radius	5µm	3µm	2µm	20µm	10µm	5µm	3µm	2µm
Min Wedge Angle / Max Slope Angle	20° / 87°							

Measuring Uncertainty

Flatness Deviation	2 x 2mm with 10x objective	$U = 0.1 \mu m$
	Height step 1000µm	E _{Uni: St: ODS, MPE} = $1\mu m$, $\sigma = 0.1\mu m$
Max Deviation of Height Step	Height step 100µm	$E_{\text{Uni: St: ODS, MPE}} = 0.4 \mu m, \sigma = 0.05 \mu m$
Max Deviation of Height Step	Height step 10µm	$E_{\text{Uni: St: ODS, MPE}} = 0.3 \mu m, \sigma = 0.025 \mu m$
	Height step 1µm	$E_{\text{Uni: St: ODS, MPE}} = 0.15 \mu m, \sigma = 0.01 \mu m$
Profile Roughness	$Ra = 0.5 \mu m$	$U = 0.04 \mu m, \sigma = 0.002 \mu m$
Area Roughness	$Sa = 0.5 \mu m$	$U = 0.03 \mu m, \sigma = 0.002 \mu m$
Distance Measurement	XY up to 2mm	$E_{\text{Bi: Tr: ODS, MPE}} = 0.8 \mu m$
Wedge Angle	$\beta = 70$ to 110°	$U = 0.15^{\circ}, \sigma = 0.02^{\circ}$
Edee Dedine	$R = 5\mu m$ to $20\mu m$	$U = 1.5 \mu m, \sigma = 0.15 \mu m$
Edge Radius	R > 20µm	$U = 2\mu m, \sigma = 0.3\mu m$

Note Euni: St: ODS, MPE & EBi: Tr: ODS, MPE conform to ISO 10360-8.

50 x 50 x 25mm

µCMM Fast Focus Variation Measurements over Large Volumes



Precise - High accuracy and fast measurement over large volumes



Expandable - 3-Axis to 5-Axis system

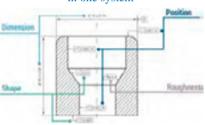
Simple - Measure matte and highly polished surfaces easily with SmartFlash



Shape and position measurement of injection nozzles



- Combines tactile and optical surface measuring technologies to measure Dimension, position, shape and roughness dimension, position, shape and roughness of components with one sensor in one system
- Most accurate purely optical micro CMM. Accuracy within $0.8+L/600\mu m$ 1 over the entire measurement volume for measuring small surface details
- Non-contact, optical measurements of matte to polished or mirrored components, plastic, PCD, CFRP, ceramic, chrome, silicon, in one system
- Intuitive usability with single-button solutions, automated measurement sequences and long-term stability ensure consistent measurement
- Wear-free, robust, suitable for production with air-bearing linear drive



μCMM				
Measuring Points	Single measurement: X: 1720, Y: 1720, X x Y: 2.95 million. Multi measurement: Up to 500 million			
Positioning Volume X x Y x Z	310 x 310 x 310mm			
Compressed Air	Maintenance-free with compressed air according to specification, 6 bar			
Axes Travel Speed	Max 100mm/s			
Coaxial Illumination	LED coaxial illumination (colour), high-power, electronically controllable			
Objective Changer	Automatic pneumatic four-place objective changer			
System Monitoring	9 temperature sensors (accuracy ±0.1K), 3 vibration sensors, internal current and voltage monitoring, including long term logging, retrievable			
ControlServerHP	4-Core, 32GB DDR4, 2TB, Windows® 10 IoT Enterprise, 2x27" LED Monitor			
Machine Dimensions W x D x H / Weight	960 x 1109 x 1958mm or up to 2288mm / 1250kg (Machine excluding PC)			
Max Sample Dimensions W x H / Weight	680 x 375mm / 30kg, more on request			
3D Accuracy ¹ (L in mm)	$E_{Uni:Tr:ODS} 0.8 + L/600 \mu m^2$. $E_{UniZ:St:ODS} 0.15 + L/50 \mu m^3$			
Flatness Deviation Accuracy	1.3mm x 1.3 mm with 800A: U = 0.1 µm			
Profile Roughness Accuracy	Ra = 0.1μ m: U = 0.012μ m, $\sigma = 0.001\mu$ m. Ra = 0.5μ m: U = 0.02μ m, $\sigma = 0.001\mu$ m			
Areal Roughness Accuracy	Sa = 0.1 μ m: U = 0.01 μ m, σ = 0.001 μ m. Sa = 0.5 μ m: U = 0.015 μ m, σ = 0.001 μ m			
Wedge Angle Accuracy	$\beta = 70^{\circ}$ to 110° : $U = 0.075^{\circ}$, $\sigma = 0.01^{\circ}$			
Edge Radius Accuracy	$R=5\mu m$ to 20 μm : $U=1.5\mu m,\sigma=0.15\mu m.~R>20 \mu m$: $U=2\mu m,\sigma=0.3\mu m$			

¹Per ISO 10360-8 and VDI 2617. ² Valid for all Multi Measurements. ³ Valid for single measurements, height step measurements.

Objectives	1500A	800A	400A	150A	80A
Working Distance	23.5mm	17.5mm	19mm	11mm	4.5mm
Lateral Measurement X, Y	2.63mm	1.32mm	0.66mm	0.26mm	0.13mm
Lateral Measurement X x Y	6.91mm ²	1.71mm ²	0.43mm ²	0.06mm ²	0.01mm ²



Waygate Technologies Overview @ a Glance





Nanotom M







V|tome|x S240

V|tome|x L450

	Nanotom M	V tome x M300	V tome x S240	V tome x	L300 450
Applications	Composites, plastics, electronics, bio, geo, metrology	AM, castings, composites, electronics, metrology	Composites, plastics, AM, small castings		composites, bio, etrology
Advantages	high resolution nano-CT®	Versatile premium precision	Price performance	Maximum	ı flexibility
X-Ray Tube	Nanofocus 180kV/20W	Micro 300kV/500W Option Nanofocus 180kV/20W	Micro 240kV/320W Option Nanofocus 180kV/20W	Custor	nizable
Technique	Cone Beam CT	Cone Beam CT with Scatter correct option	Cone Beam CT	Custor	nizable
Max CT Scan (h x Ø)	250 x 240mm	400 x 420mm	420 x 400mm	600x900mm	1250x1300mm
Max Sample Weight	3kg	50kg	10kg	50kg	100kg
Min Voxel Size	0.3µm	2μm / 0.5μm nanoCT®	2µm / 1µm nanoCT®	Custor	nizable
Best Detail Detectability	0.2µm	1μm / 0.2μm nanoCT®	1μm / 0.2μm nanoCT®	0.2µm	1µm



ASC|filter

Up to 2 times faster data acquisition at the same high image quality level



Scan larger parts more accurately with compact systems like Phoenix V/tome/x M and Phoenix V/tome/x C HS



Dynamic 41 digital detector

Reduce scan time from 6 minutes to 3 with increased detector sensitivity



Scan longer parts faster, and with better quality



Faster, more accurate inspection process for improved productivity, reduced downtime, and results you can trust



Production|edition collaborative robot

Optional collaborative robot for fully automated high-throughput CT inspection



Waygate Technologies Overview @ a Glance



V|tome|x C450



X|cube 160|225|320



Speed|scan HD



Microme|x / Nanome|x Neo

V tome x C450	X cube 16	50 225 320	Speed scan HD	Microme x / Nanome x Neo	
Large castings, AM, composites, metrology	AM + castings 2D inspection		Batteries, connectors, complex assemblies, injection moldings	Components failure analy	
Powerful, highly automated	Highly automated, opt. CT		Up to 100% inspection (inline or atline)	Highly efficient and versat	
Minifocus 450kV/1500W	160kV / 225	5kV / 320kV	High Performance Speed CT 240kV/100W	Microfocus 1	180kV/20W 60kV/15W or //20W
Fan and/or Cone or Cone with Scatter correct	2D with CT Option		Fast In-Line CT	2D with CT Option	
500 x 1000mm	300 x 300mm	with 16" DDA	200 x 150mm	680 x 635mm	
50kg	100kg	300kg	5kg	10	lkg
400μm at 700W, 1000μm at 1500W		0.5mm	2µm*		
25µm	25	μm	20µm	Nano-focus 0.2µm details	Micro-focus 0.5µm details

* Image from nano-CT is sharper.



Filter|changer

Perform batch CT scans even of samples differing in size and material with highest quality



Significantly reduces streaks, making ares Powerful, highly precise 3D automatic visible and accessible for reliable CT evaluation

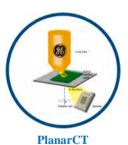


Sample|changer

Allows automatic change of different samples, e.g. for longterm overnight batch CT scans in 24/7 operation mode



defect recognition algorithms for mass production process optimization



Planar CT for microme/x /nanome/x inspections of solder joints and PCBs



Ruby|plate & True|position

Automatically correct any deviations and maintain conformance with VDI 2630 measurements



Detectors for High Performing XCT Systems

Dynamic 41 100	Dynamic 41 200			
Detector for Premium CT results in less time	Detector for improved inspection throughput			
Next generation 410mm x 410mm industrial flat panel detector. Proprietary Endurance TM CsI scintillator improving superior resolution/brightness. New photodiode design - 10x improved efficiency; 2-3 times cycle time increase without quality impact. Optimized for long-term reliability at high-energy use.				
Double resolution 16MP 100µm pixel size for up 4 to 50µm feature detection with minifocus tubes	4MP 200µm pixel size for up to 100µm feature detection even with minifocus X-ray tubes			
Reduced inspection times due to increased detector sensitivity, faster frame rates, larger imaging area and adaptive imaging modes. Dynamic range > 10000:1.				
Proprietary dynamic 41 detector exclusively for Dynamic 41 100 detector as option for Phoenix V t				
DXR500L	DXR250RT			
Static Digital Detector Array	8" Real-Time Digital Detector Array			
307mm x 249mm flat panel detector with 100μm p size (7MP). 1.5X virtual enlargement. High-resolution images for detection of subtle features				
Endurance TM technolog	gy for optimal image quality & lag			
Incorporated temperature controller for stable scans over longer periods, more consistent imaging and fewer calibrations. Dynamic >10,000:1.				
Aerospace, gas turbine castings, wax, ceramics metrology, science/geology	s, High throughput castings, pipes, electronics, manipulation systems			
DXR detectors exclusively available	le for Waygate Technologies system customers			

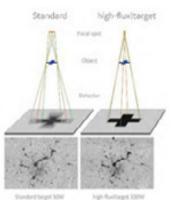
All detector specs per ASTM E2597-07.

High-flux target Up to 2X Faster microCT Scans or Doubled Resolution!

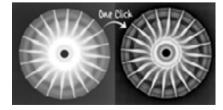




- With optimized thermal conductivity for higher power on a smaller focal spot for up to 2 times throughput at the same high resolution
- Provides better CT quality with less noise to improve speed or accuracy
- Option for all Waygate Technologies microfocus X-ray tubes up to 300kV, without impacting geometric magnification properties



Flash!TM Advanced Intelligent Image Processing for new NDT Standards!





Automotive

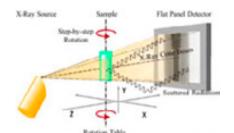
- Highest radiographic inspection image quality available
- · High- and low-density details clearly visible in one crisp image

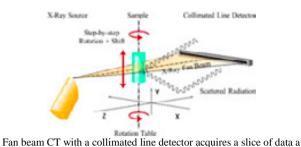


Oil & Gas



ASC|filter: Adaptive Scatter Correct Filter Unrivalled Image Quality!





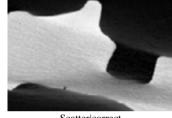
time, without scatter, resulting in high quality images. The sample is

vertically shifted, scanned and all results finally combined. This takes

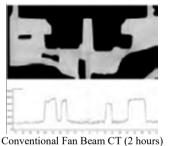
time while the manipulator movement introduces dimensional error

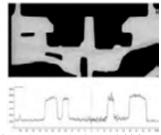
Scatter/correct with asclfilters

Cone beam CT via a high dynamic FPD capturing thousands of slices in parallel generates whole scan volumetric data in one 360° rotation. X-rays not along the source-detector path, falling on the detector array however results in scattered radiation yeilding image artefacts.



Scatter|correct





Scatter|correct (9 mins + 1 initial scan)

• Must be ordered with your system and factory-installed. Upgradeable on existing Scatter|correct versions.

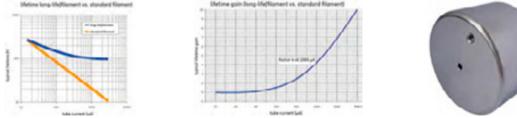
Conventional Cone Beam CT (9 mins)

• Reduced artifacts for best image quality. Fast and easy data evaluation.

Waygate Technologies' proprietary **Scatter**|**correct** incorporates leading-edge hardware and software advances to significantly correct cone beam scattering, allowing faster high image resolution scanning with quality and accuracy.

For high scattering materials such as steel, aluminum, composites and multi-material samples. Significant productivity gains enabling CT to move from R&D to production automation of serial CT inspections. Requires one-time initial correction (teaching scan) per part type, which is then saved for subsequent scatter-corrected scans. Up to 100 times faster than conventional fan beam CT! Ideal for VDI 2630-1.3 dimensional length metrology.

Long life filament Up to 10X increased lifetime

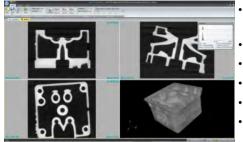


lifetime Long|life filament vs standard conventional filament; increases up to 10 times Long|life filament

- Standard for all WT x-ray directional type microfocus X-ray tubes up to 300kV (tube current of 3000µA)
- Increased filament operation lifetime at high emission currents; increasing uptime for high through-put scenarios
- Easy-to-change plug-in cathode with pre-adjusted filament: entire change process takes <20min



Phoenix Datos x Fully Automated CT Data Acquisition Software

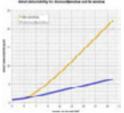


- Up to 14 times faster volume reconstruction for accelerated sample throughput
- Multi GPU based reconstruction
- Click & measure|CT functionality for high throughput
- · Flexible functionality and interfaces for Customized CT
- CT system performance monitoring following ASTM 1695 guideline
- Production mode with One-button|CT functionality and intuitive user interface for improved ease of use
- Now available with Flash!TM as an option

Diamond window for up to 2 times faster hi-res data acquisition

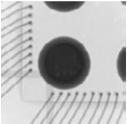
$Tube with \ \textbf{Diamond}| window$

- Standard non-toxic target for all Phoenix micro- and nano-focus X-ray transmission tubes for 180kV/20W
- Up to 2X faster data acquisition at same hi-res image
- · Improved focal spot stability for long term measurement
- Less degradation increased high-power target life

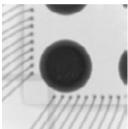


Min Focus-Object-Distance 0.3mm. Max mag of high power nanofocus X-ray tubes increased – Min spot size like W/Be target





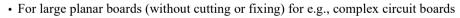
Diamond|window



Conventional Beryllium Window

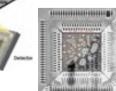
At higher power, the focal spot has to be wider to avoid the target material melting. The non-toxic, high thermal conductivity CVD Diamond|window solves this for transmission at 180kV power, allowing smaller focal spot or higher resolution image acquisition up to 2 times faster for inspecting small features with high absorbing materials.

PlanarCT Easy 2D Plane and 3D Volume Inspection Module



- 2D slice view for better quality than conventional X-ray with overlaying features
- Excellent image quality and high magnification for wide defect coverage
- Slice and ROI CT volume evaluation in any direction with Datos|x 3D|viewer





Reconstructed PlanarCT slice or multi-slice view of inspection results of a single plane or a whole package without overlaying from other board areas



Full CT visualization and evaluation of multiple slice volumes of THT solder joint defects with Datos|x 3D|viewer



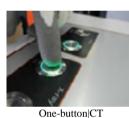
V|tome|x C450 High Power/Productivity CT with Metrology



- Compact 450kV CT system for production process control
- Max 3D scanning area Ø 500x1000mm
- Crane for efficient handling of heavy samples up to 50kg
- VDI 2630-1.3 dimensional traceability as standard
- One-button|CT fully automates entire CT process chain minimizing human influences for high CT GR&R
- Velo|CT II Accelerated 3D Reconstruction
- Measures size, volume, inclusions density, cavities and internal geometries to optimize production
- Significant productivity advantages for parts qualification
- Ideal for NDT, QA Labs in foundries and 3D metrology
- For automotive, aerospace, additive manufacturing, etc
- Low maintenance and cost of ownership



Automated wall-thickness





Quick pick manipulator

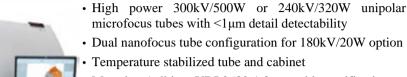
	V tome x C450	V tome x C Scatter correct / HS			
X-Ray Tube	Closed Bipolar Minifocus T	ube, 450kV at 700W/1500W			
Focal Spot Size	0.4mm (max power 700W);	1.0mm (max power 1500W)			
Focus Detector Distance FDD	1300mm	1150mm			
Voxel Size Range	100 to 146µm	87 to 139µm			
3D Geometrical Magnification	1.37 to 2X	1.44 to 2.3X			
Spatial CT Resolution	2.5 lp/mm at 130µm voxel reso	lution referring to ASTM E 1695			
Detail Detectability	Down to	o ~100μm			
Measurement Accuracy ¹	20+L/	/100µm			
Datos x metrology package	Surface extraction - automatic generation of s	urface data Easy calib – module for CT system			
(Option)	calibration Calibration object -	1 calibration tool with certificate			
Cone Beam Flat Panel Detector		or Dynamic 41 100			
Fan Beam Line Detector Array	16-bit 820mm sensitive width, 2050 pixels, 400µm pitch. Linear subpixel-shift axis for				
	resolution improvement and quality enhancement ²				
Dual Detector configuration ²	LDA and Flat Panel Detector, with detector shift and easy switching between both mode				
Granite-Based High Precision	2 axes (R,Y) manual Z-Axis (300mm)	3 (R, Y, Z) or 4 (R, Y, Z, XB) in HS base Z-			
Manipulator		auto or HS quick pick + detector shift axis			
Max 3D Scan Area/Weight	Ø 500 x 1000mm H (Ø 270 x 1000mm H	Ø 270 x 310mm H / 10kg (rotation unit HS)			
Max 3D Scall Alea/ weight	Scatter correct) / 50kg	Ø 100 x 125mm H / 3kg (Quick pick gripper)			
Focus Object Distance	650 to 950mm	500 to 800mm			
System Dimensions WxHxD	2310x2750x2870m	m excluding console			
System Weight	Approx.	15,000kg			
Datos x CT Software	Highly automated One-button CT including m	odules for CT data and workflow optimization.			
Datosix CT Software	Use with VG or other 3D evaluation software	for 3D metrology, failure or structure analysis			
Filter changer (Option)	Automated change of up to 4 filters for max flexibility and quality at automated batch CT				
Velo CT II Package (Option)		ime reconstruction			
Cabinet Crane (Option)	For ergonomic handling of heavy samples up to 50kg				
Barcode Reader (Option)	For easy samp	le identification			
Radiation Protection		German RöV, French NFC 74 100 and US			
	Performance Standard	1 21 CFR Subchapter J.			

¹Measured as deviation of sphere distance in tomographic static mode SD(TS) per VDI 2630 guideline. ²Not available for Scatter|correct and HS configuration.



V tome X M Hi-Resolution Microfocus X-Ray CT

Award winning mid-size stabilised cabinet, versatile high power, hi-resolution microfocus XCT with 180kV/20W nanofocus option, ready for VDI 2630-1.3 Dimensional Length Traceability

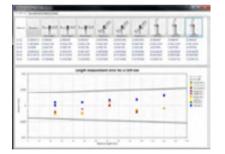


- Metrology|edition: VDI 2630-1.3 traceable certification
- Very high image quality at up to 30fps extremely fast acquisition via Dynamic 41 series detector array
- Longlife filament up to 10x increased lifetime Diamond|window for 2x faster data acquisition

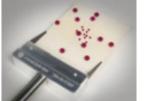
V|tome|x M

Without (L) / With (R) Scatter|correct screw scan comparison

Ground Breaking Option Scatter|correct: Advanced cone beam radiation scatter correction for fan-beam image quality at up to 100x faster cone-beam CT acquisition speeds. Ideal with 400x400mm² Dynamic 41 flat panel detectors.



V|tome|x M Metrology|edition (Option) – Measures accurately up to 3.8+L/100um



True|position / Ruby|plate



Ball Bar CFC with sphere (24, 48, 72, 96 and 120mm L)

Datos|x metrology check to verify VDI 2630-1.3 performance using calibrated artefacts above

Metrology Pack incl. vibration-insulated manipulator, long-term stabilized X-Ray tube with Diamond/window, two calibration test phantoms, Datos|x "Click & Measure CT", "Metrology", Automatic Voxel Calibration (auto-calibrates voxel size for whole travel range of the magnification axis) and ASTM 1965 CT system performance (image monitoring, determination of Modular Transfer Function (spatial resolution) and Contrast Discrimination Function (sensitivity, inverse of CNR) in %).

Production (Option) – Collaborative robot for high-throughput parts handling



The future is now, and it's fast. WT's industrial CT portfolio provides the ease of use, repeatability, and reproducibility needed to reduce scrap caused by defects and ensure productivity and quality. With highly automated systems, minimize the human factor and ensure up to 100% production control!

Add-on a collaborative robot to automate sample loading and achieve higher throughput and productivity with reproducibility.



V|tome|x S Compact High Power Micro/Nano-focus XCT Platform



- High power 240kV/320W microfocus tube
- Dual configuration ready for 180kV/15W nanofocus option
- Long|life filament for up to 10x increased lifetime
- Temperature stabilized Dynamic 41|200 and large area detector with superior image and result quality with extremely high dynamic range > 10000:1
- High dynamic temperature stabilized DXR detector for fast CT acquisition and brilliant live images (option)
- Diamond|window for 2 times faster data acquisition





NanoCT®

Dual tube configuration

	V tome x M300 V tome x M240		V tome x s 240		
X-Ray Tube		microfocus X-ray tube, closed c iguration, for additional nanofo	cooling water circuit. Optional dual cus X-ray tube.		
Microfocus Tube Power	Max 300kV/500W	Max 2	240kV/320W		
Detector Type	Dynamic 41 200 (4MP) or	DXR S100 Pro, DXR250RT or Dynamic 41 200			
Microfocus Min Voxel Size	Down to 2µm/1µm with 41	200 and 41 100 respectively	Down to 2µm		
Nanofocus Tube Option	Optional nanofocus tube	, max 180kV and 20W. Tube e	exchange by a push of a button		
Nanofocus Min Voxel Size	Down to (0.5µm (nanofocus). Detail dete	ctability: 0.2µm		
Measuring Accuracy ¹	3.8+L/100μm per VDI 26	30-1.3 (Metrology edition)			
Metrology edition Option	Ruby plate phantom for 3x f setup of CT scans with hig	gy" + patented 130mm length aster, automated verification her measurement accuracy zed scatter radiation artifacts.	N/A		
Scatter correct Option		ic magnification 1.51x to 100x			
Manipulation	Granite based precisio	5-axes metal precision manipulator, optimized high stability construction			
Focus-Detector-Distance	800mm with	800mm/8" FPD; 930mm/16" FPD			
Max Sample Ø x Height	360x600mm; up to 500x600	260mm Ø x 420mm H			
Max 3D Scanning Sample	420mm Ø 2	20011111 Ø X 42011111 H			
Max Sample Weight	High accuracy CT up to	o 20kg; Max up to 50kg	10kg		
System Dimensions WxHxD	2620x2060x1570mm (D: 298	0 with user panel + generator)	2170x1690x1500mm		
System Weight	Approx	7960kg	Approx 4550kg		
Temperature Stabilization	Active X-ray tube cooling, tem temperature sta	perature-controlled cabinet and bilized detector	Active X-ray tube cooling and temperature stabilized detector		
High-flux target Option		r doubled resolution; X-ray ins			
2D Inspection Bundle Option	Tilt and rotation axes for til	ted 2D inspection of samples up	o to 10kg; Software with Flash! TM		
Click&measure CT	Fully automated CT process	chain. Included as standard	Option		
Helix CT & Offset CT Option	Advanced scanning trajectories for improved scanning volume and data quality; Helix CT for long part scans with less artifacts; Offset CT for bigger parts or higher resolution		N/A		
Production edition Option	Fully automated with coll	aborative robot on request			
Datos x Software			construction software. Different 3D or structure analysis on request		
Analysis Software		es such as Volume Graphics fo enomena, foam structure, fiber	r 3D metrology, failure analysis, composite, etc. on request.		
Radiation Protection	Full protective radiation safety		trSchV, French NFC 74 100 and US		

¹ Per VDI 2630-1.3 measured as deviation of sphere distance in tomographic static mode SD (TS), with True|position and Ruby|plate, valid only for Phoenix V|tome|x M Metrology|edition. L: sample length in mm.



Nanotom M High Resolution nanoCT® X-Ray CT

Outstanding nanofocus tube, high dynamic, high-resolution DXR detector and advanced algorithms combine to deliver optimal high image quality with detail detectability down to 200nm





Nanotom M

Measurement of 5 features of injection molded part with CAD variance

	Nanotom M
X-Ray Tube	Proprietary open nanofocus tube, max 180kV/20W output, optimized for long-term stability with internal tube cooling
Target	Diamond/window. Other materials, e.g. molybdenum on request
Filament	Tungsten hairpin, pre-adjusted plug-in cartridges for fast and easy exchange
3D Geometrical Magnification	1.4 to 300x
Best Detail Detectability	0.2µm
Minimum Voxel Size	0.3µm
Detector	Temperature stabilized high dynamic DXR500L
Pixels/Pixel Size	3072x2400 / 100μm
Manipulation	Granite-based 5-axes manipulator, vibration insulation, precision rotation table on air bearings
Detector Focus Distance	Variable from 200 to 600mm
Max CT Sample Size/Weight	240mm Ø x 250mm H / 3kg
Sample Travel Length Y/Z	250mm/400mm
Rotation	0° to 360° x n
System Dimensions / Weight	1980mm W x 1600mm H x 925mmmm D / Approx. 1900kg
3D Metrology Bundle Option	Temperature stabilized cabinet, high accuracy direct measuring system, Calibration object, Datos x module packages "metrology" and "Click & measure CT"
Datos x Software	Phoenix Datos x 3D computed tomography acquisition and reconstruction software. Different 3D evaluation software packages for 3D metrology, failure or structure analysis on request.
Analysis Software	Various evaluation packages such as Volume Graphics for 3D metrology, failure analysis, porosity, transport phenomena, foam structure, fiber composite, etc. on request.
CT Reconstruction	Phoenix Datos Velo CT high-speed (up to 6 GPUs)
Advanced Sample Manipulation Options	Manual XY highly accurate positioning table, tensile & compression testing stage system, coolstage specimen cooling unit. Or Motorized XY-table with two linear axes
Radiation Protection	Full protective radiation safety cabinet per German StrSchG/StrSchV, French NFC 74 100 and US Performance Standard 21 CFR Subchapter J.

NanoCT® - Closest to Synchrotron X-Ray CT

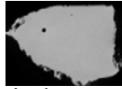


Image from nanotom m

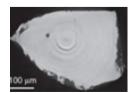


Image from ESRF Synchrotron

Nanotom M detects minute details with optimized image quality; making it an accessible alternative to limited-availability synchrotron facilities for materials science, micro-engineering, electronics, life sciences, geosciences, etc.



V|tome|x L300 / L450 Large Size Customizable XCT



V|tome|x L300

- High-mag unipolar 300kV tube for evaluating high Optimised metal-ceramic bipolar 450kV/1500W absorbing steel parts and large aluminium castings
- Option: 180kV/20W high-power nanofocus X-ray tube Long|life filament option
- 3D Metrology package for dimensional measuring
- · Easy switch between 2D and XCT
- Micro and Nano mode with details down to 1µm



V|tome|x L450

- minifocus tube for sharp scans of high absorbing parts
- Fast CT via temperature stabilized Dynamic 41 detector at up to 30fps

	V tome x L300	V tome x L450			
Max Tube Voltage / Output	300kV / 500W	450kV / 1500W			
Detail Detectability / Min FOD ¹	Down to 1µm Down to 2µm				
Min 3D Voxel Resolution ²	2µ	ım			
2D Geometric Mag	1.25 to 238x	1.25 to 400x			
3D Geometric Mag	1.25 to 187x 1.25 to 242x				
Max Object Size / Weight	600mm H x 500mm Ø / 50kg 1000mm H x800mm Ø / 100				
Manipulator Type	Granite-based 6-axes manipulation unit				
Detector	16" Dynamic 41/200 (4MP) or in combination with Line Detector Array				
2D X-Ray Imaging	Y	es			
3D CT	Yes	2D / CT switch			
Datos x Software	Phoenix Datos x 3D computed tomography acq	uisition and reconstruction software. Different			
	3D evaluation software packages for 3D metr	ology, failure or structure analysis on request.			
System Size	4100x2600x2960mm	6500x3500x4300mm			
System Weight	22,000kg	65,500kg			
Radiation Protection	Full protective radiation safety cabinet per German StrSchG/StrSchV, French NFC 74 100 an US Performance Standard 21 CFR Subchapter J.				

¹ Focus Object Distance. ² Proportionate to object size.



X|cube Real-Time X-Ray and CT Inspection System



X|cube





Flash!™

semi ADR auto defect recognition

- Real-time 2D inspection of precision plastic, ceramics, metals and alloy components, castings, welds and AM parts used in the automotive, aerospace and oilfield industries.
- · Detect hidden defects for in-time production decisions
- Modular ergonomic design, high dynamic detectors and advanced Flash!TM (option) for enhanced superior image and reliable accurate inspections
- 3D Computed Tomography option
- Optional Semi-Automatic Defect Recognition for production decisions
- High throughputs, simple workflow, easy servicing with 24/7 intuitive X-Touch[®], reduced human error and maintenance costs for reliable, efficient X-ray inspections
- Available in Compact and XL sizes for a wide inspection range with both manual and fully automated X-ray options

X cube		Compact	XL				
Energy (Max)	160kV	225kV	320kV	160kV	225kV		
Max Sample Size ¹ Ø x H		600 x 900mm		800 x 1	500mm		
Max Sample Height	1150mm	1150mm	930mm	158	5mm		
Max Sample Weight ²	150	Okg	300kg	10	Okg		
Cabinet Size LxWxH in mm	2650x21	55x2360	2540x2230x2400	2850x21	55x2885		
Cabinet Weight	535	Okg	10,500kg	660	Okg		
Control Panel Weight		350kg					
Horizontal Motion Across Beam	650mi	m max	660mm max	850m	m max		
Max External Loading Position	901	nm	150mm	90	mm		
Max Horizontal Motion Mag Axis	850	mm	620mm	105	Omm		
Focus Detector Distance FDD	800 to 1	000mm	800 to 1150mm	1000 to	1200mm		
Max Vertical Motion	900	900mm 950mm					
Max Tilt / Max Rotation	±45°/n x 360°						
2D Software	VISTAPLUS Inte	VISTAPLUS Integrated image optimization live real-time display with dedicated detectors					
System Control	X touch panel for	fast and easy set-	up of inspection rou	tines by teach-and	l-learn procedures		
Control / Drives		Hardware PLC for	or PC independent/F	anuc servo drives			
Detector Options			on and very fast CT ations and DXR 250				
Flash! TM Option	Proprietary live in	nage optimization	for easier visual def	ect detection in ca	stings or weldings		
X-Ray Tube Options	Various n	nini and macro foc	uses, as well as vari	ous high-power X	-ray tubes		
Software Options	recognition (pass	/fail final decision	image catalogue, so by operator), Rhyth orm, and automatic	nm Export Module	e with DICONDE		
Computed Tomography Add-on	All required	l hardware and sof	tware components f	or combined 2D/3	D operation		
CT Scan Range	Max	160mm Ø x 160m	m height with DXF	250RT 8"x8" det	tector		
Min Voxel Size	Up to	100µm, depending	g on the sample size	and detector pixe	l pitch		
Connection Values / Capacity	3N PE 400/230V 2	50/60Hz, 35A (16	0+225kV), 50A (32	0kV), TN-S/-CS n	etwork / $\approx 16 kVA^3$		
Earthing	Separate earthin	g for X-ray device	and high-voltage g	enerator ($< 2\Omega$) w	ith at least 6mm ²		
Means of Transport	Complete X	-ray protection cal	oinet / Control pane	l (on pallet) with f	ork lift truck		
Ambient Conditions IEC 60601-1	10 to 40°C, air	pressure 700 to10	60hPa operating hu	midity 25 to 85%	non-condensing		
Radiation protection			net per German Strandard 21 CFR Sub				

¹Longer workpieces are possible, this involves the workpiece being reloaded and inspected. ²Depends on the loading position. ³Depends on the applied X-ray tube. ^{Note} The inspection volume that can be X-rayed varies according to the total wall thickness and the material density.

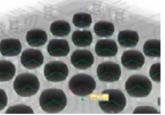


Xaminer Easy to Use Entry-Level High-Quality Electronics X-Ray Inspection



X|aminer

- Unlimited-life 160kV/20W microfocus tube with optional 3D CT even for high absorbing components
- Newest superior resolution DXR S85 detector with improved scintillator technology for higher inspection efficiency and better image quality
- High contrast CMOS FPD option for improved inspections
- Comprehensive fast, intuitive software with Live CAD overlay
- Automated real X-ray sample map for easy orientation on top, bottom and even inside samples
- Anti-collision sample protection feature
- Economical, small footprint





Open BGA ball with live CAD overlay and FLASH!TM image optimization

Flash!TM Electronic specially optimized for electronics application

	X aminer
X-Ray Tube	Low maintenance open microfocus tube, transmission head, 170° cone angle, collimated, Tungsten target rotatable for multiple use.
X-Ray Detectors	Option 1: Waygate Technologies DXR S85 1536 x 1536 pixel CsI detector Option 2: High contrast 1536 x 864 pixel CMOS detector
Geometric Magnification	>2100X
Total Magnification	>91000X
Best Detail Detectability	0.5µm
Max. tube voltage / power	160 kV/20 W
Filament	Tungsten hairpin, pre-adjusted in plug-in cartridges for fast and easy exchange in <20mins
Manipulator	High precision vibration-free synchronized 5 axes manipulation
Max Inspection Area /Sample	410x410mm / 510x510mm
Max Sample Weight	5kg
ovhm – Oblique View Rotation	Adjustable view angle up to 70° n x 360°
Control	Manual Joystick or mouse control and Automatic CNC mode
Manipulation Aids	sample X-ray mapping, click'n-move-to function, click'n-zoom-to function, automatic isocentric manipulator movement, active anti-collision system
System Dimensions / Weight	1800x1900x1430mm (WxHxD) (D without console and demountable back extension) / 2050kg
Radiation Protection	Full protective radiation safety cabinet per German StrSchG/StrSchV, French NFC 74 100 and US Performance Standard 21 CFR Subchapter J.
Software Configuration (Option)	 X/act BGA check strategy: automated CAD based analysis of BGA solder joints. X/act PTH check strategy: automated CAD based analysis of PTH solder joints. QFP/module: automated QFP solder joint evaluation. QFN/module: automated inspection of QFN / MLF solder joints. PTH/module: automated pin-through-hole solder joint evaluation. X/act review: visual interface for rework and failure indication. FLASH!TM: Waygate's exclusive image optimization technology. Now Flash!TM Electronics optimized specially for electronics application available
CT (Option)	Available as an option for easyfixCT
Barcode scanner	Manual bar code reader: for product identification
Tilt / Rotate Unit Option	Tilt ±45° and rotate n x 360° samples up to 2kg
Positioning aid (Option)	Laser crosshair
Rotation PCB Holder Option	Max Board 310x310mm
XY Table Option	510x510mm inspection area without rotation and OVHM



Microme x / Nanome x neo Hi-Res Micro/Nanofocus X-Ray Inspection



- Temperature stabilized digital DXR detector w active cooling (high dynamic live imaging)
- 180kV/20W high-power micro- /nanofocus tube with up to $0.5 \mu m/0.2 \mu m$ detail detectability respectively
- X|act CAD based μ AXI programming and inspection
- Diamond window for 2 times faster data acquisition
- Flash!TM (option) for faster, more reliable failure detection.
- CT Upgrade Option for 3D scans within 10 seconds
- PlanarCT easy 2D Slice and 3D Volume Inspection

CT of USB flash drive



Brilliant DXR-HD live imaging

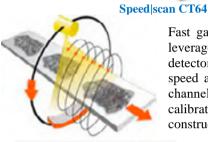
	Nanome x neo 180	Microme x neo 180	Microme x neo 160					
	nanofocus 180kV/15W	microfocus 180kV/20W	microfocus 160kV/20W					
X-Ray Tube		with unlimited lifetime, transm nated, target rotatable for multip						
Target	Diamond window for up to 2	2 times faster data acquisition	Al Window, Optional Diamond window					
X-Ray Detector	High dynamic 200µm pixel res Large size 100µm pixel resol	Superior 85µm pixel resolution detector DXR S85 or 75µm pixel res. CMOS detector						
Geometric Magnification	DXR250RT: Max 1970x; I	DXR S100 Pro: Max 2185x	Max 1970x					
Total Mag 27" Monitor/2K	DXR250RT: Max 36,800x; DXR S100 Pro: Max 40,700x DXR S85: Max 84,80 CMOS: Max 96,00							
Best Detail Detectability	0.2µm	0.2μm 0.5μm						
Filament	Tungsten hairpin, pre-a	Tungsten hairpin, pre-adjusted in plug-in cartridges for fast and easy exchange						
Manipulator	high-precision	high-precision vibration-free synchronized 5-axes manipulation						
Max Inspection Area	460x360mm, 610x510mm without rotation table							
Max Sample Size / Weight	680x635mm / 10kg							
ovhm – Oblique View Rotation	continuously ad	justable view angle up to 70°, ro	tation 0° to 360°					
Control	Manu	al Joystick or mouse control and	I CNC					
Manipulation Aids	sample X-ray mapping, click'n	n-move-to/-zoom-to functions, au	atomatic isocentric manipulator					
Positioning Aid	laser cr	rosshair	Optional laser crosshair					
Anti-Collision System	may be deactivated for	or maximum magnification (tube	e touching the sample)					
System Dimensions / Weight	2160x1958x1590mm DxHxW	without control console. (Trans	sport width 1770mm) / 3250kg					
Dose Reduction		arget, inside the X-ray tube, ena ion for radiation protection of se						
Image Processing Software	<i>Phoenix X/act</i> : inspection software comprising image enhancement, measuring functions, and fast automated CAD-based programming for automatic inspection. <i>BGA/module</i> : Intuitive view based BGA solder-joint evaluation including automatic wetting analysis. <i>VC/module</i> : Intuitive view based voiding calculation including multiple die attach voiding evaluation capability.							
Software Options		. <i>PlanarCT module</i> : Non-destruction including 3D viewer s						
Hardware Options	Tilt ($\pm 45^{\circ}$)/ rotate (n x 3	60°) unit for samples up to 2kg.	Manual bar code reader.					
CT Options		reconstruction for 2D/3D CT (vi voxel resolution: 2µm (depends						
Radiation Protection		cabinet per German StrSchG/St ormance Standard 21 CFR Subc						



Speed|scan CT64 Automated High-Speed Production XCT



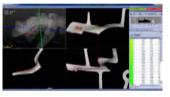
- Productivity gains via quantitative 3D automated defect recognition and dimensional control
- Faster product ramp up times and reduced rejects
- Up to 100% production control of large castings
- 64-channel data acquisition and patented quickslide manipulator for rapid sample throughput (scans cylinder head in 15secs); hundred times faster than fan beam CT 3D inspection
- · Optimized ease of use due to high automation
- Low Total Cost of Ownership



Fast gantry-based helix CT multi-line technology from Medical CT knowhow, leverages a high-performance X-ray tube and very-high sensitivity multi-line detector to scan work pieces continuously with low scattering artefacts. A high-speed automatic helix gantry with X-ray tube and multi-line detector (up to 64 channels) rotates around the work piece forwarded on a conveyor belt at precise calibrated speed. The proprietary high-speed 3D evaluation algorithms then construct the high-quality images and the evaluation results.







3D automated defect recognition (3D Speed|ADR)

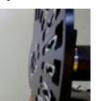
	Speed scan CT64
Inspection Concept	Manual loading, operator-based or robot-based fully automated inspection with automated 3D failure detection Speed ADR and 3D dimensional control for statistical process control
Max Sample Size / Weight	~600 Ø x900mm; Max Scan Ø ~ 500 Ø x ~888 to 979mm / 50kg
Penetration Length	Allows inspection of Al gear cases and engine blocks depending on part geometry
Min Detectable Defect Size	≥0.5mm ³ , depending on part size with detail detectability of ≥300µm
3D Metrology	Fast automated CAD nominal/actual analysis and measurement tasks for process control
Scan/Reconstruction/Cycle Speed	10.62 to 61.25mm/s / reconstruction speed up to 75 slices/s inspection / <1min per part
Multi-Line Detector	High dynamic, 64-layer parallel acquisition. The detector embodies the patented HiLight [™] material, a ceramic scintillator specially developed for CT applications.
High Performance Rotating Anode X-Ray Tube	Max 140kV, 515mA current, 72kW generator output. Typical inspection parameters: 140kV, 100mA. Ratio between X-ray on and cooling time depends on selected parameters.
CT Gantry	Advanced continually rotating generator, X-ray tube, detector and data acquisition system around the test specimen. Rotation speed adaptable within the range of 0.5 to 1 revolutions/sec depending on required data quality and specimen throughput rate
Production	Fully automated robot loading/unloading for high throughput inlineCT on request
Dimensions W x D x H / Weight	2500 x 4000 x 2500mm / 13,000kg
Design	Suitable for industrial environment with dust and foreign body protection
Air Condition	Active air conditioning system to safely remove the heat created during the test procedure
Patented quick-slide manipulator	Speed: 10.62 to 61.25mm/s for data acquisition, up to 1000mm/s for loading/unloading
Control Unit	Operator console with 2 flat screen monitors close to the system to facilitate speedy loading and unloading by the operator. Touch panel for visualization of PLC / control
3D Data Analysis and Visualization	Automated DICOM image transfer to analysis station. CT visualization – 3D detection and classification of pores and inclusions (GE Speed ADR). Dimensional control: Wall thickness determination and Actual/nominal CAD comparison via VGStudio MAX
Software User Level	Create and modify 3D inspection programs on- or off-line. Inspector for semi- or fully- automated analysis. VG Approval for interactive visualization and review of results.
Radiation Protection	Full protective radiation safety cabinet per German StrSchG/StrSchV, French NFC 74 100 and US Performance Standard 21 CFR Subchapter J.



Speed|scan HD 100% Inline High-Speed microCT for Production



- Fully automated high-speed inline CT system for production process control and optimization with >20 years of industry-proven technology
- Large sample size inspections up to 100% of production volume
- Full 3D production control for electronic, automotive, and medical device applications, including batteries, connectors, injection moldings, and complex assemblies
- Fully automated part handling and CT innovations enable 24/7 Speed|scan HD operations at exceptional voxel resolutions down to $25\mu m$
- Advanced AI-based battery anode overhang analysis as well as automatic defect recognition (ADR) for pass/fail decisions and fully automated CT workflows
- Proprietary, rugged microfocus X-ray tube (Inline|edition, 240kV/100W) designed for production environment
- Automated filter|changer for increased flexibility (up to 10 different hardware filters)
- Dynamic41|200p+ X-ray detector for long-term stability and reliability at industrial high-energy use in production, delivers up to 10 times more efficiency and sensitivity than advanced technology 200µm pixel detectors.
- · Dual manipulator shortens inspection cycles, reducing loading/unloading wait times



Automated filter|changer



AI-based automated defect recognition (ADR)



Dual manipulator

	Speed scan HD						
X-Ray Tube Type	Open directional high-power 240kV/100W microfocus tube with closed cooling water circuit						
3D Geometrical Magnification	8X						
Detail Detectability / Voxel size	Down to 20µm / Min 25µm						
Detector type / Focus Detector Distance	Temperature stabilized Dynamic 41 200p+ large area detector with superior image and result quality, 410x410 mm, 200µm pixel size, 2036x2036 pixels (4MP), extremely high dynamic range > 10000:1 / 800mm. Optional Dynamic 41 100 large area detector with superior image and result quality, 410x410mm, 100µm pixel size, 2048x2048 pixels (16MP), extremely high dynamic range > 10000:1						
Max Sample Size / Weight	150mm Ø x 200mm / 5kg						
Dimensions WxDxH / Weight	~2310x2200x2055mm (without external components) / 7250kg						
Maximum Focus Object Distance	500mm						
Temperature Stabilization	Active X-ray tube cooling temperature stabilized detector						
Production	Fully automated robot-based workflows						
Software	Phoenix Datos x 3D computed tomography acquisition and reconstruction software. WT proprietary Automated defect recognition (ADR) software with a focus on battery overhang detection. Barcode/matrix code reader for part identification. Optional 3D evaluation software packages available for 3D metrology, failure analysis, and structural analysis						
Options	48 GB network attached NAS storage with in air-conditioned PC rack with optional uninterruptible power supply; 2 calibration objects for enhanced accuracy; Click & Measure CT for fully automated CT process chain; Dual-stage manipulation for faster part handling; Flash! TM provides outstanding image enhancement on 2D images; Filter changer with up to 10 filters hosted for automatic filter setting adjustment during part mix scanning						
Radiation protection	Full protective radiation safety cabinet per German StrSchG/StrSchV, French NFC 74 100 and US Performance Standard 21 CFR Subchapter J.						

X ACCRETECH

XYZAX Line-Up of High Productivity Made-In-Japan CMMs



Accretech's XYZAX CMMs looks back 50 years to when Tokyo Seimitsu launched the DCM-600A, Japan's first computerised CMM in 1969. Since then, Accretech's CMMs have become household names and is largely used in the automotive and precision engineering industries.

The XYZAX line up comprises the high productivity AXCEL series with sizes from 7/7/5 to 12/25/10, operating at high speed, low vibration and high accuracies with a full range of Zeiss and Renishaw sensors and probes; the ergonomic MJU available in two compact sizes with greatly reduced air and energy consumption, and the sturdy and time-tested SVF manual CMM series.

All models are produced in Tsuchiura (near Tsukuba science city, home to Japan's high-technology research) for conservative, under-stated high quality of manufacturing and reliability.

Accretech means accretion of the best technologies from all over the world into a complete, versatile and capable system. This is what customers find in all Accretech metrology equipment!



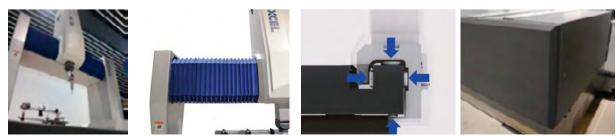


XYZAX AXCEL High Productivity CMM



AACEL

- Sizes from 7/7/5 to 12/25/10. E_0 MPE = 1.8+3L/1000 μ m at 18–22°C for all sizes from 7/7/5 to 10/15/8
- Expanded temperature operation at $16 26^{\circ}C$ and $15 30^{\circ}C$ (option) with climate-stabilised worktable structure
- Higher speed with low vibration and improved accuracy:
- o New drive mechanism increases speed by 64% and acceleration by 35% compared to previous models
- New bridge structure with Y- and torsion-direction 3.8X and 1.5X increased rigidity than previous models
 4-direction Y-Axis guide support air pads, reducing runout and vibration at probe tip
- Air Saver function reduces running costs. Option LED illumination of worktable below the X-Axis guide
- Air anti-floor vibration unit for $Z \ge 800$ mm sizes; option for $Z \le 600$ mm by attaching a base cover
- · Accretion of best of world technologies with Renishaw and Zeiss probe heads and sensors



New Highly Rigid Bridge X-Axis temperature guide cover 4-direction Y-Axis air bearings Open Y-Axis guide reduces heat



XYZAX AXCEL High Performance CMM

XYZAX AXCEL RDS - Zeiss Probe Systems

Zeiss RDS-C5 head with 5° rotary increments ±180° horizontal/vertical for 5184 orientations. Auto-calibration routine by probing 12 specified positions. Supports VAST XXT, XDT, LineScan2 and ViSCAN probe choices. Popular CALYPSO software.



- Wide ±3mm minimizes collision impact
- joints for auto-styli change

· For small holes or grooves and soft or thin workpieces

XYZAX AXCEL PH - Renishaw Probe Systems



PH10T + motorized indexing probe head with TP200



TP200 compact, higher accuracy, longer life strain-gauge probe



PH10T+/TP200B & PH1/TP20

Proven Renishaw PH10T/M+ heads; 7.5° rotary increments; air supply not needed; wide range of Renishaw probes including TP20, TP200, TP200B. Use with CALYPSO or XYANA2000 software (for PH20 infinite orientation revolving probe head).





ACR200/MCR20 auto change rack for Renishaw styli modules

Extension bars; Autojoint fitting Ø 25mm with connection repeatability: 1µm at stylus tip, 50mm from autojoint

Effective length	D1	D2	Weight
400mm	Ø 25mm	Ø 14mm	104g
450mm	Ø 25mm	Ø 13mm	112g

arbon fibre extension bars PAACF (A-1051-0513 and A-1051-0394) respectively



XYZAX AXCEL Specifications Table

XYZA	AX AXCEL RDS/PH	7/5/5	7/7/5	9/6/6	9/10/6	9/15/6	10/10/6	10/12/6	10/15/6		
Measuring l	Range X	650mm	650mm	850mm	850mm	850mm	1000mm	1000mm	1000mm		
Measuring	Range Y	500mm	700mm	600mm	1000mm	1500mm	1000mm	1200mm	1500mm		
Measuring	Range Z	480mm 600mm									
Measuring I	Length Scale	Linear Scale									
Min Display	y Value	0.01µm									
м	· • 1	Common for $Z = 480$ mm and 600mm models									
Measurement Accuracy ¹			RDS	/XXT			PH10T-	+/TP200			
	18 – 22°C				1.8+3L/	1000µm					
E ₀	16 – 26°C				1.8+4L/	1000µm					
	15 – 30°C ²				1.8+5L/	1000µm					
	18 – 22°C				2.3+3L/	1000µm					
E150	16 – 26°C				2.3+4L/	1000µm					
	15 – 30°C ²				2.3+5L/	1000µm					
R0, MPL			1.3	μm			1.5	μm			
PFTU, MPE			1.8	μm			2.0	μm			
MPETHP at '	T=75s		2.9	μm			N	/A			
Guidance S	ystem for Each Axis	Air bearings									
Table Mater	rial	Gabbro									
Table Usable Width (X)		1050mm 1200mm						1200mm			
Table Usable Depth (Y)		1400mm	1600mm	1500mm	1900mm	2400mm	1900mm	2100mm	2400mm		
Table Heigh	nt from Floor	600mm									
Table Flatn	ess	JIS Class 1									
Table Clam	ping Screw	M10 threaded hole									
Max Workp	viece Height	670	mm			790	mm				
Max Workp	viece Weight	600kg	80	Okg	1000kg	1500kg	1000kg	1200kg	1500kg		
Drive Max	Acceleration/Deceleration	2300mm/s ²									
Drive Varia	ble Speed Range	Auto measurement mode 0.01 – 700mm/s (Stepless control) Joystick and manual mode (Automatic measurement) 0 – 120 (Stepless control)									
Drive Meas	uring Speed	Joystick and manual mode (Automatic measurement) 0 – 120 (Stephess control) Joystick and manual mode (Automatic measurement) 0 – 5mm/s									
Temperatur		1.0° C/hr, 2.0°C/day (at 18 – 22°C and 16 – 26°C) 2.0°C/hr, 5.0°C/day (at 15 – 30°C ²)									
Temperatur	-	$\frac{1.0^{\circ} \text{C/m}}{1.0^{\circ} \text{C/m}} (\text{at 16} - 22^{\circ} \text{C}, 16 - 26^{\circ} \text{C} \& 15 - 30^{\circ} \text{C}^{2})$									
	/ Working Pressure	0.49 to 0.69MPa / 0.39MPa									
Air Consum					55N4	2/min					
Power Supp	1	Sin	gle phase A	C 100 to 2	40V±10% (factory pre	-set). Grou	nding requi	red.		
Power Cons	-		~ 1	1210W			,	1350W			
	idth x Height	1462 x 2	2339mm		16 x 2578n	ım	18	66 x 2578n	nm		
Machine De	~ ~		1650mm	1550mm	1950mm	2450mm	1950mm	2150mm	2450mm		
Machine W	•	1610kg	1800kg	2100kg	2550kg	3150kg	2850kg	3100kg	3450kg		
	eight at Transport ³)mm	- 0	- 0)mm	- 0	- 0		

¹ Evaluation methods are per current JIS B7440-2, -4 and -5 (ISO 10360-2, -4 and -5). E_{0,MPE}, E_{150,MPE}, R_{0,MPL} and P_{FTU, MPE} with stylus tip dia. Ø 5, length: 50mm for RDS; tip dia. Ø 4, length: 20mm for PH10. MPE_{THP} using stylus with tip dia. Ø 3, length: 50mm for RDS.

 2 Adapting to temperature condition 15 – 30°C is an Option for PH models.

³Z-Axis is folded down for transport. Please provide adequate allowances for passageways and lifting/support equipment used.



XYZAX AXCEL Specifications Table

XYZA	X AXCEL RDS/PH	10/10/8	10/12/	/8	10/15/8	12/15/10	12/20	/10	12/25/10	
Measuring F	Range X	1000mm			1200mm					
Measuring F	Range Y	1000mm	1200m	nm	1500mm	1500mm	20001	nm	2500mm	
Measuring F	Range Z		800m	m			10001	nm		
Measuring I	Length Scale	Linear Scale								
Min Display	/ Value	0.01µm								
M	· • 1	Common	n for $Z = 8$	300mr	n models	Common	for $Z = 1$	1000m	m models	
Measurement Accuracy ¹		RDS/XX	Т	PH1	0T+/TP200	RDS/XX	T	PH1	0T+/TP200	
	18 – 22°C]	1.8+3L/10	00µn	1	2.2+3L/100	0µm	2.4+	3L/1000µm	
E ₀	16 – 26°C]	1.8+4L/10	00µn	1	2.2+4L/100	0µm	2.4+	4L/1000µm	
	$15 - 30^{\circ}C^{2}$	1	1.8+5L/10)00µn	ı	2.2+5L/100	0µm	2.4+	5L/1000µm	
	18 – 22°C	2	2.3+3L/10)00µn	ı	2.7+3L/100	0µm	2.9+	3L/1000µm	
E150	16 – 26°C	2	2.3+4L/10)00µn	ı	2.7+4L/100	0µm	2.9+	4L/1000µm	
	$15 - 30^{\circ}C^{2}$	2	2.3+5L/10)00µn	ı	2.7+5L/100	0µm	2.9+	5L/1000µm	
R0, MPL		1.3µm			1.8µm	2.2µm			2.4µm	
RFTU, MPE		1.8µm			2.4µm	2.5µm			3.0µm	
MPETHP at 7	Γ=75s	2.9µm			N/A	3.8µm			N/A	
Guidance Sy	ystem for Each Axis	Air bearings								
Table Mater	ial	Gabbro								
Table Usabl	e Width (X)	1270mm				1470mm				
Table Usabl	e Depth (Y)	2000mm 2200mm 2500		0mm 3100		nm	3600mm			
Table Heigh	t from Floor	630mm								
Table Flatne	ess	JIS Class 1								
Table Clam	ping Screw				M10 thre	aded hole				
Max Workp	iece Height		1000m	nm			12001	nm		
Max Workp	iece Weight	1000kg	1200k	cg	1500kg 1000kg					
Drive Max A	Acceleration/Deceleration	-			2300r	nm/s ²				
Drive Varia	ble Speed Range	Auto measurement mode 0.01 – 700mm/s (Stepless control) Joystick and manual mode (Automatic measurement) 0 – 120mm/s (Stepless control)								
Drive Measu	uring Speed	Joystick and manual mode (Automatic measurement) 0 – 5mm/s								
Temperature	e Changes	1.0°C/hr, 2.0	°C/day (at	t 18 –	22°C & 16 – 2	26°C) 2.0°C/h	r, 5.0°C/	day (at	$15 - 30^{\circ}C^{2}$	
Temperature	e Gradient		1.0°	C/m (at 18 – 22°C, 1	6 – 26°C & 15	$-30^{\circ}C^{2}$	2)		
Air Supply /	Working Pressure				0.49 to 0.69M	Pa / 0.39MPa				
Air Consum	ption		85Nℓ/n	nin			90Nℓ/	min		
Power Supp	ly	Single	phase AC	100 t	o 240V±10% (factory pre-set). Ground	ding re	quired.	
Power Cons	umption				150	0W				
Machine Wi	idth x Height	1	1930 x 30	15mm	1	2	2180 x 34	415mm	1	
Machine De	pth	2050mm	2250m	nm	2550mm	2550mm	31501	nm	3650mm	
Machine We	•	3800kg	4100k	cg	4600kg	5200kg	6300	kg	7600kg	
	hight at Transport ³		2450m	0			27501	0	2	

¹ Evaluation methods are per current JIS B7440-2, -4 and -5 (ISO 10360-2, -4 and -5). $E_{0,MPE}$, $E_{150,MPE}$, $R_{0,MPL}$ and $P_{FTU,MPE}$ with stylus tip dia. Ø 5, length: 50mm for RDS; tip dia. Ø 4, length: 20mm for PH10. MPE_{THP} using stylus with tip dia. Ø 3, length: 50mm for RDS.

 2 Adapting to temperature condition 15 – 30°C is an Option for PH models.

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MJU NEX Low Maintenance Ergonomic CMM



- In popular 5/8/4 and 5/5/4 compact sizes
- 2.2+4L/1000µm at 18–22°C with PH10T+/TP200 probe
- 75% reduced air consumption and 73% savings on power due to using one air bearing hybrid guideways
- 40% reduced footprint and 37% lighter L-shaped bridge
- Smallest Ø 0.3mm stylus ball; 0.01µm res linear scales
- Max acceleration: 1732mm/sec²
- User-friendly, productivity savings; quick ROI
- Calypso or XYANA object-oriented software
- · Allows flexible workpiece changes and measuring tasks
- Applications: Replaces fixed, complex manual gages







Energy saving hybrid guideway mass/v





L-shape highly rigid low mass/vibration cast-iron bridge

V-shape Y-Axis reduce bimetal contact with granite table

mju	5/5/4			5/8/4				
Measuring Range X	x Y x Z	510 x 460 x 410mm				510 x 760 x 410mm		
Measuring Length S	cale	Linear scale system						
Min Display Value				0.01	μm			
Maagunamaa	Measurement Accuracy ¹		Commo	n for all r	nju NEX	K models		
Wieasuremen	It Accuracy	PH1/TP20	PH10/TP20	RTI	?20	PH10T/TP200B	PH1/TP200B	
E ₀		2.7+L/	250µm	2.7+L/	l 50µm	2.2+L/2	250µm	
E150	18 – 24°C	3.2+L/	250µm	N/	A	2.7+L/1	50µm	
R ₀	18 – 24 C	1.8µm		2.0	um	1.4	ım	
R _{FTU}		2.7µm		3.3	um	2.5	ım	
Guidance System for	r Each Axis	Air bearings						
Table Material/Flatn	ess/Clamping Screw	Gabbro / JIS Class 1 / M10 internal screw						
Table Dimensions W	/ x D x H	700 x 900 x 725mm				700 x 1150 x 72	25mm	
Max Workpiece Hei	ght / Weight			520mm	/ 200kg			
CNC Speed / Max A	cceleration		0.01 to 433mm/s	(Steples	s contro	l) / 1732mm/sec ²		
Joystick and Manual	Speed Range	(Automatic measurement) 0 to 120mm/s (Stepless control)					ol)	
Joystick and Manual	Fine Feed Speed		(Automati	c measur	ement) () to 5mm/s		
Air Supply / Workin	g Pressure	0.40 to 0.69MPa / 0.30MPa						
Air Consumption		10Nℓ/min						
Power Supply / Con	sumption	Sin	gle phase AC 100)V±10%.	Ground	ing required. / 801	W	
Machine Dimension	s W x D x H	1145 x	1256 x 2170mm			1100 x 1536 x 21	170mm	
Machine Weight			660kg			920kg		

 $^1\mbox{Evaluation}$ methods are per current JIS B7440-2, -4 and -5 (ISO 10360-2, -4 and -5).

E0, MPE, R150, MPE, R0, MPL and PFTU, MPE with stylus tip dia. Ø 4, length: 20mm. TP20 and RTP20 – LF Module. TP200B – SF Module.

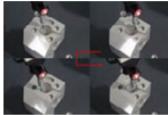


MJU NEX J NEW! Highly Accurate Manual Measurement



mju NEX J with integrated PC

- Newly-developed operation box with compact hand-held size and doublethumb stick for easy positioning and precise measurement
- Same excellent features of mju NEX such as the smallest footprint in its class, significant reductio of air and power consumption by the hybrid guide structure equipped with high-rigidity linear guides in X, Y (right) and Z axes and air bearings in Y axis (left), high environmental adaptability by installing dustproof covers in X and Y axes and Z axis scale in the Z axis column
- Auto-probing function provides probing at a constant measurement speed and force, making accurate and stable measurement possible
- Upgrading to CNC possible on site to efficiently support the creation of measurement plan and automatic measurement when mass production of future workpieces and inspection of workpieces with the large amount of lots are required



Automatic hole inner diameter measurement



Auto Probing

mju NEX J		5/5/4	5/8/4			
Measuring Range X x Y x Z		510 x 460 x 410mm	510 x 760 x 410mm			
Measuring Length Scale		Linear scale system				
Min Display Value		0.01	lμm			
Measurement Accuracy ¹ E ₀		2.9+L/	250µm			
Guidance System for Each A	xis	Air be	arings			
Table Material/Flatness/Clar	nping Screw	Gabbro / JIS Class 1	/ M10 internal screw			
Table Dimensions W x D x I	H	700 x 900 x 725mm	700 x 1150 x 725mm			
Max Workpiece Height / We	eight	520mm / 200kg				
Max Acceleration/Deceleration	ion	606mm/sec ² / 1039mm/sec ²				
Variable Speed Range/Meas	uring Speed	Manual Mode: 0.5 to 121mm/sec / 5mm/s				
Temperature Changes		1.0°C/hr, 2.0°C/d	ay (at 18 – 22°C)			
Temperature Gradient		1.0°C/m (at	: 18 – 22°C)			
Air Supply / Working Pressu	ire	0.49 to 0.69M	IPa / 0.30MPa			
Air Consumption		10N8	2/min			
Power Supply / Consumption	n	Single phase AC 100V±10%. Grounding required. / 550W				
Machine Dimensions (with	WxDxH	1805 x 1920 x 2170mm	1805 x 2200 x 2170mm			
data processing unit)	Weight	620kg	880kg			

¹Testing and evaluation methods are per current JIS B7440-2:2013 (ISO 10360-2:2009) with stylus tip dia. Ø 4mm, length: 20mm.



SVF NEX Proven and Trusted Manual CMM



- In popular 4/4/3, 6/5/3, 8/6/6/ and 8/10/6 sizes
- AI Function for enhanced efficiency
- Lightweight, surface-hardened aluminium alloy X-guide and Z-Axis, reduces fatigue even in long operating hours
- High-Rigidity Table with Surface Guides on Both Sides
- Rack cabinet for data processor resulting in 30% smaller footprint than existing model
- Workpiece, calibration ball and tablet PC set on the table reduces eye movements and increases efficiency
- Standard Touchscreen Colour LCD Monitor with XYANA2000 simplified object-oriented software



Z-Axis Terminate Switch standard



horizontal $\pm 115^{\circ}$ vertical rotation at 15°

pitch both direction with TP20 probe



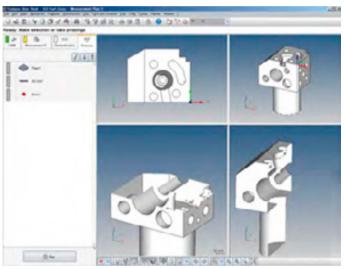
TP20 auto-probe change module. 5 or 6-way kinematic trigger; 4 force modules



MH20i Manual Indexable Probe Head with repeatable orientation 2-Axis indexing

SVF NEX	4/4/3	6/5/3	8/6/6	8/10/6					
Measuring Range X x Y x Z	400 x 350 x 300mm	600 x 500 x 300mm	800 x 600 x 600mm	800 x 1000 x 600mm					
Measuring Length Scale		Linear sca	ale system						
Min Display Value		0.01µm							
Eo	3.0+4L/1000µm	4.0+5L/1000µm	5.4+5.5L	/1000µm					
Guidance System for Each Axis		Air be	arings						
Table Material / Flatness		Gabbro / J	IS Class 1						
Table Clamping Screw		M10 inter	mal screw						
Table Usable Width x Depth	600 x 895mm	800 x 1045mm	1000 x 1250mm	1000 x 1750mm					
Table Height from Floor		760	mm						
Max Workpiece Height	450	mm	750	mm					
Max Workpiece Weight	300kg	400kg	600kg	800kg					
Probe Balance		Max 1kg (Inte	ervals of 200g)						
Air Supply / Working Pressure	0.3 to 0.69M	Pa / 0.27MPa	0.4 to 0.69M	Pa / 0.39MPa					
Air Consumption		40N4	2/min						
Power Supply / Consumption	Single	phase AC 100V±10%.	Grounding required. / 5	500VA					
Machine Dimensions W x D x H	990x895x2105mm	1190x1045x2105mm	1490x1250x2705mm	1490x1750x2705mm					
Machine Height at Transport ¹	1780	Omm	2080	Omm					
Machine Weight	580kg	770kg	1200kg	1700kg					

¹Z-Axis is folded down for transport. Please provide adequate allowances for passageways and lifting/support equipment used.



CALYPSO Powerful Versatile CMM Operations

- · CAD kernel for unmatched operability
- 3 AI automatic algorithms for element recognition (patented), coordinate system setting and measuring plane recognition for points, straight lines, flat surfaces, spheres, symmetrical points, circles, cylinders, cones, ellipses, square and long holes
- Auto Collision-Free Measuring Path Generation with safety/supplementary safety planes per number of measuring points and probing return distance
- · Flexible, Customisable Report Formats including colour scale evaluation of roundness
- · Geometric Division Evaluation for Flatness, Roundness and Straightness
- Actual Point Memory Difference of flatness measurement result allows re-calculation by selecting any points to be used
- · Error Plotting for display of evaluation of each point of circles and contours at any intervals of points
- Geometric Element Preview, Navigation for Measurement Procedures, Diverse Edit, Calypso Macro, Standard Simple-to-Use Off-Line Teaching, etc.
- Optional Programs: Table File Output, Statistics, TESCHART Plus: Inspection Chart Generation Program, Basic Reporter, Stylus Simulation, List Calibration, EDM Module, Hole Pattern Best Fit, Pipe Evaluation Function, DMIS Compatible System, Parameter Coded Measurement, Free Form Curved-Surface Evaluation
- Optional Interfaces: IGES 2D/3D, VDA 2D/3D, STEP 3D, DXF 2D, PMI and FTA direct processing or native interfaces: ParaSolid, CATIA V4, CATIA V5, ProEngineer, UniGraphics, Inventor and SolidWorks



On-screen Articulating Probe Head Angle Simulation



Geometric Element Preview



Interchange of Icons



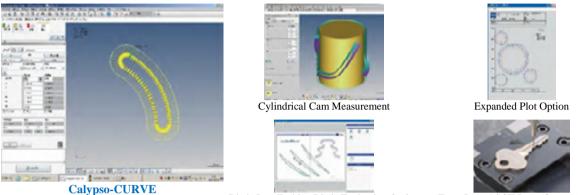
Automatic Stylus Calibration



Calypso Auto Run Function

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Calypso Curve Option for 2D and 3D curves: curve slope, length, form, cam throw, surface area, etc., for crank/camshafts, turbine blades etc.



Blade Pro: Turbine Blade Evaluation Option



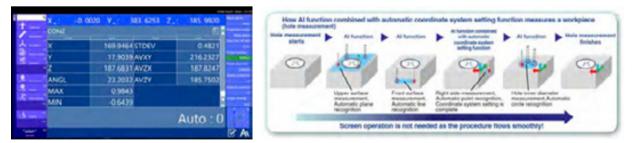
Form Data ASCII Input/Output Option

TESCHART Plus Optional Inspection Chart Generation Program



- · Import measurement results into Excel and create inspection charts
- Set measurement procedures easily. Re-use the layout once an inspection chart is created in Excel sheet
- New DB function for storing database results as well as searching/referencing past results

XYANA smart[®] General Purpose Measuring Software for Manual CMM



- · For highly reliable measurement with mju NEX J and SVF NEX
- Intuitive user interface supporting both touch input and key-in
- Reduce duration of preparation and measurement with functions such as AI for automatic geometric feature judgement, voice guidance, coordinate system assist, automatic inner hole diameter measurement, etc.
- · Eliminate factors that may negatively affect measurement results in advance to prevent breakdown and shipment of defective products with alerts
- · Support for accurate measurement that reflects the actual conditions

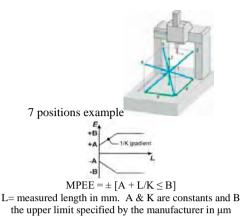
CMM Acceptance Methods

ISO 10360 and JIS B7440 Maximum Permissible Error (MPE) include consideration of material standard calibration uncertainty, alignment method uncertainty, reference sphere form deviation and all other material factors including measuring uncertainty.

Volumetric Length Indication Error E₀ and E₁₅₀ (ISO 10360-2)

A step, block or other artefact gage is used with a total of 105 length dimensions - 5 gauges of varying lengths measured 3 times from 7 different directions within the CMM's measuring range. E_0 is the maximum difference between the standard calibration value and the measured values, and must be within E_{150} . For E_{150} 5 length gauges have to be measured 3 times in the YZ-or XZ plane with opposite styli, mounted 150mm off the Z spindle axis



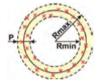


ACCRETEC

Limit of Repeatability Range R0 MPL (ISO10360-2) - From the E0 test values, for each of the 35 sets of 3 repeated length measurements, the difference between the maximum and minimum of the 3 test values is calculated. If these are equal or less than the specified limits, the CMM has met its specification.

Probing Error P (ISO 20160-2) - Any 25 points approximately evenly distributed are measured on a hemisphere of a test standard sphere of Ø 10-50mm, and the least squares method center position is calculated. The distance R from this sphere center location to the 25 measured points is calculated. Probing error P is the difference between the maximum value and the minimum value of the distance of the 25 locations R (R max-R min). Test judgment verifies that this probing error P is less than the MPEP specified by the manufacturer, considering measuring uncertainties, expressed in μ m units.





Probing Target Contact Points

- 1 point at pole determined by styli shaft direction
- 4 evenly spaced points 22.5° below the pole
- 45° below the pole: 8 evenly spaced points rotated 22.5° from the previous group
- 67.5° below the pole: 4 evenly spaced points rotated 22.5° from the previous group
- 90° below the pole (equator): 8 evenly spaced points rotated 22.5° from the previous group

Scanning Probing Error THP (ISO 10360-4) - A Ø 25mm test standard sphere is scanned at four sections with measuring pitch of 0.1mm and the least squares method center position is calculated. The distance R from this sphere center location to all of the measured points is calculated and scanning probing error THP is (1) the difference between the maximum and minimum values of the distance of the locations R (R_{max} - R_{min}); or (2) the maximum absolute value of the difference between all distances R and half the corrected diameter of the test standard sphere. Both of the above scanning probing errors THP must be within the THP specified by the manufacturer. Time for scanning test is in seconds. A precision sphere has to be scanned with 4 defined lines. THP is the range of all radii. THP = $R_{max} - R_{min}$ = sphere form, scanning.



Scanning Section

- Desirable slope angle α: 45°
- Sect 1: Equator
- Sect 2: Shifted 8mm parallel to Section 1
- Sect 3: From the equator, passing through the pole
- Sect 4: Shifted 8mm parallel to Section 3
- Sections 2 and Sections 3 and 4 are perpendicular

Single stylus form error PFTU (ISO 10360-5) - Any 25 points approximately evenly distributed are measured on a hemisphere of a test standard sphere of Ø 10 to 50mm, and the least squares method center position is calculated. The distance R from this sphere center location to the 25 measured points is calculated. PFTU is the difference between the maximum and minimum values of the distance of the 25 locations R ($R_{max} - R_{min}$). This PFTU must be within the PFTU specified by the manufacturer, considering measuring uncertainties, expressed in μ m units. A precision sphere has to be measured with 25 probings. PFTU is the range of all radii. PFTU = $R_{max} - R_{min}$ = sphere form.





ROUGHNESS & CONTOUR Line Up at a Glance!

			sure tions		Dete	ctor '	Туре			Speci	fications				
Classification	Model	Roughness	Contour	Roughness: Analog	Contour: Analog	Contour: Digital	Integrated: Analog	Integrated: Digital	Detector Stroke Z	Contour Detector Indication Accuracy Z	Detector Resolution Z	Tracing Driver Straightness Accuracy X			
Roughness	S NEX 001	0	-	0	-	-	-	-	1000µm	-	0.1-20nm	0.05+L/1000µm			
C 1	S NEX 030		0			0			(0)	±1.5+ 2H /100µm		1µm/100mm			
Contour	S NEX 040	-	0	-	-	0	-	-	60mm	$\pm 0.8 + 2H /100 \mu m$	0.02µm	(2µm/200mm)			
Combined	S NEX 031	_		_		_			S NEX 031combines NEX 001 + NEX 030. Refer to thos						
Roughness/ Contour	S NEX 041	0	0	0	-	0	-	-	S NEX 011 combines NEX 001 + NEX 040. Refer to those spec						
Integrated Hybrid Roughness/	S NEX 100	0	0	0	-	0	-	-	$5mm \qquad \pm 1.0 + 2H /100 \mu m \qquad \begin{array}{c} Roughness: \\ 1-100nm, \\ Contour: \\ 0.015 \mu m \end{array} 0.$		0.05+L/1000μm				
Contour	S CREST	0	0	-	-	-	-	0	13mm	$\pm 0.2 + H /1000 \mu m$	0.31nm	0.05+3L/10000µm			
	S1400G	0	-	0	-	-	-	-	800µm	-	0.4-10nm (0.1nm) ¹	0.05+1.5L/1000μm			
	S Touch 550	0		0					1000		0.1-1.25nm				
Roughness	S Touch 50	0	-	0	-	-	-	-	1000µm	-	0.1-1.25nm	0.3µm/50mm			
C	S Touch 35/40/45	0		0					270		0.7nm				
	handysurf+ 35/40/45	0	-	0	-	-	-	-	370µm	-	0.7nm	-			
C	C1600G		0		0	-			50	±0.25% Full scale	0.1-1µm	1µm/100mm			
Contour	C2600G	-	0	-	-	0	-	-	50mm	$\pm 0.8 + 4H /100 \mu m$	0.025µm	2µm/200mm			
Combined	S1800G	0	6	0	0	0	-			S1800G	combines S1400G a	nd C1600G.	Refer to those specs		
Roughness/ Contour	S2800G C		0	0	-	0	_	-	S2800G	combines S1400G a	nd C2600G.	Refer to those specs			

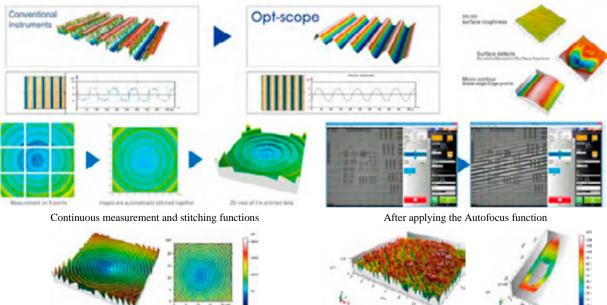
¹When high-magnification pickup is used.

Z ACCRETECH

OPT-SCOPE^{*NEW!*} Non-Contact Versatile Roughness Evaluation



- Proprietary Peak Detection Algorithm of white interference fringe (DEAP) cum high-resolution of PSI (Phase Shifting Interferometry) with wide range of VSI (Vertical Scanning Interferometry)
- High-speed camera with new high-speed dedicated algorithm DEAP2 makes the Opt-scope 6 times faster compared with previous models
- · Fast, comprehensive 3D surface texture and profile measurements of superfine surfaces and machined components
- · Non-contact measurements, hundreds of times faster than styli instruments
- · Quick measurement with original white light interferometer
- EDR function that uses two different amounts of light in one scan to obtain accurate and complete measurement of surfaces with strong brightness contrast
- · Continuous measurement and stitching with the optional electric stage to conduct measurement beyond the field of view for analysis as a single piece of measurement data
- Non-contact, highest resolution, and wide range 3D evaluation of grinding stones, needle pins and blades and various workpieces
- · Applications include fine roughness, scratches, abrasion, grinding stone edges and cemented carbide tips
- Compliant with ISO 25178-2 and JIS B 0681-2 3D Surface Texture Parameters



Advanced Contour Analysis

Grain Analysis

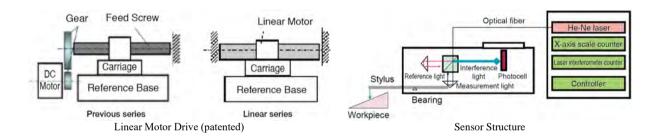
Fine Roughness Evaluation -Tip of injection needle



SURFCOM CREST Highest Accuracy and Speed



- Highly stable laser interferometer optical path with wide Measurement range Z: 13mm and X: 200mm
- Resolution to 0.31nm at 13mm Z-Axis measuring range!
- Dynamic range: resolution ratio of 42000000:1! Allows contour profiles and hidden fine surfaces to be evaluated in one trace
- Linear motor drive for high speed movement with low vibration for high accuracy stable measurement at high magnifications
- Tilting Unit Model Surfcom Crest-T with up to 45° motorized tilting unit also available

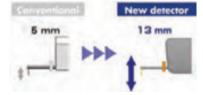


Z-Axis Measuring Range	13mm/50mm; 26mm/100mm
Z-Axis Accuracy	\pm (0.2+H/1000) µm (where H=Measuring Height in mm)
Z-Axis Resolution/Scale Sensor	0.31nm for 50mm arm/Highly stable Optical Path Laser Interferometer
X-Axis Range	200mm
X-Axis Indication Accuracy	\pm (0.2+L/1000) µm (where L=Measuring Length in mm)
X-Axis Resolution/Sensor	0.54nm/Optical Diffraction Scale
Straightness Accuracy ¹	(0.05+3L/10,000) µm (where L=Measuring Length in mm)
System Noise ^{1,2}	$Ra \le 2nm/0.4mm; Rz \le 10nm/0.4mm$
System Form Error ^{1,3}	$Pt \le 0.1 \mu m $ (Ø 30mm or smaller)
Max Permissible Radius ^{1,4}	$\leq \pm 0.1 \mu m$ (Ø 30mm or smaller)
Max Permissible Distance ^{1,5}	$\leq \pm (1+L/150) \mu m$ where L: measuring length in mm
Max Permissible Angle ^{1,6}	$\leq \pm 0.5 \min(\pm 45^{\circ})$
Z Column Up-Down Speed	Up to 200mm/s
X Measurement/Movement Speed	0.03 to 3mm/s (roughness); 0.03 to 20mm/s (contour)/0.02 to 60mm/s max
Drive Unit Tilt	±45° (T type)
Stylus Characteristics	Replaceable Diamond stylus; 0.75mN measuring force; 2µm radius (50mm arm) with retract function
Power Supply	Single phase AC 100 to 240V±10%. Grounding required. 50/60Hz.
Air Supply / Consumption	Supply Pressure: 0.45 to 0.7MPa, Working Pressure: 0.4PA / Max 8ℓ/min
Machine Dimensions WxDxH / Weight	1405 x 1050 x 1851mm / 700kg

¹ With DM84145 standard accessory. ²0.03mm/s, Gaussian filter: $\lambda c=0.08$ mm, $\lambda s=2.5$ µm. ³±45°, 0.3mm/s, LSC, Gaussian filter: $\lambda s=0.08$ mm. ⁴±45°, 0.3mm/s, Gauge uncertainty included. ⁵0.3mm/s, Gauge uncertainty included. ⁶Length of one sloop side: 5mm or more, 0.3mm/s, Gauge uncertainty included.

SURFCOM NEX IMPROVED! Hybrid / Roughness / Contour Metrology

- · World-first dual sensor hybrid detector: combines wide-range highaccuracy and narrow-range high resolution sensors for simultaneous roughness and contour measurement (Patented)
- Newly developed wide-range hybrid detector with 13mm Z-axis measurement range (2.6 times wider than conventional detectors)
- · Patented high-accuracy linear motor tracing driver minimizes vibration which improves actual values to unmatched levels
- · Patented newly-developed column design enables extremely highspeed driving for shorter tact time
- Operation panel with new override dial for real-time control of the driving speed
- Highest Z Indication Accuracy in class: $\pm (1.0+2H/100)\mu m$
- · Contour Detector incorporates linear drive with temperature correction system providing guaranteed 20°C±5°C range
- Quick-change arm with auto-recognition (Patent Pending)
- Z-axix measurement range expanded to 60mm (±30mm)
- · T-shaped continuous upward/downward measurement stylus
- · Manual gear and linear measurement connection automatic cut-off mechanism during measurements to preserve linear motor low vibration characteristics for high operability and accuracy



Newly developed wide-range hybrid detector



Measure ultra-low vibration and operate at 20±5°C





SURFCOM NEX

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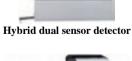
Freely combine and change detectors



System for Roughness, Contour or Hybrid Detectors, Driver Unit and Measuring Stands

Detector Selection

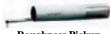
- · Measures roughness and contour concurrently
- Indication accuracy: ±(1.0+|2H|/100)µm; Measuring range (Z-Axis): 13mm (standard stylus)



Contour detector



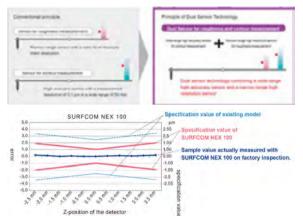
High-accuracy contour



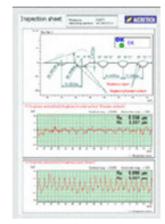
Roughness Pickup

- · General purpose detector with new high-precision scale
- · Simple replacement with Quick-change arm; Upward/downward measurement option
- Indication accuracy: ±(1.5+|2H|/100)μm; Measuring range (Z-Axis): 60mm
- · High accuracy detector with new laser diffraction linear scale for full-range measurement resolution of 0.02µm; Indication accuracy: ±(0.8+|2H|/100)µm; Measuring range (Z-Axis): 60mm
- · Auto measuring force adjustment mechanism over 60mm Z-Axis measurement range and quick-change arm mechanism; Upward/downward measurement option
- · High magnification wide-range measurements
- 14mm outer diameter; 1000µm measurement range; 500,000 times max measurement magnification
- · For pickup upward measurement (with the auto-stop function) and horizontal trace measurements.



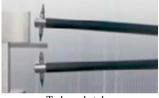


Hybrid Dual Sensor Detector





Attaching 100mm High rigidity offset arm

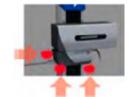


T-shaped stylus

Contour Detectors



Attaching lower offset arm attachment



Safety mechanism against detector collision

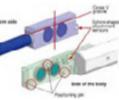
Roughness Detector



Measurement range of 1000µm in the Z direction



Auto stop possible for upward measurements



Quick Change Arm



Optional Attachment for quick change arm



SURFCOM NEX DX2/SD2 Specifications

	SURFCOM NEX	-12	-13	-14	-15	-22	-23	-24	-25		
X-Axis Tracin	g Driver Sensing Method				Linea	r scale					
X-Axis Measu	rring Range		100	mm			200	mm stylus 00mm stylus 0µm/200mm g L in mm)			
Z-Axis Colum	n Up/Down Stroke in mm	250	4	50	650	250	60 450 6 LH=50mm stylus				
	Hybrid Detector with Dual Sensor Technology	0.05+1.0L/1000μm with LH=50mm stylus 2(0.05+1.0/1000)μm with LH = 100mm stylus									
Straightness	High-Accuracy Contour Detector	0.8µm/100mm 2.0µm/200mm									
Accuracy	General-Purpose Contour Detector		0.8μΠ/	TOOMIN			2.0µm/	20011111			
	Pickup for Roughness Measurement		0.05 +	1.0L/10	00µm (L	.: Measu	ring L i	n mm)			
X-Axis Indica	tion Accuracy / Resolution	±	0.8+1.0	L/100µ1	n or ± 0 .	8+3.0L/2	200µm /	0.016µı	n		
X-Axis Movir	ng / Measuring Speed		C	0.03 to 1	00mm/s	/ 0.03 to	o 30mm/	's			
X-Axis Tilt A	ngle			±15° (Optiona	l tilting o	levice)				
Measuring Sta	nd Column Max Travel Speed / Base Material		CNC	C 50mm	/s; Joyst	ick 50m	250 450 6. n LH=50mm stylus				

	Hybrid Detector with Dual Sensor Technology (E-DT-CR14B)
Z-Axis Measuring Range	13mm (LH=50mm stylus), 26mm (100mm stylus)
Roughness Sensing Method	High accuracy scale
Roughness and Contour Resolution	0.9 (Full range) (LH=50mm stylus) 1.8 (Full range) (LH=100mm stylus)
Indication Accuracy (H: Measuring Height in mm)	±1.0+2H/100μm (LH=50mm stylus) ±1.5+2H/100μm (LH=100mm stylus)
Stylus Characteristics for Roughness & Contour	DM84071 (LH=50mm, Standard arm),
Styrus Characteristics for Roughness & Contour	Replaceable 2µm radius / 60° Cone, Diamond, 0.75mN
Stulue Characteristics for Contour	DM48775 (LH = 100mm, 2x arm)
Stylus Characteristics for Contour	Replaceable 25µm radius / 24° Cone, Cemented Carbide, 4mN
Common Functions	Downward Measurement/Collision Detection Safety/Retract function

	High-Accuracy Contour Detector	General-Purpose Contour Detector					
Z-Axis Measuring Range	60mm						
Contour Measurement Sensing Method	Laser optical diffraction scale	High Accuracy Scale					
Contour Measurement Range / Resolution	0.02nm (Full range)	0.04nm (Full range)					
Indication Accuracy (H: Measuring Height in mm)	$\pm 0.8 + 2H /100 \mu m$	±1.2+2H/100μm at 20±2°C ±1.5+2H/100μm at 20±5°C					
Contour Functions	Down/Up Measurement / Collision	Detection Safety / Retract Function					
Strulus Characteristics for Contour (DM45505)	Replaceable 25µm radius / 24° Cone, Cemented Carbide						
Stylus Characteristics for Contour (DM45505)	2 to 30mN (Set with ACCTee)	10 to 30mN (Manual Adjustment)					

	Pickup for Roughness Measurement (E-DT-SS01B)
Z-Axis Measuring Range	1000mm
Roughness Sensing Method	Differential inductance
Roughness Measuring Range / Resolution	6.4 to 1000µm / 0.1 to 20nm
Roughness Functions	Down/Up Measurement / Upper Safety Limit
Stylus Characteristics for Roughness (DM43801)*1	Replaceable 2µm radius / 60° Cone, Diamond, 0.75mN

Common Specifications

Power Supply / Consumption	Single phase AC 100 to 240V. Grounding required. 50/60Hz. / Max 930VA
Air Supply / Working Pressure / Consumption	0.45 to 0.7MPa / 0.4MPa / 0.1ℓ/min (Max. 10ℓ/min)
Air Supply Port Position	Main body lower left (DX2) Main body back side (SD2 with anti-vibration table)
Air Supply Connecting Port	One-touch pipe joint for tubes with Outer Diameter Ø6mm
Accuracy Guaranteed Operation Temperature *2*3	20±5°C
Operating Temperature / Storage Temperature	15 to 30°C / 5 to 40°C
Operation Guarantee / Storage Humidity	40 to 80% / 80% or lower (without condensation)

¹Excluding when using roughness pickup. ²Guaranteed accuracy is excluding deformation of workpiece, caused by temperature change. ³Indication accuracy (vertical) with general-purpose contour detector is variable depending on temperature range. ^{Notes} Power and air supply and connecting hose required before the delivery. Power Supply (type D grounding) required. Guaranteed accuracy temperature limit is $\pm 0.5^{\circ}$ C/hour and 0.1°C/measurement time. Specifications may change without any notice due to product modifications.



DX2	Туре	Main	Unit Dime	ensions	Table Column Measuring rang			ng range	Ва	ise	Weight (kg)			
	unless	Width W1	Depth D1	Total Height H1	Height H2	Height H3	X-Axis	Z-Axis	Width W2	Depth D2	Main unit	Total Weight ¹	Max Load	
	12	960		1489		634	100	250	700 1000	- 450	277	290	82	
	13	900		1689		834		450			284	297	75	
	14	1261	800	1689		834		450			407	420	95	
DX2	15	1201		1909	855	1054		650			421	434	81	
DA2	22	960	800	1489	833	634		250	700		284	297	75	
	23	900		1689		834	200	450	700		291	304	68	
	24	1261	1	1689		834	200	450	1000		414	427	88	
	25	1201		1909		1054	-	650			428	441	74	

SURFCOM NEX DX2 Type External Specifications

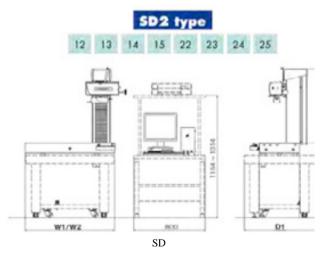
¹ Includes PC, driver unit and monitor.

SURFCOM NEX SD2 Type External Specifications

DX2	Туре	Main	Unit Dime	ensions	Table	Column	Measuri	ng range	Ba	ise	١	Weight (kg	g)
	unless	Width W1	Depth D1	Total Height H1	Height H2	Height H3	X-Axis	Z-Axis	Width W2	Depth D2	Main unit	Total Weight ²	Max Load ³
	12	700	626	1452	010	634	$\frac{4}{4}$ 100 $\frac{4}{4}$	250	700		119	132/217	81
	13	700	636	1652	818	834		450	1000		126	139/224	74
	14	1000	780	1675	0.4.1	834		450			206	219/442	54
SD2	15	1000		1895	841	1054		650		450	220	233/456	40
5D2	22	700	(2)	1452	010	634		250	700	450	126	139/224	74
	23	700	636	1652	818	834	200	450	700		133	146/231	67
	24	1000	0 700	1675	841	834	200	450	1000		213	226/449	47
	25	1000	780	1895		1054		650			227	240/463	33

 2 Left values: includes PC, driver unit and monitor. Right values: includes PC, driver unit, monitor and optional accessories (anti-vibration table, stand, rack) 3 Max Load is the value with optional anti-vibration table).





Surfcom Touch 550 Ergonomic Roughness Measurement

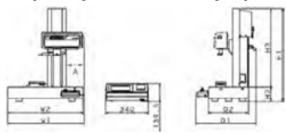


Surfcom Touch 550

- Electric column for high accuracy and size variation
- 1mm Z Range and 0.1nm min. resolution skid-less measurement

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- Roughness/waviness even on undulating stepped or round surfaces can be evaluated in one trace
- Easy levelling/zeroing before measurement
- Modularly combine granite bases and columns to accommodate your workpiece height and X-Axis drive range requirements



Surfcom Touch 550	-11	-12	-13	-14	-21	-22	-23	-24		
Z-Axis Measuring Range		±500µm								
X-Axis Measuring Range		100	mm			200)mm			
X-Axis Straightness Accuracy		0.05+1.5L/1000μm								
X-Axis Measurement Speed	0.03, 0.	0.03, 0.06, 0.15, 0.3, 0.6, 1.5, 3, 6 / 0.05, 0.1, 0.2, 0.5, 1, 2, 5mm/s (switching)								
X-Axis Moving Speed	Up to	3mm/s (wi	ith Touch a	amplifier);	Up to 6mm	n/s when u	sing the jo	ystick.		
Pickup Sensing Type			Ι	Differential	Inductanc	e				
Pickup Measurement Method			S	Skidless/Sk	id (Option)				
Pickup Z Direction Resolution			0.0001µr	n/±40µm, (0.00125µm	n/±500µm				
Stylus Characteristics		2µm r	adius, 60°	Cone, Dia	mond, 0.75	5mN (DM4	43801)			
Machine Max Width W1		610mm		1000mm		670mm		1000mm		
Machine Max Depth D1		481mm		586mm		481mm		586mm		
Machine Max Height H1	667mm	738mm	938mm	963mm	667mm	738mm	938mm	963mm		
Machine Column Height	552mm	623mm	823	Smm	552mm	623mm	823	mm		
Column Travel Range	250	mm	450	0mm 250		0mm 450		mm		
Base Width W2		600mm		1000mm		600mm		1000mm		
Base Depth D2		317mm		450mm		317mm	450mm			
Base Height		115mm		140mm		115mm		140mm		
Column Set (Position A)		140mm		240mm		140mm		240mm		
Machine Weight	89kg	95kg	104kg	209kg	94kg	100kg	109kg	214kg		
Measurement Stand Column Moving Speed	N/A (Manual)		's with Tou m/s with j	1 /	N/A (Manual)		/s with Tou nm/s with j			
Measurement Stand Base Size in mm		600x317		1000x450		600x317		1000x450		
Measurement Stand Base Material				Gra	nite					
Measurement Stand Max Load ¹	48kg	42kg	33kg	48kg	43kg	37kg	28kg	43kg		
Power Supply / Consumption	Single phase AC 100 to 240V±10%. Grounding required. 50/60Hz. / Max 110VA									
Dimensions W x D x H / Weight	Amplification Indicator: 340 x 214.5 x 139.5mm / Approx. 4.1kg									
Standard Accessories				S24C, level er E-CH-S2						

¹This max load is when using the optional antivibration table (E-VS-S57B for -11/12/13/21/22/23 system, and E-VS-R16B for -14/24 system).



Surfcom Touch 50 Portable Roughness Measurement





Optional compact stand for tall workpieces or jigs

Surfcom Touch 50

- Compact tracing driver with 50mm X-Axis/vertical range and 0.3µm/50mm straightness accuracy precision
- · Versatile hi-res pickup plus styli for deep, long, small holes or round surface
- Wide Z range to 1mm and 0.0001µm min. resolution skid-less measurement
- · Roughness/waviness on undulating, stepped or round surfaces in one trace
- · Easy pre-measurement levelling/zeroing
- · Handy-type tracing driver for measuring on vertical, ceilings or narrow areas

Surfcom Touch 50					
Measuring Range Z Direction	±500μm (total 1,000μm or 1mm)				
Measuring Range X Direction	50mm				
Tracing Driver Evaluation Length	0.1 to 50mm				
Tracing Driver Straightness Accuracy	0.3µm/50mm				
Tracing Driver Measurement Speed	0.15, 0.3, 0.6, 1.5, 3 / 0.05, 0.1, 0.2, 0.5, 1mm/s (Switching)				
Pickup Sensing Type	Differential inductance				
Pickup Measurement Method	Skidless/Skid (Option)				
Pickup Z Direction Resolution	0.0001µm/±40µm, 0.00125µm/±500µm				
Stylus Characteristics	2µm radius, 60° Cone, Diamond, 0.75mN (DM43801)				

Built-in Battery with AC adaptor	3-hour full charge for ≈ 600 measurements			
Power Supply / Consumption	Single phase AC 100 to 240V±10%. Grounding required. 50/60Hz. / Max 80VA			
Dimensions W x D x H / Weight	Printer Model: 320 x 167 x 44mm / Approx. 4.2kg			
	No Printer Model: 252 x 167 x 44mm / Approx. 3.8kg			
Standard Accessories	Roughness specimen E-MC-S24C, touch pen E-MA-S112A, printing paper E-CH- S25A ¹ , instruction manuals, SupportWare II			

¹ For models with printer only.



Z-Axis measurement range to 1,000µm (for Surfcom Touch 550 and 50 only)



Easy user's guide



Intuitive screen for condition setting, calibration, measurement and analysis



USB/micro USB ports as standard equipment

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Multi-language support

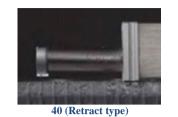


Measurement results can be printed quickly



Ultra-Portable Roughness handysurf+ / Surfcom Touch 35/40/45







- Widest in class 370µm Z measuring range with 0.0007µm max resolution over the entire range
- Choice of tracing drivers for various measurements:
 - 035 (standard) for horizontal, inclined, vertical and ceiling surfaces
 - 0 40 (retraction type) raises pickup before or after measurement to avoid damage to stylus/pickup
 - 0.45 (horizontal tracing) transverse trace: pickup moves sideways in narrow crankshaft pins and journals, etc.
- Library of replaceable pickups for small or extremely small holes, deep grooves, etc.

Drive	-3	-35 -40			-45	
Tip Radius	5µm	2μm	5µm	2μm	5µm	
Measuring Range Z		-210 to -				
Drive Range		X Directi	on 16mm		Y Direction 16mm	
Tracing Driver Type	Stan	dard	Retra	ction	Horizontal Tracing	
Tracing Driver Evaluation Length		0.2 to	0.2mm to 4.0mm			
Tracing Driver Measurement Speed		0.5, 0.6, 0.75, 1.0mm/s 0.6mm/s				
Pickup Sensing / Measurement			Differential Inc	ductance / Skid		
Pickup Z Resolution		0.0	007μm over rar	nge -210 to 160	μm	
Pickup Model	E-DT-SM10A	E-DT-SM49A	E-DT-SM10A	E-DT-SM49A	E-DT-SM39A	
Pickup Stylus Measurement Force	4mN	0.75mN	4mN	0.75mN	4mN	
Pickup Stylus Tip Radius	5µm	5μm 2μm		2µm	5µm	
Pickup Stylus Tip Angle	90° cone	60° cone	90° cone	60° cone	90° cone	
Pickup Stylus Tip Material	Diamond					

Choice of Processors



handysurf+

Compact, versatile. Detachable display and tracing driver.

• Calibration table E-WJ-S1045A, roughness specimen E-MC- • USB port for small printer, USB memory stick and PC S24C, touch pen E-MA-S112A, printer paper E-CH-S25A, SupportWare II V-type nosepiece E-WJ-S536A are included

Handy-type driver can be attached

- · Easy to calibrate without driver height/inclination adjustment
- 2.4-inch color LCD. 6 buttons UI for intuitive operations. Multiple analysis functions. 10 sets measurement data stored
- handysurf+ Surfcom Touch 35/40/45 3-hour full charge for ≈ 600 measurements 4-hour full charge for ≈ 1000 measurements Built-in battery with AC adaptor Power Supply Single phase AC 100 to 240V±10%. Grounding required. 50/60Hz. Power Consumption Max 80VA Max 10W 320 x 167 x 44mm / 2kg (Printer Model) Dimensions W x D x H / Weight 184.5 x 68 x 57.4mm / Approx. 500g 252 x 167 x 44mm/ 1.6kg (No Printer)



Surfcom Touch / handysurf+ Panel

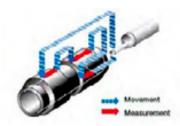
		Surfcom Touch	handysurf+					
Analysis Defi	nition Standards	Comply with JIS2013/2001, JIS1994, JIS1982, ISO1997/2009, ISO13565, DIN1990,						
		ASME2002/2009, ASME1995, CNOMO						
Profile Curve	Analysis	Pa, Pq, Pp, Pv, Pc, PSm, P Δ q, PPc, Psk, Pku, Pt, Pmr(c), Pmr, P δ c, Rz82, TILTA, AVH, Hmax, Hmin, AREA, Rmax, Rz, Sm, Δ a, Δ q, λ a, λ q, Lr, Rsk, Rku, Rk, Rpk, Rvk, Mr1, Mr2, Vo, K, tp, tp2, Hp						
Roughness Cu	ırve Analysis	Ra, Rq, Rz, Rv, Rc, Rt, RSm, R Δ q, Rsk, Rku, Rmr(c), Rmr, R δ c, Rz94, R3z, R Δ a, R λ a, R λ q, Ry, Lr, Sm, S, tp, tp2, PC, RPc JIS, RPc ISO, RPc EN, Pc, PPI, Rp, Rmax, Rz.I, RS, Rmr2, Mr1, Mr2, Rpk, Rvk, Rk, Vo, K, A1, A2, Rpm, Δ a, Δ q, Htp	Ra, Rq, Rz, Rv, Rc, Rt, RSm, R Δ q, Rsk, Rku, Rmr(c), Rmr, R δ c, Rz94, R3z, R Δ a, Ry, Sm, S, tp, PC, RPc JIS, RPc ISO, RPc EN, Pc, PPI, Rp, Rmax, Mr1, Mr2, Rpk, Rvk, Rk, Vo, K, A1, A2, Rpm, Δ a, Δ q, Htp					
Motif Analysi	s		e, NCRX, NR, CPM, SR, SAR, Wte, NW, le, Mr2e, Vo, K					
	file Curve Analysis Touch 550/50 only)	Wa, Wq, Wt, Wp, Wv, WSm, WPc, Wsk, Wmr(c), Wmr, W δ c, Wz, Wc, Wku, W Δ q, WEM, WEA, WE-a, WE-q, WE-p, WE-v, WE-Sm, WEC-q, WEC-m, WEC-p, WEC- v, WEC-SmN/A						
Evaluation Curve	For all models	Profile Curve, Roughness Curve, ISO13565 Special Roughness Curve, Roughness motif curve, Waviness motif curve, Upper envelope waviness curve						
Analysis	Extra for 550/50	Filtered Waviness Curve, Waviness Profile Curve, Rolling Circle Waviness Curve						
Characteristic	s Graph Analysis	Abbot curve, Amplitude density function, Power graph	Bearing area curve, Amplitude distribution curve					
Filter Type		Gaussian, 2RC (phase compensation), 2RC (non-phase compensation)						
			2.5mm (all models)					
Filter Cutoff	Value λc	8 and 25mm (extra for Surfcom Touch 550 and 50)						
Filter Cutoff	Value λ s	None, 2.5, 8, 25µm	None, 2.5, 8µm					
Amplifier Dis	play	7-inch color liquid crystal touch panel	2.4-inch color liquid crystal panel					
Amplifier Data Output		USB connector – 2 (model without printer) / 1 (model with printer), 1 Micro USB	1 USB memory connector, 1 Micro USB communication connector					
Printer		Integrated for 550; optional integrated or external for 50 and 35/40/45	Optional external printer					
Printer Outpu	t (models with printer)	Thermal recording paper width:	58mm (recording width: 48mm)					
Amplifier Lar	plifier Language Japanese, English, Chinese, Korean, Thai, Malay, Vietnamese, Indonesian, Ge French, Italian, Czech, Polish, Hungarian, Turkish, Swedish, Dutch, Spanish, Po							

X ACCRETECH

SURFCOM 1400G Conventional Robust Roughness Measurement



- · Patented AI auto-selects roughness measuring conditions
- Teaching function to automate repeat measurements and generation of final reports
- Special film thickness step/area, wear volume calculation (superimposed profile area) and LCD glass substrate (special waviness) evaluations
- Re-perform analysis with different measurement standards, evaluation range and removal of data from a notch
- 3DF X-Y table upgrade option
- Expands to Surfcom 1800G by adding contour detector



SURFCOM 1400G

Teaching function memorizes and automates a series of measurements at multiple locations and generates reports

Surfcom 1400G		-11	-12	-13	-14	-21	-22	-23	-24
Z-Axis Measuring Rang				800	μm				
X-Axis Measuring Rang	ge		100mm			200mm			
Tracing Column Up-Do	own Stroke	250	mm	450)mm	250	mm	450)mm
Resolution / Range		0.02µm to	o 0.0004µr	n (0.0001)	um) ³ / 800	um range	to 25µm ra	ange (6.4µ	m range) ³
X-Axis Tracing Driver	Indication Accuracy		\pm (1+2L/100) µm (L: Measuring length in mm)						
X-Axis Resolution					0.1	μm			
X-Axis Tracing Driver Accuracy	Straightness		0.05	+1.5L/100	$00 \mu m (L = 1)$	measuring	length in	mm)	
X-Axis Tracing Driver	Sensor		Moiré str	iped scale			Linea	r scale	
X-Axis Measurement S	peed		0.03	, 0.06, 0.1	5, 0.3, 0.6,	1.5, 3, 6m	ım/s (8 spe	eeds)	
Z-Axis Column Up-Dov	wn Speed	N/A	10n	nm/s (3mn	n/s) ¹	N/A	10n	nm/s (3mn	n/s) 1
Detector Sensing Metho	od	Differential Transducer							
Stylus Characteristics					um radius, 75mN. On				
Table Dimensions in m	m		600x317		1000x450		600x317		1000x450
	E-VS-S57B/S58B	48kg	42kg	33kg	N/A	43kg	37kg	28kg	N/A
Max Part Weight with	E-VS-S45A	50kg	40kg	30kg	98kg	50kg	40kg	30kg	93kg
Anti-Vibration Table	E-VS-R16B	50kg	40kg	30kg	48kg	50kg	40kg	30kg	43kg
	E-VS-R21B	50kg	40kg	30kg	100kg	50kg	40kg	30kg	100kg
Machine Width ²		2000mm		2300mm		2000mm		2300mm	
Machine Depth ²		1000mm							
Machine Height ²		1700)mm	190	0mm	1700)mm	190	0mm
Machine Weight		115kg	120kg	130kg	235kg	120kg	125kg	135kg	240kg
Power Supply / Consun	nption	Sing	gle phase A	AC 100V±	10%. Grou	nding req	uired. 50/6	60Hz. / 710	OVA

¹ Joystick operation.

 2 Optional stand, anti-vibration table and computer rack incl. in dimensions.

³ Using high-magnification pickup.

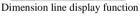
💐 ACCRETECH

CONTOURECORD 2600G/1600G High-Accuracy Contour Metrology

- $\leq 1 \mu m$ contour accuracy for 5mm Z-Axis displacement!
- · Display of measured parameters and geometric deviation
- Profile Synthesis for stylus angle range analysis limitations
- Peak and Valley function detects max workpiece point by tracing with the stylus, simplifying alignment
- · Contour evaluation of high accuracy non-spherical lenses, optical fiber connectors, ball screws, precision parts
- Add roughness detector to become Surfcom 2800G/1800G









Peak and Valley function



SURFCOM 2600G

Contourecord 2	600G/1600G	-11	-12	-13	-14	-21	-22	-23	-24
Z-Axis Measuring Rang	50mm								
X-Axis Measuring Rang	je		100	mm			200)mm	
Tracing Column Up-Down stroke)mm	450)mm	250mm 450)mm
C1600G Z-Axis Scale In	ndication Accuracy				±0.25% (f	ull scale)			
C1600G Contour Resolu	ution		0.1µm/5	mm range	, 0.4µm/20	mm range	, 1µm/50n	ım range	
C1600G Contour Sensor	r]	Differential	transduce	er		
C2600G Z-Axis Scale In	ndication Accuracy		±(0	.8+2H/100)) μm (H: M	leasuring	height in 1	nm)	
C2600G Contour Resolu	ution				0.025µm/I	Full range			
C2600G Contour Sensor	r			Lase	r Optical D	iffraction	Scale		
X-Axis Tracing Driver I	ndication Accuracy	\pm (1+2L/100) µm (L: Measuring length in mm)							
X-Axis Resolution					0.04	μm			
X-Axis Tracing Driver S Accuracy	1μm/100mm 2μm/200mm								
X-Axis Tracing Driver S	Sensor		Moiré str	iped scale			Linea	r scale	
X-Axis Measuring Spee	d		0.03	, 0.06, 0.1	5, 0.3, 0.6,	1.5, 3, 6m	ım/s (8 spe	eeds)	
Z Column Up-Down Sp	eed	N/A	10n	nm/s (3mn	n/s) ¹	N/A 10mm/s (3mm/			ı∕s)1
Stylus Characteristics		Rep	laceable, 2	5µm radiu	is, conical c	arbide, 30	mN with	retract fun	ction
Measuring Direction Or	ientation		Pull-Push	and Up-D	own directi	ons, Max	following	angle: 77°)
Table Dimensions in mr	n		600x317		1000x450		600x317		1000x450
	E-VS-S57B/S58B	41kg	35kg	26kg	N/A	35kg	29kg	20kg	N/A
Max Part Weight with	E-VS-S45A	50kg	40kg	30kg	91kg	50kg	40kg	30kg	85kg
Anti-Vibration Table	E-VS-R16B	50kg	40kg	30kg	41kg	50kg	40kg	30kg	35kg
	E-VS-R21B	50kg	40kg	30kg	100kg	50kg	40kg	30kg	100kg
Machine Width			2000mm		2300mm	1 2000mm 230		2300mm	
Machine Depth x Height		1000 x	1700mm	1000 x	1900mm	1000 x 1	1700mm	1000 x	1900mm
Machine Weight		115kg	125kg	130kg	235kg	125kg	130kg	140kg	245kg
Power Supply / Consum	ption	Sin	gle phase A	AC 100V±	10%. Grou	nding requ	uired. 50/6	60Hz. / 380	VA

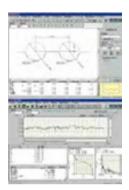
¹ Joystick operation.

Cairnhill Metrology

ACCRETECH

SURFCOM 2800G/1800G Combi Roughness-Contour Metrology

- S2800G/1800G combines C2600G/1600G with S1400G!
- Patented roughness AI automatically sets measuring conditions and executes measurement. Contour AI autorecognizes points, lines and circles. Dimension lines can be drawn with measured parameters and geometric deviation
- Auto-operation log stores drive unit and column movements and analysis procedures for CNC playback measurement



Built-in Shape Merge eliminates analysis range limitation created by the stylus angle (contour)





SURFCOM 2800G

Surfcom 2800G/	1800G Model	-11	-12	-13	-14	-21	-22	-23	-24	
Z-Axis Measuring Rang	Z-Axis Measuring Range				50r	nm				
X-Axis Measuring (Pick		100mm 200mm								
Tracing Column Up-Do	wn Stroke	250	mm	450)mm	250	mm	450	450mm	
Roughness Measuring R	lange	8	00µm rang	e to 25µm	range (6.4	µm range	with high	mag picku	p)	
Roughness Resolution			0.02µn	n to 0.0004	4µm (0.000	1µm with	high mag	pickup)		
S1800G Z-Axis Scale In	dication Accuracy				±0.25% (1	full scale)				
S1800G Contour Resolu	ition				, 0.4µm/20					
S2800G Z-Axis Scale In	dication Accuracy		±(0	.8+2H/10	0)µm (H: M		height in n	nm)		
S2800G Contour Resolu	ition				0.025µm/					
X-Axis Indication Accur	racy / Resolution				1+2L/100)					
Tracing Driver Straightr	ess Acc Roughness		0.05	+1.5L/100)0μm (L: M	leasuring	Length in	mm)		
Tracing Driver Straightr	ness Acc Contour		1μm/1	00mm			2µm/2	200mm		
Tracing Driver Sensing			Moiré Str	iped Scale			Linear	r Scale		
Tracing Driver Measurin	0.03, 0.06, 0.15, 0.3, 0.6, 1.5, 3, 6mm/s (8 speeds)									
Z-Axis Column Up-Dov	vn Speed	N/A 10mm/s (3mm/s joystick)			N/A 10mm/s (3mm/s joystick)			oystick)		
Differential Transducer	Detector Used		S1800	G Roughr	ness and Co	ontour, S28	300G Roug	ghness		
Laser Optical Diffraction	n Scale Used				S2800G					
Roughness Stylus Chara	cteristics	Replaceable, 2μm radius, 60° Cone, Diamond Waviness: 800μm radius, ruby ball, 0.75mN								
Contour Stylus Characte	eristics	25µm rae	dius, 24° C	Conical sup	er-solder,	30mN with	h retract fu	inction (2	provided)	
Measuring Direction Or	ientation		Pull-Push	and Up-D	own direct	ions, Max	following	angle: 77°)	
Table Dimensions in mr	n		600x317		1000x450		600x317		1000x450	
	E-VS-S57B/S58B	40kg	34kg	25kg	N/A	34kg	28kg	19kg	N/A	
Max Part Weight with	E-VS-S45A	50kg	40kg	30kg	90kg	50kg	40kg	30kg	84kg	
Anti-Vibration Table	E-VS-R16B	50kg	40kg	30kg	40kg	50kg	40kg	30kg	34kg	
	E-VS-R21B	50kg	40kg	30kg	100kg	50kg	40kg	30kg	100kg	
Machine Width			2000mm		2300mm		2000mm		2300mm	
Machine Depth					1000)mm				
Machine Height		1700mm 1900mm 1700mm 1900			0mm					
Machine Weight		120kg	125kg	135kg	240kg	125kg	135kg	140kg	245kg	
Power Supply / Consum	ption	Sin	gle phase A	AC 100V±	10%. Grou	nding requ	uired. 50/6	0Hz. / 710)VA	

X ACCRETECH

SURFCOM C5 Automated Production Floor Surface Roughness





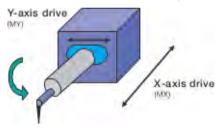
<u>Current Engine Production Roughness Measurement</u> Cylinder Block/Head, Cam/Crank Shaft, Connector Rod



By Portable Texture Measuring Problems: - 1) not universal; 2) high result variation difficult to record judgement; 3) subject to human errors

Surfcom C5 solves the problems at once!

- Measurement efficiency by multi-axis control
- · Integrated sensor rotating mechanism in all orientations
- X-/Y-Axis tracing drivers (200/30mm) integrated into a single structure (Patented)
- Low-vibration linear motor drive (X-Axis)

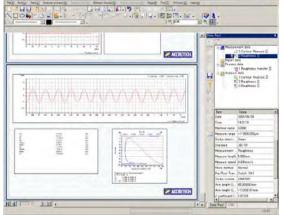


Surfcom C5					
Z-Axis Measuring Range	1000µm				
X-Axis Measuring Range	200mm				
Tracing Column Up-Down Stroke	500mm (resolution 0.1µm)				
X-Axis Tracing Driver Travel Range	200mm (resolution 0.1µm)				
Y-Axis Column Cross-Feed Travel Range	800mm (resolution 0.1µm)				
Y-Axis Pickup Tracing Driver Travel Range	50mm (resolution 0.1µm)				
Pickup Rotation Angle / Measuring Force	0°, 90°, 180°, 270° / 0.75mN				
Tracing Driver Straightness Accuracy	X-Axis: 0.5µm/200mm / Y-Axis: 0.5µm/50mm				
Sensing Method	Z-Axis Detector: Differential inductance X-Axis Tracing driver Optical diffraction scale				
Roughness Standards, Parameters, Evaluation Curves, Graphs, Tilt Correction, Filters, Cut- Off, Data Points, Vertical/Horizontal Mag.	See ACCTEE Roughness Measurement Software				
Z-Axis Column Up-Down Speed	100mm/s max				
X-Axis Tracing Driver Measurement Speed	0.03mm/s to 3mm/s (roughness meas.), 0.03mm/s to 20mm/s (waviness meas.)				
Y-Axis Measurement Speed	0.03mm/s to 3mm/s				
X / Y-Axis Tracing Driver Movement Speed	Max 100mm/s for both				
Stylus Characteristics	Replaceable, 2µm radius, Diamond, 0.75mN (with standard pickup)				
Power Supply /Consumption	Single-phase AC 100 to 240V±10%. Grounding required. 50/60Hz. / 1000VA				
Air Supply	0.45 to 0.7MPa, One-touch pipe joint for tubes with Outer Diameter Ø 8mm				
Weight	2000kg				

Cairnhill Metrology



ACCTEE for Integrated Roughness Measurement



Easy to Use – All Operations in Document Screen!



AI: Can specify parameters, analysis/optimum measurement condition Pickup sensitivity calibration by depth, magnification or ref specimen

The second secon

Change Analysis Conditions with Preview Function

- Integrated for Roughness, Contour and Roundness metrology
- Intuitive Operability and Analysis in one result sheet!
- Edit, add, re-analyse and re-measure per different ISO/JIS standards or evaluation ranges; or remove data from a notch!
- · Instrument and configuration set-up wizards for different measurements, calibration, checking styli and parameters



Self-Diagnosis Auto Pass/Fail Judgement under 16% JIS2001 Rule



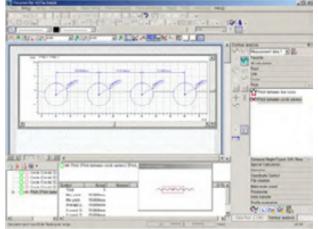


Roughness Peak and Valley Detection Function detects and automatically shifts the stylus to the max point

ACCTee Roughness Measurement and Analysis Program					
Roughness Standards	JIS-2013/-2001/-1994/-1982, ISO-1997/-1984, DIN1990, ASME1995, CNOMO				
Roughness Parameter	Ra, Rq, Ry, Rp, Rv, Rc, Rz, Rmax, Rt, Rz.J, R3z, Sm, S, RΔa, RΔq, Rλa, Rλq, TILT A, Ir, Pc, Rsk, Rku, Rk, Rpk, Rvk, Mr1, Mr2, VO, K, tp, Rmr, tp2, Rmr2, Rσc, AVH, Hmax, Hmin, AREA, NCRX, R, Rx, AR, NR, CPM, SR, SAR, etc.				
Parameter Judgement	Results Displayed via Standard, Average, Max and Min Values and 16% Rule				
Roughness Evaluation Curve	Profile, roughness, waviness (filtered, filtered center line, rolling circle, rolling circle center line), ISO13565-1 (DIN4776) roughness, roughness/waviness motif and envelope waviness				
Surface Characteristic Graph	Bearing Area Curve, ISO13565-2, Power Spectrum, Amplitude/Peak Height Distribution, Auto Correlation, Wear-Out Amount Analysis (2 arbitrary), Overlapping Analyses (≤ 10 curves)				
Form Removal/Tilt Correction	Least square straight line, circle and oval, n-Dimension Polynomial (n=2 to 9), spline, robust (spline), arbitrary or first or latter half or both ends of setting range for all options				
Filter Type	Gaussian phase compensating, 2RC phase compensating/non-compensating, spline, robust				
Cut-Off Wavelength λc	0.008, 0.025, 0.08, 0.25, 0.8, 2.5, 8, 25, 50mm (9 levels), arbitrary from 0.001mm				
Cut-Off Ratio λs	1/30, 1/100, 1/300, 1/1000, arbitrary (from 1/10)				
Cut-Off Wavelength λs	0.08, 0.25, 0.8, 2.5, 8, 25, 80μm (7 levels), arbitrary (from 0.05)				
Stylus Calibration	Depth specimen (JIS), magnification calibration unit and reference specimen. Max 20 units of stylus calibration information can be registered with calibration interval deadline				
Data Points	300,000 Max				
Vertical Mag Display	Arbitrary value (unit:0.01), automatic, 50, 100, 200, 500, 1K, 2K, 5K, 10K, 20K, 50K, 100K, 200K, 500K, 1000K, 5000K, 10,000K times				
Horizontal Mag Display	Arbitrary value (unit:0.01), automatic, 1, 2, 5, 10, 50, 100, 200, 500, 1K, 2K, 5K, 10K, 20K, 50K, 100K, 200K, 500K, 1000K times				



ACCTEE for Integrated Contour Measurement



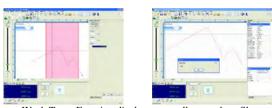
Contour Analysis Result

Master Ball Calibration Function (Patented)

Circle Correction Calculation: As the probe moves in a circular motion vertically around the support, X-Axis error is produced as the probe also moves in the X-Axis direction. This plus the tip R error can be corrected via calibration with a master ball calibration unit.

rohe R center locu

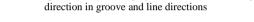
Probe R-correct

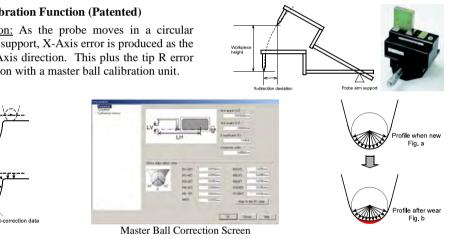


Work Trace Function displays manually traced profile



Ball Circle Calculation Ball Screw Probe Calculation Ball screw Option: Analyse and project measured data in edge





Tip R-Correction for High Accuracy: The R-shape contour probe tip optimally has near-zero roundness. Measurements are taken from its center and offset in the normal direction at 11 dividing points to monitor wear and to compute the offset correction using a proprietary algorithm. An error indicator alerts when the correction value is outside pre-set limits.

AC	ACCTee Contour Profile Measurement Machine and Analysis Program					
AI Function	Automatic distinction of elements (incl. points, straight lines, circles and ovals); of combinations of two elements (point-point, point-straight line, point-circle, point-oval, straight line-straight line, circle-straight line, circle-circle, straight line-oval, circle-oval, oval-oval)					
Contour Calculations	Point (cross, mid and contact, peak, valley), line (perpendicular, median, contact, parallel, bisector, virtual), circle (partial, oval, contact, virtual), pitch (between line cross, circle centers), distance, curve length, angle, inter angle (complementary, supplementary), coordinate difference (X, Z, angle, radius, polar coord), level difference (average, max, min), area, calculation (addition, subtraction, multiplication, division, power operation, surplus, absolute value, square root), statistics (average, max, min, std. dev., total sum), over-pin calculation, dimension line display function, calculation result design value collation, mirror inverse, smoothing, form combining (whole composition, partial composition), calculation point repeat function, work trace function, peak/valley function, CNC function, nominal collation, best fit (parallel move, rotary move), nominal value preparation function					
Data File I/O	Input of point sequence, text, CSV, IGES, DXF data and Calypso Curve					
Coordinate Settings	Zero point (origin) setting for each axis, X-Axis setting, parallel movement, rotary movement					
Calculation Support	Infinite cursor, cursor form vertical/horizontal switch, one point micro motion, setting or error band					
Stylus Calibration	Automatic calibration and manual calibration by master ball calibration unit. Max 20 stylus calibration information can be registered (deadline of the calibration time can be specified)					
Measure Pitch	0.01~1000µm					
Data Points	Max 300,000 points					
Vertical/Horizontal Mag	Display: Arbitrary value (unit:0.01), automatic and 0.01 - 10,000,000 times					



SURFCOM MAP Advanced 3D Roughness Analysis Software



Workpiece Movement Type

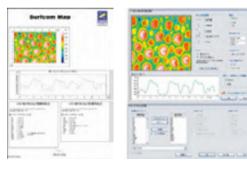
Y-Axis range settable between 50 to 200mm. For CREST / NEX / 2800 / 1800 / 1400 / 2000 / 2900 / 1900 / 1910 / 1500.



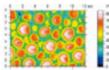
Detector Movement Type (Patent Pending)

Small Y-Axis driver installed for performing 3D roughness measurement on large or heavy workpieces without moving them. For NEX / 2000 / 2900 / 1900 / 1910 / 1500.

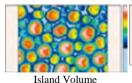
	E-DH-S173B	E-YM-S06B	E-YM-S12B	E-YM-S07B	E-YM-S08B				
Drive System	Detector Moves	Workpiece Moves							
Drive Range	13mm	50mm	100mm	150mm	200mm				
Min Feed Pitch / Measurement Pitch		0.001mm / 2 to 4001 lines							
Straightness Accuracy	1μm		0.05+3L	/1000µm					
Table Dimensions	Handles large	80 x 120mm	100 x 120mm	120 x 150mm	150 x 150mm				
Max Load	heavy parts	5kg 10kg		5kg	10kg				

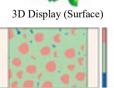


- Most advanced offline 3D roughness analysis software available, combining versatile 3D analysis with simple operation
- More than 20 types of offline analysis
- Wide Range of Visual Representations of Surface Properties
- · Object orientated enables condition modification on the inspection report, enhancing analysis efficiency with automatic recording of analysis procedures



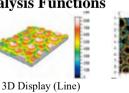
Colour Display





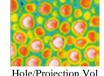
Section Profile Display

Analysis Functions









Hole/Projection Vol



Photograph Display



	Su	rfcom Ser	Opt-Scope		
Analysis Functions	Premium	Expert	Standard	Premium	Opt
Colour / Contour Line / 3D / Load Curve / Section Profile Display	0	0	0	0	0
Photograph Display / Distance Measurement / Hole and Projection Vol	0	0	Х	0	0
Peak distribution	0	0	0	0	Х
Island volume	0	0	Х	0	Х
2D surface roughness analysis	0	Х	Х	0	0

Distance & Angle



ROUNDNESS Line Up at a Glance!

		Met	hod	St	yle		D	etector		Та	able Specifications			Z-Axi	s Column	R-Ax	is
Rondc Mode		CNC	Manual	All-in-one Type	Separate Type	All Position	Standard	Stroke in µm	Offset holder	Max Sample Weight in kg	Rotation Accuracy in µm Max Sample Weight in kg		Feed Range in mm	Cylindricity/ Rectilinear	Straightness Accuracy in μm	Max Measuring Ø in mm	Feed Range in mm
Cres	t	0	-	0	-	0	-	±1000	0	65	0.01+3H/10000	340	500	~	0.05/100mm 0.13/350mm	420	250
NEX 100 / -α	DX SD	-	0 0	0 -	- 0	0 0	Δ Δ	±1000	0	30 / 60	0.02+3.2H/10000	235	300	~	0.10/100mm 0.15/300mm	300 (350) 1	180
NEX 200/300		-	-	0	-	0	Δ	±1000	0	30 / 60	0.02+3.2H/10000	235	300	~	0.10/100mm 0.15/300mm	300 (350) _{1,2}	180
$/ -\alpha$ NEX Rs		0 0	-	- 0	0 -	0 0	Δ Δ	. 1000		201.00	0.02.2.2.11/10000	225	200	✓	0.10/100mm	300 (350)	100
200/300 / -α	SD	0	-	-	0	0	Δ	±1000	0	30/ 60	0.02+3.2H/10000	235	300	•	0.15/300mm	1,3	180
Touc	h	-	0	-	0	-	0	±400	-	15	0.04+6H/10000	148	162	-	-	150	160 (±80)
65B		0	-	0	-	0	Δ	±1000	Δ	60	0.01+4H/10000	290	500	~	0.05/100mm 0.2/500mm	420	220
65A-I	LH	0	-	0	-	0	Δ	±1000	0	250	0.08+6H/10000	400	900	~	0.2/100mm 1.0/900mm	580	343
60A		0	-	-	0	0	Δ	±1000	Δ	60	0.02+6H/10000	290	500	~	0.1/100mm 0.25/500mm	420	220
43C-	S	_	0	_	0	Δ	0	±400	_	15	0.02+6H/10000	148	300	~	0.25/100mm	200	100
430								-+00		15	0.02+011/10000	140	500		0.8/300mm	250	125
41C	2	_	0	_	0	Δ	0	±400 -		- 25 0.04+6H/10000 148 300		~	0.5/100mm 1.5/300mm	250	125		
310	2									25	0.041011/10000	148	200	-	-	250	125

 1 With optional offset-type detector holder E-DH-RB86A. 2 For R NEX 200/NEX α 200. 3 For R NEX Rs 200/NEX Rs α 200.

	Met	hod			Detector			Table Specif	icatio	ons		Z-A	xis Column	R-Axis	
Rondcom Model	CNC	Manual	Standard	PA	Stroke in µm	Offset holder	Max Sample Weight in kg	Rotation accuracy in µm	X Feed range in mm	Y Feed range in mm	Dimensions in mm	Feed range in mm	Straightness accuracy in µm	Max measuring Ø in mm	Feed range in mm
76A	0	-	Δ	0	±500 (arm a) ±1000 (arm b)	-	400	0.04+ 3H/10000	700	200	800x680	1000	0.28/50mm 0.37/100mm 1.32/700mm	500	290
73A	0	-	0	Δ	±800	-	200	0.06	600	120	600x550	1000	0.9/200mm	450	265
Zero1	-	0	X	X	±300	-	Х	1	X	X	X	135	1/125mm	950	6
Grande	0	-	0	X	±1000	-	500	0.08+H/1000	X	X	Ø 1650	550	0.15/100mm 0.5/490mm	1650	450

O – Standard accessory; Δ – Available as option; \checkmark – Possible.

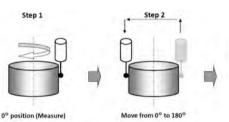


RONDCOM NEX^{*IMPROVED!*} High Productivity Fully CNC Roundness

- High Rotation Accuracy: 0.02+3.2H/10000µm
- · Measures Roundness, Diameter and Roughness with one system
- Automatic switching of measurement direction and force with the AFD (Automatic Force adjustment Detector)
- Labour-saving optional XY-Axis automatic stage allows many workpieces on the stage to be measured at once, minimizing operator effort and reducing measurement task time.
- Patented offset type detector holder
- · Auto-centering/-tilting/-leveling functions
- R-Axis taper following function measures taper angle and straightness even if it exceeds the detector range
- Spiral cylindricity measurement function
- Patented diameter measurement function Opposite Pair Method
- R-Axis ceramic arm is light weight and highly rigid hard to be affected by room temperature changes and maintenance free
- Larger Ø 235mm table and centering range $\pm 5 \text{mm}$



Automatic Force adjustment Detector



Patented diameter measurement - Opposite Pair Method



XY-Axis Automatic Stage

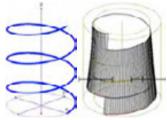




R tracking during measurement



3 Measuring Functions in 1



Spiral cylinder measurement

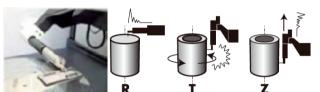
	Accessories for Diameter Measurement Capability										
Model with External View	E-DH-RB09A Facing Dia. Measurement Holder	E-MG-R88A Diameter Master	547 592 5137 6 5157 6 5157 7 5157 7 5157 7 5157 7 5157 7 5157 7 5157 7 5157 7 5157 7 5157 7 5157 7 517 51								
	$OD \le \emptyset$ 100mm. Require horizontal		Recommended for Dia.								
Notes	feed coupling E-DH-RB08A	OD Ø 24.5mm; ID Ø 13.7mm	Measurement								



RONDCOM NEX Rs High Productivity Roundness / Roughness

Features (in addition to Rondcom NEX features)

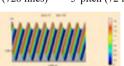
- Integrated High Accuracy Roughness measurement in R/T/Z axes
- · Lead Twist measurement option
- T angle scale High 0.0001° resolution angle scale for roughness measurement
- Low speed drive motor (R/Z:0.1mm/s, T:0.01/min)
- Air bearing with low vibration



High accuracy roughness measurement in R-, T- and Z-axes









RONDCOM NEX RS

Lead twist measurement option

RONDCOM NEX a / NEX Rs a For Eccentric and Heavy Parts

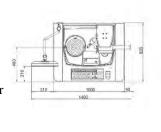


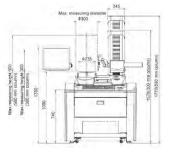
RONDCOM NEX a

- Measures up to 60kg workpieces at high accuracy
- Unique compact highly rigid low-vibration air bearing spindle supporting heavy workloads



Measuring crankshaft using designated jig tool





RONDCOM NEX / NEX Rs / NEX a / NEX Rs a Specifications

Models and Size		10	00			20	00			30	00	
Standard or Deluxe	S	D	D	Х	S	D	D	Х	S	D	D	X
RONDCOM NEX (-11, -12) ¹	11	12	11	12	11	12	11	12	11	12	11	12
RONDCOM NEX α (-21, -22)	21	22	21	22	21	22	21	22	21	22	21	22
Alignment		Manual CNC										
Offset Type Detector Holder		Manual CNC						NC				
Max Measuring Diameter Range					00mm 60mm (eter: 30 eter: 360	
R-Axis Radial Feed Range						180	mm					
Z-Axis Up-Down Feed Range in mm	300	500	300	500	300	500	300	500	300	500	300	500
Max Loading Diameter		Ø 580mm										
Max Measuring Height in mm	300	500	300	500	300	500	300	500	300	500	300	500
Max Measuring Depth		150mm ²										
Rotational Radial / Axial Accuracy ³	$0.02{+}3.2H/10000\mu m/0.02{+}3.2R/10000\mu m$											
Z-Axis Straightness Accuracy	0.10μm/100mm 0.15μm/300mm for -11/-21 models; 0.23μm/500mm for -12/-22 models											
		0.15µn	n/300m	m for -			•		nm for -	12/-22	models	
R-Axis Radial Straightness Accuracy							μm/180					
Z-Axis/T-Axis Flatness Accuracy		0.7µn	n/300m	m for -	11/-21 1	models;	1.0µm	/500mr	n for -1	2/-22 n	nodels	
R-Axis/T-Axis Squareness Accuracy						1.0µm/	150mm	l				
R-Axis Scale Indication Accuracy				· ·				· /	⊿T: ter ntal ten	1		
θ-Axis Rotational Measuring Speed			1 to 10)/min; I	Rs: 0.01	to 1/m	in (roug	ghness	measur	ement)		
Z-Axis Up-Down Measuring Speed		0	.5 to 10	mm/s;	Rs: 0.1	to 1.5n	nm/s (ro	oughne	ss meas	uremen	t)	
R-Axis Radial Measuring Speed		0	.5 to 10	mm/s;	Rs: 0.1	to 1.5n	nm/s (ro	oughne	ss meas	uremen	t)	
θ-Axis Rotational Movement Speed						max. 2	20/min					
Z-Axis Up-Down Movement Speed						5 to 6	0mm/s					
R-Axis Radial Movement Speed						5 to 3	0mm/s					
Table Diameter / Centering / Tilt Range	Ø 235mm / ±5mm / ±1°											
Max Load	30kg (NEX / NEX Rs); 60kg (NEX α / NEX Rs α)											
Standard Detector E-DT-R120B	30 to 2	30 to 100 mN, ± 1000 µm range, Inner/outer Ø switching, front/over travel, safety stop						y stop				
Standard Stylus EM46000-S302			Ø 1.6	mm sty	lus ball	l, 53mn	n length	, Ceme	ented Ca	arbide		

¹NEX-11 (Max. loading mass 30kg, 300mm column), NEX-12 (Max. loading mass 30kg, 500mm column), NEX -21 (Max. loading mass 60kg, 300mm column), NEX -22 (Max. loading mass 60kg, 500mm column).

²Check for limitations arising from the measurement diameter and combination of detector and stylus.

³ Per JIS B 7451-1997. H = height of measurement point from the upper table surface, and R = distance from the table rotational center in mm.

⁴ With optional measurement diameter extension offset-type detector holder E-DH-RB86A.

Standard for NEX Rs α 200/300

Low Force Detector E-DT-R168C	4mN measuring force; linear range ±400µm
Roundness Stylus 010 2505	Ø 1.6mm ball diameter, 26.5mm length, ruby
Roughness Stylus 010 2501	SR5 (90° cone), 26.5mm length, diamond



RONDCOM NEX / NEX Rs / NEX a / NEX Rs a Specifications

Models and Size		1(00			20	00			30	00		
Standard or Deluxe	S	D	D	X	S	D	D	Х	S	D	D	X	
RONDCOM NEX (-11, -12) ¹	11	12	11	12	11	12	11	12	11	12	11	12	
RONDCOM NEX α (-21, -22)	21	22	21	22	21	22	21	22	21	22	21	22	
Number of Sampling (point)													
Digital Filter													
θ-Axis Rotational Direction Lowpass													
θ-Axis Rotational Direction Bandpass			S	ACCT	FF Do-	mdnoo	a Maaa		at Caft				
Z-Axis Rectilinear Direction Lowpass			See	ACCI	LE KO	unanes	s Meas	uremei	11 5011	ware			
Roundness Evaluation of Form Error													
Rotational Direction Measuring Items													
Rectilinear Direction Measuring Items													
Analysis Processing Function	 nominal value collation, cylinder 3D profile display (line drawing, shading, contour line), real-time display, profile characteristic graph display (bearing area curve, amplitude distribution function, power spectrum), CNC automatic measuring function, automatic centering/ tilting adjustment function (except for NEX 100) Measuring conditions, measuring parameters, comments, printer output conditions, 												
Display Items		pro		aphics (
Installation Width	720	mm	1400	Omm	720	mm	1400)mm	720	mm	1400	Omm	
Installation Depth		mm		mm		mm	820mm		580mm		820mm		
Installation Height NEX in mm	895	1095	1570	1770	895	1095	1570	1770	895	1095	1570		
Installation Height NEX α in mm	900	1100	1570	1770	900	1100	1570	1770	900	1100	1570	1770	
Installation Height NEX Rs in mm	-	N	[/A		920	1120	1595	1795	920	1120	1570	1570	
Installation Height NEX Rs α in mm				1	925	1125	1595	1795	925	1125	1595	1795	
Machine Weight NEX in kg	180	190	330	340	180	190	330	340	180	190	330	340	
Machine Weight NEX α in kg	200	210	350	360	200	210	350	360	200	210	350	360	
Machine Weight NEX Rs in kg		N	Δ		180	190	330	340	180	190	330	340	
Machine Weight NEX Rs α in kg					200	210	350	360	200	210	350	360	
Power Supply		Si	ngle pł	nase AC	C 100 to	o 240V.	Ground	ding rec	quired.	50/60H	z.		
Power Consumption		NEX,	NEX o	a: Appro	ox. 530	VA / N	EX Rs,	Nex R	s α: Ap	prox. 6	30VA		
Air Supply		NEX,	NEX	Rs: 0.35	5 to 0.7	MPa / N	NEX α,	NEX R	ls α: 0.4	45 to 0.'	7MPa		
Working Pressure	NEX, NEX Rs: 0.3MPa / NEX α, NEX Rs α: 0.4MPa												
Air Consumption	NEX, NEX Rs: $30N\ell/min / NEX \alpha$, NEX Rs α : $40N\ell/min$												
Air Supply Connecting Port	One-touch pipe joint for tubes with Outer Diameter Ø 8mm hose												
Operating Temperature	10 to 30°C												
Guaranteed Accuracy Temperature						20±	2°C						



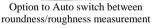
RONDCOM CREST Ultra-high accuracy



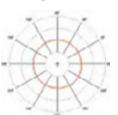
- World's highest radial direction rotation accuracy $0.01+3H/10000\mu m$ and axial direction rotation accuracy $0.02+3R/10000\mu m$
- New driving and guiding mechanism (Patent Pending)
- Higher accuracy diameter measurement by automatic crowning function, higher accuracy straightness/taper angle measurement by R-Axis tracking and higher accuracy spiral Cylindricity measurement
- Z/R/T-Axis roughness measurement and Lead Twist measurement option







Opposed diameter measurement (Patented)



No. 1 accuracy in the world



Excellent User Operation Panel

Rondcom CREST									
Max Measuring Diameter	420mm (OD) / 480mm (ID)								
R-Axis Radial / Z-Axis Up-Down Feed Range	250mm / 520mm								
Max Workpiece Diameter / Height	490mm / 500mm								
Radial / Axial Rotation Accuracy ¹	0.01+3H/10000µm / 0.02+3R/10000µm								
Z-Axis Up-Down Straightness Accuracy	0.05µm/100mm / 0.13µm/350mm								
R-Axis Radial Straightness Accuracy	0.2µm/200mm								
Z-Axis/T-Axis Parallelism Accuracy	0.5µm/350mm								
R-Axis/T-Axis Squareness Accuracy	0.3µm/200mm								
R-Axis Radial / Z-Axis Scale Indication Accuracy	0.3+L/1000µm / 0.5+L/1000µm								
T-Axis Rotation Measuring Speed	1~10 (rotation meas.), 0.01~1 (roughness meas.)								
R-Axis Radial / Z-Axis Up-Down Measuring Speed	0.5~10 (linear motion meas.), 0.03~1.5 (roughness meas.)								
T-Axis Rotation Movement Speed	Max 20								
R-Axis Radial Movement Speed	50 (Auto movement), 5~50 (Jog operation)								
Z-Axis Up-Down Movement Speed	70 (Auto movement), 5~50 (Jog operation)								
Table Diameter / Centering / Tilt Range	340mm / ±5mm / ±1°								
Max Load	65kg								
Machine Dimensions W x D x H	2240 x 2010 x 1940mm (L-shape) / 2750 x 1250 x 1940mm (I-shape)								
Machine Weight	1350kg (Measuring Unit) / 100kg (Data Processor)								
Power Supply / Consumption	AC 100 to 240V±10%. Grounding required. 50/60Hz. / Approx. 820VA								
Air Supply / Working Pressure / Air Consumption	0.45 to 0.7MPa / 0.4MPa / Approx. 54Nℓ/min								
Air Supply Connecting Port	One-touch pipe joint for tubes with Outer Diameter $Ø$ 8mm tube								
Operation Environment	10~30°C (Operating Temp.); 20±1°C (Accuracy Guaranteed Temp.)								

¹ Per JIS B 7451-1997. H = height of measurement point from upper table surface and R = distance from table rotational center in mm.



RONDCOM 65B Ultra-High Accuracy CNC Roundness



- Highest Rotation Accuracy in Class: 0.01µm
- Centering and tilting within 60 secs for fast total measuring time
- Robust high accuracy and high rigidity structure
- Gabbro with minimal susceptibility to age-related deterioration, used in column, base and arm, guarantees top-class high accuracy over time
- Patented Offset type detector holder option enables various workpieces to be measured easily without interference from the R-Axis arm
- Switch easily between outside diameter and top flatness measurements just by tilting the detector holder



Offset Type CNC Detector Holder (Patented)

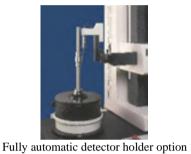
Rondcom 65B	Standard Model	High Column Model						
Measuring Method	CNC and	l Manual						
Max Measuring Diameter / Loading Diameter	420mm /	/ 680mm						
R-Axis Right-Left / Z-Axis Up-Down Feed Range	220mm / 500mm	220mm / 800mm						
Max Measuring Height (same for OD and ID)	500mm	800mm						
	150mm							
Max Measuring Depth (Throat height)	(limited by measuring diameter and detector-stylus combination)							
	0.01+4H/	10,000µm						
Radial Rotation Accuracy ¹	(H: Height from table top	to measuring point in mm)						
Axial Rotation Accuracy ¹	0.03+4R/	10,000µm						
Up-Down Straightness Accuracy (Narrow Range)	0.05µm/100mm	0.1µm/100mm						
Up-Down Straightness Accuracy (Wide Range)	0.2µm/500mm	0.5µm/800mm						
R-Axis Radial Straightness Accuracy	0.5µm/	200mm						
Z-Axis Up-Down Parallelism Accuracy	1.5µm/	500mm						
R-Axis Radial Parallelism Accuracy	0.5µm/200mm							
R-Axis Scale Indication Accuracy	$(2+L/220)\mu m$ (where L =	= Moving Length in mm)						
θ-Axis Rotational Speed	2/min to 10/min (At moving: Max 20/min)							
Z-Axis Up-Down Measuring Speed	0.6mm/s to 6mm/s (At moving: Max 30mm/s)							
R-Axis Radial Measuring Speed	0.6mm/s to 6mm/s (At	moving: Max 20mm/s)						
Z-Axis/R-Axis Auto-Stop Accuracy	±5	μm						
Rotary Table Outside Diameter	Ø 29	0mm						
Rotary Table Centering / Tilt Range	±5mm	n / ±10						
Rotary Table Load	60	kg						
Stylus Characteristics	30 to 100mN (variable) measuring force	ee, Ø 1.6mm carbide ball, 53mm length						
Number of Sampling	14400 poin	ts / rotation						
Measurement Magnification	50 to	100K						
Special Function	Offset Type CNC De	etector Holder Option						
Display Colour Monitor / Items		parameters, comments, printer output on plan, 3D plan), error messages, etc.						
Recording System	Colour or Laser Printer							
Power Supply / Consumption	AC 100V to 240V. Grounding required. 50/60Hz. / Approx. 800VA							
Air Supply / Working Pressure / Consumption	0.5 to 0.7Mpa / 0.	4Mpa / 49Nℓ/min						
Machine Dimensions W x D x H / Weight	1740 x 875 x 1755mm / 810kg	1740 x 875 x 2075mm / 930kg						



RONDCOM 60A High Accuracy CNC Roundness



- High Rotation Accuracy of $0.02 \mu m$
- High-Accuracy Air Bearings for Z-, R- and $\theta\text{-axes}$
- Gabbro in column, base and R-Axis for top-class accuracy
- World's highest throughput (within 60s for alignment)
- · Detector with Overload Safety Function in all orientations
- Offset Type Detector Holder Option (Patented) for measurement without interference from R-Axis arm
- Air Type Anti-Vibration Table Option
- Fully Automatic Measurement via ACCTEE Teach Mode





RONDCOM 60A

Rondcom 60A	Standard	High Column				
Measuring Method	CNC and	Manual				
Max Measuring Diameter / Loading Diameter	420mm / 680mm					
R-Axis Right-Left / Z-Axis Up-Down Feed Range	220mm/500mm	220mm/800mm				
Max Measuring Height (same for OD and ID)	500mm	800mm				
Radial Rotation Accuracy ¹	0.02+6H/10,000µm (H: Height from	table top to measuring point in mm)				
Up-Down Straightness Accuracy (Narrow Range)	0.1µm/100mm	0.2µm/100mm				
Up-Down Straightness Accuracy (Wide Range)	0.25µm/500mm	0.6µm/800mm				
R-Axis Radial Straightness Accuracy	0.5µm/2	200mm				
Z-Axis Up-Down Parallelism Accuracy	1.5µm/5	500mm				
R-Axis Radial Parallelism Accuracy	0.5µm/2	200mm				
R-Axis Scale Indication Accuracy	(2+L/200)µm (where L =	Moving Length in mm)				
θ-Axis Rotational Speed	2 to 10/min (At auto cente	ering/tilting: 6/10/20/min)				
Z-Axis Up-Down Measuring Speed	0.6mm/s to 6mm/s (At	moving: Max 30mm/s)				
R-Axis Radial Measuring Speed	0.6mm/s to 6mm/s (At	moving: Max 20mm/s)				
Z-Axis/R-Axis Auto-Stop Accuracy	$\pm 5 \mu m$					
Rotary Table Outside Diameter	Ø 290	Ø 290mm				
Rotary Table Centering / Tilt Range	±5mm	±5mm / ±10				
Rotary Table Load	601	kg				
Stylus Characteristics	30 to 100mN (variable) meas. force,	Ø 1.6mm carbide ball, 53mm length				
Filter, θ-Axis Rotational / Z-Axis Rectilinear Cut- off values and Measuring Items, Form Error Roundness Evaluation, Analysis Processing	See ACCTEE Roundness	s Measurement Software				
Display Magnification	50 to	100K				
Special Function	Offset Type CNC De	tector Holder Option				
Display Colour Monitor / Items	17" LCD / Measuring conditions and conditions, profile graphics (expansio					
Recording System	Colour or Laser Printer					
Power Supply / Consumption	AC 100 to 240V±10%. Grounding re-	equired. 50/60Hz. / Approx. 800VA				
Air Supply / Working Pressure / Consumption	0.5 to 0.7Mpa / 0.4	/Ipa / 0.4Mpa / 49Nℓ/min				
Machine Dimensions W x D x H / Weight ²	1974 x 924 x 1950mm / 500kg	1974 x 924 x 2250mm/ 520kg				

¹ Per JISB7451-1997. ² Excludes anti-vibration table, rack.



RONDCOM 43C/41C/31C Desktop Manual Roundness





KONDCOM 45C

RONDCOM 41C

- Bar Graph aids Centering/Tilting Adjustment
- High-precision straightness column for 43C/41C with high column option and R43C-S for small, high-accuracy workpieces. R31C not equipped with straight Z column but can still do coaxiality and concentricity measurements of center point deviation
- Integrated ACCTee / Compact, space saving / Energy-efficient high precision static-pressure air bearings (θ -Axis)

	R43C-S	R43C	R41C	R31C			
Measuring Method		Ma	nual				
Max Measuring Diameter / Loading Diameter	200mm / 400mm		250mm / 400mm				
R-Axis Right-Left Feed Range	100mm		125mm				
Z-Axis Up-Down Feed Range Standard		300mm					
Z-Axis Up-Down Feed Range High Column	N	/A	500mm	N/A			
Max Measuring Height Standard		300mm		200mm			
Max Measuring Height High Column	N	/A	500mm	N/A			
Radial Rotation Accuracy ¹	0.02+6H/	10,000µm	0.04+6H/1	0,000µm			
Up-Down Straightness Accuracy Standard	0.25µm/100mm	, 0.8µm/300mm	0.5μm/100mm, 1.5μm/300mm	N/A			
Up-Down Straightness Accuracy High Column	N	/A	0.5µm/100mm, 2.5µm/490mm	N/A			
R-Axis Radial Straightness Accuracy	0.2µm/10mm)		N/A				
Z-Axis Parallelism Accuracy Standard	1.5µm/	300mm	3µm/300mm	N/A			
Z-Axis Parallelism Accuracy High Column	N	/A	1µm/100mm	N/A			
R-Axis Radial Parallelism Accuracy	0.3+0.1L/10µm		N/A				
θ-Axis Rotational Speed		6/1	min				
Z-Axis Up-Down Measuring Speed	0.6, 1.5, 3, 6	mm/s (At moving:	15mm/s max)	5mm/s			
R-Axis Radial Measuring Speed	0.6, 1.5, 3, 6mm/s		5mm/s				
Z-Axis/R-Axis Auto-Stop Accuracy		±5	μm				
Rotary Table Outside Diameter		Ø 14	8mm				
Rotary Table Centering/Tilt Range		±2mr	n / ±1°				
Rotary Table Load	15	ikg	251	ĸg			
Stylus Characteristics	±400µm	range, 70mN meas	force, Ø 1.6mm carb	oide ball			
Stylus Length	54.5mm		15.5mm				
Filter, θ-Axis Rotational / Z-Axis Rectilinear Cut-Off values, Measuring Items, Form Error Roundness Evaluation and Analysis	See A	CCTEE Roundnes	s Measurement Soft	tware			
Display Colour Monitor / Items			parameters, commen on plan, 3D plan), err				
Recording System		Colour or I	Laser Printer				
Power Supply / Consumption	AC 100 to 240V	/±10%. Grounding	required. 50/60Hz. / A	Approx. 600VA			
Air Supply / Working Pressure / Consumption).3Mpa / 30Nℓ/min				
Dimensions (Standard) W x D x H / Weight ²	1800 x 1000 x 1	800mm / 130kg	1800 x 1000 x 17	700mm / 120kg			
Dimensions (High Column) WxDxH / Weight ² R41C only: 1800 x 1900mm / 140kg							

¹ Per JISB7451-1997. ² Excluding options.



RONDCOM 73A CNC Detector Rotating Roundness



- Compact Footprint, Lighter, Energy Saving!
- Highest 0.06µm Rotation Accuracy in its class: at Rotation Speed of 4/min
- Z-Axis Straightness Accuracy 0.9µm/200mm; Parallelism: 0.9µm/100mm
- Z-Axis Stroke: 1015mm; Max Loading: Ø 900mm
- · 120mm Y-Axis Stroke efficiently measures crankshafts and eccentric holes
- · Detector with Overload Safety in all orientations
- · 265mm R-Axis Feed Range avoids need to change detector position
- · Able to use wide range of detectors and accessories
- Safety Device and Auto Balancing on R-Axis
- · Auto-Centering, -Tilting and -Levelling. CNC measurements via ACCTEE
- Edge Detection Measurement Option automatically recognizes edge-toedge distance and sets measuring length at a rectilinear measurement
- Calibration Wizard aids operators to perform calibration easily
- · Self-Diagnosis Function displays error messages and countermeasures







4/1 RONDCOM 73A

Rotation accuracy 0.06µm at 4/min rotational speed

High Z-Axis straightness & parallelism accuracy

Space-saving Design

	Rondcom 73A			
Measuring Method	CNC			
Max Measuring Diameter	450mm			
Max Measuring Height	1015mm (standard detector); 630mm (620mm long shaft measuring tool)			
Feed Range	X-Axis Right-Left Y-Axis Forth-Back Z-Axis	Up-Down R-Axis		
	600±300mm 120±60mm 100	0mm 265mm		
Table Dimensions W x D / Load	600 x 550mm / 200kg			
Workpiece Position CG / Table Tilt Range	Within Ø 200mm of Table	Within Ø 200mm of Table / 2° ($\pm 1^{\circ}$)		
X / Y / R Axes Drive Speed	Max 30mm/s			
Radial Rotation Accuracy	0.06µm (standard detector); 0.6µm (620mm long shaft measuring tool)			
Axial Rotation Accuracy (Meas. Radius: 50mm)	0.2µm (standard detector); 0.4µm (620mm long shaft measuring tool)			
θ-Axis Rotational Speed	1 to 6/min (at measuring), Max 10/min			
Z-Axis Straightness Accuracy	0.9µm/200mm (standard detector)			
Z-Axis Up-Down Parallelism Accuracy	0.9µm/100mm			
Z-Axis Up-Down Measuring Speed	0.6 to 6mm/s (Max 30mm/s)			
Standard Configuration and Accessories	Measuring unit, Table, Air bearing and rotation clampers, detector holder E- DH-R550A, Detector E-DT-R244A, Stylus 0194412, Master ball E-MG-			
	R01B (sphericity: 0.05μm), controller, operation box, mobile stand			
Filter, θ-Axis Rotational / Z-Axis Rectilinear Cut-		·		
Off values and Measuring Items, Form Error	See ACCTEE Roundness Measurement Software			
Roundness Evaluation, Analysis Processing				
Display Colour Monitor / Items	17" LCD / Measuring conditions and parameters, comments, printer output			
Display Colour Monitor / Items	conditions, profile graphics (expansion plan, 3D plan), error messages, etc.			
Recording System	Colour or Laser Printer			
Machine Dimensions W x D x H / Weight	1235 x 1455 x 2500mm / 1500kg (Measuring Unit) 800 x 800 x 1400mm / 100kg (Control Unit)			
Table Surface Height	760mm			
Power Supply / Consumption	AC 100V to 240V±10%. Grounding required. 50/60Hz. / Approx. 1kVA			
Air Supply / Working Pressure / Consumption	0.35 to 0.7Mpa / 0.3Mpa / 30Nℓ/min			
Air Supply Connecting Port	One-touch pipe joint for tubes with Outer Diameter Ø 8mm hose			



RONDCOM 76A CNC Detector Rotating Roundness



Full Air Bearing Granite RONDCOM 76A

• XY Table and R-Axis Straightness Accuracy for parallelism evaluations of cylinder block bores

• Max Driving Speed: 100mm/s for efficiency

• Highest Rotation Accuracy in class: 0.1µm

700mm long shaft measuring toolAir Bearings for X-, Y-, Z- and θ-axes

• Fully Automatic 7-Axis Control

• Column Straightness Accuracy: 1.3µm/700mm with

• Gabbro in column and base for top-class accuracy

- ACCTEE fully automatic multiple workpieces meas
- Automatic Part-Program Call Function Option





Crankshaft

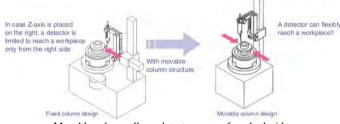
	Rondcom 76A			
Measuring Method	CNC and Manual			
Max Measuring Diameter / Loading Diameter	500mm / 980mm			
Feed Range	X-Axis Right-Left	Y-Axis Forth-Back	Z-Axis Up-Down	R-Axis
	700mm	200mm	1000mm	290mm
Radial Rotation Accuracy ¹	0.04+3H/10,000µm, 0.097µm (H=189), 0.13µm (H=314), 0.26µm (H=736)			, 0.26µm (H=736)
Axial Rotation Accuracy ¹	0.1+8R/10,000μm, 0.14μm (R=50), 0.18μm (R=100), 0.22μm (R=150)			
Angle Resolution Rotation Accuracy		0.025°		
Z-Axis Up-Down Straightness Accuracy		0.2+8L/10,000	x 1+S/1000µm	
R-Axis Radial Straightness Accuracy	0.5+I	0.5+L/300µm, 0.83µm (L=100), 1.47µm (L=290)		
X-Axis / Y-Axis Table Straightness Accuracy	X: 0.5µm/100mm, 1.6µm/700mm / Y: 0.5µm/100mm, 0.6µm/200mm			0.6µm/200mm
X-Axis / Y-Axis / Z-Axis Position Display Res.	0.001mm			
Z-Axis and θ-Axis Parallelism Accuracy	0.8µm/200mm			
R-Axis Radial Parallelism Accuracy	1.0µm/200mm			
R-Axis Diameter Measuring Accuracy	3+5 (L+S)/1000μm			
θ-Axis Rotational Speed	2/min to 4/min (At automatic centering: 10/min)			
Z / X / Y / R Axes Measuring Speed	0.6mm/s to 10mm/s (At moving: Max 100mm/s)			
Auto-Stop Accuracy	$\pm 5\mu m$ (5mm/s or less)			
Table Dimensions W x D / Load	800 x 680mm / 200kg			
Table Centering / Tilt Range	(1/3 or less of measuring diameter) / $\pm 1^{\circ}$			
Stylus Characteristics	±500μm range, 130mN meas. force, R0.25mm sapphire (Arm a) ±1000μm range, 65mN meas. force, R0.25mm sapphire (Arm b)			
Filter, θ-Axis Rotational / Z-Axis Rectilinear Cut- Off values and Measuring Items, Form Error Roundness Evaluation, Analysis Processing	See ACCTEE Roundness Measurement Software			
Display Magnification	50	to 100K, Auto, Me	asuring Magnificati	on
Display Colour Monitor / Items	17" LCD / Measuring conditions and parameters, comments, printer output conditions, profile graphics (expansion plan, 3D plan), error messages, etc.			
Recording System	Colour or Laser Printer			
Power Supply / Consumption	AC 100V to 240V±10%. Grounding required. 50/60Hz. / Approx. 1kVA			
Air Supply / Working Pressure / Consumption	0.5 to 0.7Mpa / 0.4Mpa / 160Nℓ/min			
Machine Dimensions W x D x H / Weight	2200 x 2050 x 3200mm / 6700kg (Measuring Unit) 800 x 800 x 1400mm / 100kg (Control Unit)			

¹ Per JISB7451-1997. For Accuracy Specifications, H: Height from mounting surface top stylus in mm; R: Radial length from center to stylus tip in mm. L: Measuring length in mm; and S: Height from mounting surface to stylus tip in mm.



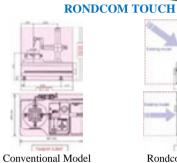
RONDCOM TOUCH Affordable Compact Roundness

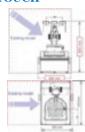
- Compact Design and Small Footprint (Nearly Portable)!
- Only 320x410mm WxD (0.13m² footprint); 500mm height!
- Measures workpieces up to Ø 150mm and 15kg weight!
- Movable Column Design (Patented):
 - R-Axis can be moved from side to side
 - Z-Axis column can be moved from side to side
 - Flexibility to reach workpieces from both right and left sides
- Windows[®] Tablet with ACCTee software:
 - Measure anywhere on the shop floor
 - All necessary icons on one screen plus alignment assist function
 - Wireless and USB communications
- Automatic Detection of Gear Tooth Tip
- Very simple, quick setup



Movable column allows detector access from both sides







Rondcom Touch

Rondcom Touch				
Measuring Method	Manual			
Max Measuring Diameter / Loading Diameter	150mm / 240mm			
R-Axis Right-Left / Z-Axis Up-Down Feed Range	Manual ±80mm / 162mm			
Max Measuring Height	160mm			
Radial Rotation Accuracy ¹	0.04+6H/10000µm (where H is measuring Height in mm)			
Axial Rotation Accuracy ¹	0.04+6R/10000µm (where R is measuring Radius in mm)			
θ-Axis Rotational Speed	6/min (fixed)			
Rotary Table Outside Diameter / Load	Ø 148mm / 15kg			
Rotary Table Centering/Tilt Range	Manual ±2mm / ±1° (fixed tilting fulcrum mechanism)			
Stylus Characteristics	±400µm range, 70mN meas. force, Ø 1.6mm carbide ball, 17mm length			
Data Processor	Windows [®] Touch Panel Tablet PC with Bluetooth [®] and USB 2.0 port lo with ACCTEE R-TOUCH version			
Digital Filter	Gaussian, Phase-compensation type 2RC, Spline, Robust (Spline)			
θ-Axis Rotational Direction Lowpass	15, 50, 150, 500 peaks/rotation any value in range 15 to 500 peaks/rotation			
θ-Axis Rotational Direction Bandpass	15 to 150, 15 to 500 peaks/rotation			
Display Magnification	10 to 200K (22 stages), Auto			
Roundness Evaluation of Form Error	MZC, LSC, MIC, MCC, N.C.			
Rotation Direction	Roundness, flatness, concentricity, parallelism, coaxiality, squareness, thickness deviation, run-out			
Analysis Processing Function	Notch function (level, angle, cursor), profile characteristic graph displa (bearing area curve, amplitude density, power spectrum), Gear analysi			
Special Function	Alignment Assist, Error Judgment, Security by Password			
Recording System	Colour Printer Option			
Power Supply / Consumption	AC 100V to 240V±10%. Grounding required. 50/60Hz. / Max 50VA			
Air Supply / Working Pressure / Consumption	0.3 to 0.7Mpa / 0.25Mpa / 30Nℓ/min			
Air Supply Connecting Port	One-touch pipe joint for tubes with Outer Diameter Ø 8mm hose			
Machine Dimensions W x D x H / Weight	320 x 410 x 500mm / Approx. 26kg ²			

¹ Per JISB7451-1997; Accuracy guaranteed temperature at 15 – 30°C. ² Excludes printer and tablet PC.



RONDCOM GRANDE CNC Roundness for Very Large, Heavy Parts



RONDCOM GRANDE

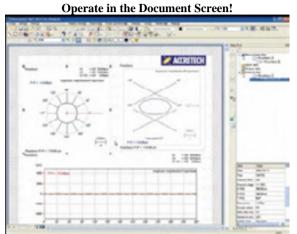
RONDCOM Grande DUO

Features: Incorporates new high precision air bearings. For wind energy generators and very large machine tool bearings. Flexible R-Axis able to also measure roughness and contour.

	Rondcom Grande	Rondcom Grande Duo	
Measuring Method	CNC		
Max Measuring Diameter / Loading Diameter / Measuring Height	Ø 1650mm / Ø 2100mm / 500mm		
R-Axis Right-Left / Z-Axis Up-Down Feed Range	450mm/550mm		
Radial Rotation Accuracy	0.08+H/1000µm (H: Height from table surface in mm)		
Axial Rotation Accuracy	0.2+R/1000µm (R: Radius from table center in mm)		
Z-Axis Up-Down Straightness Accuracy	0.15µm/100mm, 0.5µm/490mm		
R-Axis Radial Straightness Accuracy	0.1µm/200mm, 2µm/400mm		
Z-Axis Up-Down Parallelism Accuracy	1.8µm/350mm		
R-Axis Radial Parallelism Accuracy	2µm/200mm		
Rotary Table Outside Diameter / Centering / Tilt Range / Load	1650mm / ±10mm / ±0.5° / Max 500kg		
Roughness Contour Up-Down Stroke		190mm	
Roughness Contour Sensing Method	N/A	Optical Diffraction Scale	
Roughness Contour Resolution		0.54nm	
Roughness Contour Straightness Accuracy		0.3+L/1000µm	
Permissible Eccentric Weight	10000kg/mm		



ACCTEE for Roundness Metrology



ACCTEE

Expert Mode

Easy Mode

0 6 ò.

Patented Gear Tip Analysis

- Easy-to-Use Interface for Leading-Edge Operability • Easy and Expert Modes
- Detector Calibration Wizard
- Change of Analysis Condition with Preview Function
- Gear Tip Analysis (Patented)
- Straightness Measurement Function with Edge Detection
- Help System. Self-Diagnosis Function

Easy Detector Calibration Wizard

Select calibration artefact (depth/reference specimen or magnification cal unit), input condition ref value, installation method and measurement position to start!



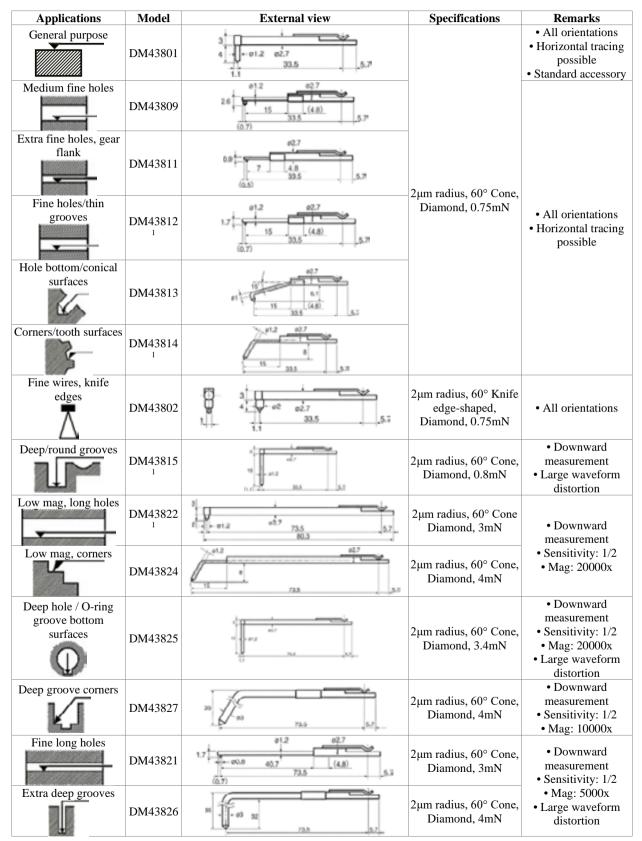
Self-Diagnosis Function

ACCTee Roundness Measurement and Analysis Program				
Digital Filter Types	Gaussian filter, phase compensation 2RC filter, spline and robust (spline) filters			
θ -Axis Rotation Direction Cut-Off	Low Pass: 15, 50, 150, 500, 1500, any value from 15 to 1500 peaks/rotation			
0-Axis Rotation Direction Cut-Oli	Band Pass: 15 to 150, 15 to 500, 15 to 1500 peaks/rotation			
Z-Axis Rectilinear Direction Cut-Off	Low Pass: 0.025, 0.08, 0.25, 0.8, 2.5, 8mm, settable in 0.0001mm units			
Roundness Evaluation of Profile Error	MZC (min zone circle), LSC (least square circle), MIC (max inscribed circle), MCC (min circumscribed circle), N.C. (no correction), Multiple setting			
Rotation Direction Measurement	Roundness, flatness, (+ compound), parallelism, concentricity, coaxiality, cylindricity, squareness, run-out, thickness variation, diameter deviation, radius, partial circle			
Rectilinear Direction Measurement	Straightness (Z and R-Axis), diameter deviation, cylindricity, squareness, parallelism			
Rectificat Direction Measurement	Also straightness with edge detecting function (for Rondcom 55, 60, 65, 73)			
Detector	Polarity and automatic measurement direction distinction function			
Master for Detector Calibration	Magnification calibration, block gauge, level difference master can be used			
Calibration Support	Sets by the guidance wizard			
Number of Sampling Points	14,400 points/rotation			
Analysis Processing Functions	Display (2D, 3D, rectilinear expansion, parameters, measuring conditions), centering/tilting support, notch/gear tip analysis (level, angle, cursor), combination of roundness evaluation methods, nominal value collation, 3D cylinder profile display (line drawing, shading, contour line), real-time display, profile characteristic graph display (bearing area curve, amplitude distribution graph, power spectrum, Fourier table CNC automatic measuring, automatic centering/tilting adjustment (for CNC models)			
Special Functions	Easy operation "Easy mode" / for CNC "Expert mode", wide-range, security function by password, error self-diagnosis function			



Replaceable Roughness / Profile Styli

For Surfcom Touch Series / Surfcom 1400 / Surfcom NEX 001



¹ Indicates stylus/nose piece set DM43800. Value of measuring force when E-DT-S03A/B / E-DT-SE19A/B / E-DT-SS01A/B / E-DT-SSE01A are mounted.



Replaceable Styli

For Surfcom CREST / Surfcom NEX100

Applications	Model	External view	Specifications	Remarks
General purpose	DM48505		2μm radius, 60° Cone, Diamond,	• Stroke: 5mm (Surfcom NEX 100) Stroke: 13mm
General purpose highly rigid stylus	DM84071		0.75mN	(Surfcom Crest) • For roughness and contour measurement
Highly rigid stylus for contours 2X arm	DM48508		Ø 1 ruby ball, 0.75mN	Stroke: 10mm (Surfcom NEX 100) Stroke: 26mm (Surfcom Crest) • For contour measurement only
Highly rigid stylus for contours 2.5X arm	DM48509	20 3	Ø 1 ruby ball, 3.2mN	Stroke: 12.5mm (Surfcom NEX 100) Stroke: 32.5mm (Surfcom Crest) • For contour measurement Only
Offset measurement Stylus	DM48511		2μm radius, 60° Cone, Diamond, 0.75mN	Stroke: 5mm (Surfcom NEX 100) Stroke: 13mm (Surfcom Crest) For roughness and contour measurement
Offset measurement stylus 2X arm	DM48742	27 5 6 8 8 9 8 9 8 9 6 108.6	25μm radius, 24° conical carbide, 4mN or less	Stroke: 10mm (Surfcom NEX 100) Stroke: 26mm (Surfcom Crest) • For contour measurement Only
Small hole stylus	DM48513			
Extra small hole Stylus	DM48514		2μm radius, 60° Cone, Diamond, 0.75mN	• Stroke: 5mm
Deep hole stylus	DM48515	25 26 24 24 24 24 25 24 25 24 26 38,5		(Surfcom NEX 100) Stroke: 13mm (Surfcom CREST) • For roughness and contour measurement
Stylus for fine contours	DM48588	(3) 13 10 	5μm radius, 30° Cone, Diamond, 0.75mN	
Stylus for ridge/ tooth tip measurement	DM48774		2µm radius, 60° Knife edge-shaped Diamond, 0.75mN	

*Special stylus will be studied and proposed in accordance with customer's workpieces.



Contour Styli

Applications	Model	External view	d	L1	L2	Applicable arm	Remarks
General purpose	DM45501 ²	ød -• [] •†	3	60	52	010 2804	
	DM45502	12'- L2 L1	3	34	26	010 2800	
	DM45503	R0.025	2	21	13	010 2801	
General purpose	DM45504 ²	od → 1 →	3	60	52	010 2804	
-	DM45505 ³		3	34	26	010 2800	Standard accessory
	DM45506	24° conical, R0.025	2	21	13	010 2801	
Edge line	DM45507 ²	ød→ ∏ ←]	3	60	52	010 2804	
1	DM45508 ³		3	34	26	010 2800	
\sim	DM45509		2	21	13	010 2801	
Small holes	DM45081	12'-1 /2	-	12	9		
	DM45082	17		7	5	010 2802	
	DM45083 ¹	R0.025 65	-	3.5	1.5		
Small hole twist	DM45084 ³	-+ ⁷	-	12	9		
	DM45085	17 ¹	-	7	5	010 2802	
umumumu	DM45086 ^{1,3}	24° conical, R0.025 65	-	3.5	1.5		
Ordinary offset	DM45087	25 65	-	12	9		
	DM45088		-	7	5	010 2802	Offset: 25mm
	DM45089 ¹	L2 12° angular, R0.025 17	-	3.5	1.5		
Helix surface offset	DM45090	25 65	-	12	9		
	DM45091		-	7	5	010 2802	Offset: 25mm
	DM45092 ¹	L2 24° conical, R0.025 17	-	3.5	1.5		
	DM45522 ²		3	60	52	010 2804	
High precision	DM45523	ød →∏ ⊷1	3	34	26	010 2800	Ø 0.7 ruby ball
	DM45524		2	21	13	010 2801	
\bigcirc	DM45525 ²		3	60	52	010 2804	
	DM45526	. + +	3	34	26	010 2800	Ø 1 ruby ball
	DM45527		2	21	13	010 2801	

For Contourecord 1600 / Surfcom 1800

¹ Requires master ball calibration unit for small holes. ² Requires pickup holder joint. ³ Indicates stylus/arm set 010 2999.



Adjustment Devices

For All Surfcom Series

Name	Model	External view)rthogonal ljustment (Swive	el adj.	Tilt	adj.	Table	Load/ Weight	Remarks
			Х	Y	Ż	Fine	Coarse	Fine	Coarse	size mm	in kg	
Adjustment Stand	E-AT-S01D	and the second	50	50	-	8°	360°	-	-	Ø 150	20 / 7	Min reading increment 10µm
Leveling Adjt. Stand	E-AT-S02A	\bigcirc	-	-	-	-	-	±1.5°	-	80×110	15/3	
	E-AT-S03A		-	±2.5	-	±2°	-	-	-	80×58	3 / 0.9	For E-RM- S75A/B
Adjustment Stand	E-AT-S04A		-	±8	-	±3°	-	-	-	80×125	15 / 8	
	E-AT-S05A		-	±3	-	±1°	-	-	-	120×58	3 / 1.4	For E-RM- S76A/B
X-direction movement Adjt. Stand	E-AT-S08A		400	-	_	-	-	-	-	150×150	20 / 25	-
3D fine Adjt. Stand	E-AT-S10B		50	50	30	-	-	-	-	76×76	1.6/5	Straightness 0.03mm
1-axis precision fine Adjt. Stand	E-AT-S11B		-	50	_	-	-	-	-	125×150	20 / 4.9	Straightness 3µm. Min reading: 10µm
Swivel fine rotation stand	E-AT-S12B		-	-	-	±5°	360°	-	-	Ø 90	3 / 0.58	Min reading: 5'
Tilting stand	E-AT-S64B		-	-	-	-	-	±20°	-	60×120	10 / 1	Min reading: 5'
Universal stand	E-WJ-S03A	S	-	-	_	-	360°	-	±90°	Ø 110	3 / 2.5	X/Y- direction adj.
Column spacer	E-CS-S32A ¹ E-CS-S77A ³	Î	-	-	H:200	-	-	-	-	-	-	Set between table and column
Tracing driver spacer	E-CS-S33A ¹	Je contraction	-	L : 70	_	-	-	-	-	-	-	Set between column and tracing driver
Column rotary spacer	E-CS-S31A ¹ E-CS-S76A ³		-	-	H: 100	-	360°	-	-	-	-	Set between table and column
Tracing driver tilting device	E-CA-S32A ² E-CA- S101A ³		-	-	-	-	-	-	±5°	-	- / 5	For roughness

 $^{\rm 1}$ Cannot be used with S3000A Series and S5000 Series.

² For S1400D, S1800D, S2800E, C1600D, C2600E.

³ For the Linear Series and S1400G, C1600G, S1800G, C2600G, and S2800G Series, S TOUCH 550, S480.

 4 For the NEX Series, Linear Series, and 1400G, 1600G, 1800G, 2600G, and 2800G Series.

⁵ For the NEX Series.



TABLE ROTATING RONDCOM STYLI

For Rondcom 31 / 41 / 43 / NEX / NEX α / NEX Rs / NEX Rs α / 60A / 65B

Application	Model with	Specifications	
	1:1 Standard Sensitivity L = 59.5mm	1.5:1 Sensitivity L = 97mm	
General	EM46000-S300	EM46100-S300	Ø 3.2mm Carbide ball
Purpose	EM46000-S302	EM46100-S302	Ø 1.6mm Carbide ball
Small Holes	Ø 1mm Carbide ball		
	EM46000-S303	EM46100-S303	R0.25mm, 55° conical Sapphire, L-type, L = 4.5mm
Grooves	EM46000-S306	EM46100-S306	R0.25mm, 55° conical Sapphire, T-type, L = 6.5mm
	EM46000-S307	R0.25mm, 55° conical Sapphire, T-type, L = 10mm	
D. C.	EM46000-S304		
Deep Grooves -	EM46000-S308 EM46100-S308		R0.25mm, 55° conical Sapphire, T-type, L = 20mm
Corners	EM46000-S305	EM46100-S305	R0.25mm, 55° conical Sapphire, L-type, L = 3.4mm/60°
Extra Small Holes	EM46000-S309	EM46100-S309	
Cutter Mark Removal			R0.25mm Sapphire, L type, L =
	EM46000-S310	EM46100-S310	4.8mm/R15mm

	2:1 Sensitivity						
Stylus Attachment	EM-59103-S001	Used when 2: 1 stylus for detectors E-DT-R32A/-R74A is mounted					



TABLE ROTATING RONDCOM STYLI

Application	Model with	Specifications	
	1:1 Standard Sensitivity L = 17mm	2:1 Sensitivity L = 54mm	
General	0194 000	0194 200	Ø 3.2mm Carbide ball
Purpose	0194 002	545 (st 2) 110° carbido bad (st 1.00) 545 (st 2) 10° carbido bad (st 1.00) 550 (st 2) 10° (st 1.00) 550 (st 1.00) 550 (st 2) 10° (st 2) 10° (st 1.00) 550 (st 2) 10° (st 2) 10° (st 1.00) 550 (st 2) 10° (st 2) 10	Ø 1.6mm Carbide ball Standard stylus
Small Holes	0194 001	** 00 1 1 cartiste ball 55 545 (0.5) 0194 201	Ø 1mm Carbide ball
Extra small holes	0194 009	6194 209	Ø 0.5mm Carbide ball
	0194 003	0194 203	R0.25mm, 55° conical Sapphire, L-type, L = 4.5mm
Grooves	Public de la conceletaria de la	Hi 25, 55 corical (buth sides)	R0.25mm, 55° conical Sapphire, T-type, L = 6.5mm
	1.5 (100) (1	et of second particular and the second parti	R0.25mm, 55° conical Sapphire, T-type, L = 10mm
Deen Cheering	0194 004	0194 204	R0.25mm, 55° conical Sapphire, L-type, L = 10mm
Deep Grooves –	All the second part of the secon	0194 208	R0.25mm, 55° conical Sapphire, T-type, L = 20mm
Corners	0194 005	0194 205	R0.25mm, 55° conical Sapphire, L-type, L = 3.4mm/30°
Cutter Mark Removal		101 100 100 100 100 100 100 100 100 100	R0.25mm Sapphire, L type, L =
	0194 010	0194 210	4.8mm/R15mm

TABLE ROTATING RONDCOM DETECTORS/HOLDERS

General Purpose Detectors -m 024.6 Model with External View - D **The** E-DT-R120B E-DT-R83B and -R95B R55/60A/65B with E-DH-669B; R E-DT-R83B for R47/55/60A/65B E-DT-R95B for R31/41/43 NEX/ α /Rs/Rs α with E-DH-Applicable for with detector safety device R749B/R774B/R770C Specifications Meas. Range: $\pm 1000 \mu m$; Meas. Force: 30 to 100mN; Front adjust mechanism: ID/OD switch function

For All Rondcom Series

CNC Detector Holders (for E-DT-R120B)							
Model with External View	E-DH-R665B and -R669B	E-DH-R720B	E-DH-R677B	E-DH-R690A			
Applicable for	E-DH-R665B for R60A/R65B and E-DH- R669B for R55	R60A/R65B ¹ + 30mm EE74023 combi link cable	R60A/R65B + 70mm EE74017 combi link cable	R55/R60A/R65B + 30mm EE74023 combi link and EE74022 holder cable			
Throat Height			189mm				
Throat Depth	55mm	96mm	135mm	55mm			
Others		Magnification: $\leq 10000x$	Magnification: \leq 5000x. F	or Stylus Sensitivity: 1.5:1			

Offset Detector Holders (for E-DT-R120B)						
Model with External View	E-DH-R749B/(R845A)	E-DH-R770C/(RB28C)	E-DH-R779B/(R892A)	E-DH-R774B/(R900B)		
Throat Height	153	mm	19	lmm		
Throat Depth		651	nm			
Operation	Manual		CNC			
Others		filter 15, 50 peaks/rotation for stylus sensitivity 1.5:1				
Applicable for	R54. R55, R60A and R65B with horizontal feed device. Rondcom NEX (-R845A, -RB28C, -R892A, -RB30B)					

	Manual Detector Holders							
Model with External View			L Del					
	E-DH-R636B/-R603B	E-DH-R618A	E-DH-R613A	E-DH-R678A				
Applicable for	R636B for R47/R55/R65B ¹ R603B for 60A	R31/R41/R43 ²	R47/R55/R60A/R65E	3 ¹ and R31/R41/R43 ²				
Throat Height	154mm 192mm							
Throat Depth	68mm 120mm							
Others		Magnification: ≤ 5000x. For Stylus Sensitivity: 1.5:1						

¹With detectors E-DT-R83B, E-DT-R173B, E-DT-R120B, E-DT-R168C. ²With detector E-DT-R95B.



TABLE ROTATING RONDCOM DETECTORS/HOLDERS

		Gen	eral Purpos	se Detector		
Model with External View			70p of detect 24.5 12 12 Detectar with 14 58.8	22 00 17 0.5 3.5 28.8	Stylus_	R32A: L = 25mm R74A: L = 45mm
	E-DT-R32B for F	T-R32B and -R272 30/R31/R40/R41/F		DT-		-R74B
Applicable for	K	272C for R Touch			R47/R55/H	R60A/R65B
Specifications		00µm; Meas. Force nism: ID/OD swite		ont Me	U 1 /	Meas. Force: 70mN; Front D/OD switch function
Option		S	tylus: Ø 1.6	carbide bal	ll (0194 002)	
		Low M	leasuring F	orce Detect	tor	
Model with External View	E-DT-R10B	E-DT-F		Lee results frow Silder 26.5 64.8 153.	DT-R173B	E-DT-R168C
Applicable for	R30/R31/R40/R41/	R43 ¹ R47/R55/R60)A/R65B ^{1,2}		R65B ³ , R55/R65B 0A ⁴ , R60A ^{4,6,7}	R55/R65A ^{3,6} , R60A ^{4,6} , R44/R54 ⁵
Specifications		Mea	as. Range: ±	400µm; Me	as. Force: 5mN	
¹ Stylus: Ø 1.6 ru holder E-DH-R63	by ball (010 2505) wit 36B. ⁴ with holder E-D	h cable length 1.5m. H-R603B. ⁵ with offs	² with detected et holder E-D	or holder E-I H-R749B. ⁶	DH-R639A and C46 ada With CNC holder. ⁷ Wit	pter (cable length 0.5m). ³ With h C6L6 conversion adapter.
			Detector H	olders		_
Model with External View	E-DH-R639A and			The Assessment of State		B (1997)
	-R384A	E-DH-R617A	E-DH-	R149B	E-DH-R329A	E-DH-R317A
Applicable for	R639A for R47/R55/R65B ^{1,3} , R31/R41/R43 ^{2,4} R31/R41/R43/R47/R55/R60A/R65B ^{1,2} R60A ¹ R384A for R60A <t< td=""><td>R60A¹</td></t<>				R60A ¹	
Throat Height	90.1			300mm	170mm	
Throat Depth	68n	nm			60mm	115mm
ID / ID Meas. Range			Ø 31	mm	$\geq \emptyset 31 \text{mm} / \emptyset 16 \text{ to}$ 300 mm	Ø 20 to 300mm
Magnification			≤ 20	000x	≤ 1000x	≤ 2000x
Stylus Sonsitivity			1:	:1	1	:1 to 3:1

¹With detector E-DT-R74B. ²With detector E-DT-R32B. ³With detector E-DT-R87B. ⁴With detector E-DT-R10B.

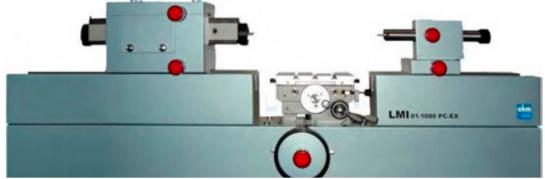
Sensitivity

Stylus for Low Measuring Force Detector							
Model with External View							
	General Purpose Stylus 010 2505	Small Hole Stylus 010 2516					
Appliashla for	E-DT-R10B, -R87B, -R	172B, -R173B, -R168C					
Applicable for	Stylus: Ø 1.6mm ruby ball	Stylus: Ø 1mm ruby ball					



LMI 01-400 / 680 / 1000 PC Universal Length Metrology Instrument

For accurate length measurements and inspection tools calibration



LMI 01-1000 PC-EX

Universal Length Measuring Instrument available in 400, 680 and 1000mm range



Calibration of plug/pin gauge

- USB interface plus a retrofitted model
- LMI-MS for Windows® 10 software
- Digital axis in X, Y and Z
- 3D mode for gauges with parallel contact surfaces
- Motorized Z-Axis option / Granite bed option
- · Software and kits available as retrofits for older systems





Calibration of ring gauge ID



Calibration of thread ring gauge

Available Kits: For plain gauges (cylindrical plug, ring, taper and snap gauges), thread gauges, indicator tools (dial gauges, micrometers) and for measuring the diameter between/over balls/pins at gears and gear gauges.

Taper

External D > 0mm

Internal $D \ge 1mm$

Dial Gauges /

Indicators

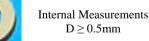
Range ≤ 100 mm

Internal Micrometer

Range ≤ 100 mm



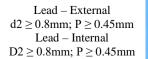
External Measurements D > 0mm







Internal Threads $D2 \ge M3;$ $P \ge 0.45mm$



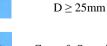












Gears & Serrations External MdK \ge 7mm Internal MdK \ge 15mm

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Kits of Masters D≥0mm

Snap Gauges

 $D \ge 0.5 mm$

Taper Threads External d > 0mmInternal $D \ge M3$

General Measurements External d > 0mmInternal $D \ge 0.5mm$

New kits for large internal threads and for measuring forces up to 11N, and others on request



AVX550 AVX CNC Automatic Vision Metrology System

- Innovative dual-optical feature that delivers accurate, fast measurement and throughput
- Dual camera inputs allow users to inspect parts at multiple levels without changing lenses or re-calibrating
- Large format platform stage: 550x400x250mm
- MetlogixTM M3 software with video edge detection is extremely user friendly and intuitive
- 24" touchscreen monitor and PC
- Dedicated 12:1 zoom optics with choice of 0.14x-4x telecentric optics
- Linear guide X-Y transport for ultra-smooth, high-speed positioning
- Ideal for large platform measurements uses in quality control labs in research engineering and manufacturing inspection processes, where large parts with intricate features need inspection



AVX550



	AVX550			
System	CNC XY&Z Servo Motor Drive with CNC/Joystick Control			
X x Y x Z Travel in mm	550mm x 400mm x 250mm			
E2 X,Y Accuracy	2.5+5L/1000µm			
E1 Z Accuracy	2.5+5L/1000µm			
Scale Resolution	0.1µm			
Max Sample Load	23kg			
Multi-Sensor Compatible	Optic & Touch Probe			
Base	Granite			
Control System / Display	MetLogix M3 / 24" Touchscreen PC			
Zoom Optics – Standard	12:1 (26X to 310X)			
Telecentric Options	Choice of 4.0x, 2.0x, 1.0x, 0.8x, 0.5x, 0.3x (fixed or interchangeable), 0.14x (fixed)			
Digital Video Camera	1.3MP with Zoom Lens, 5.0MP with Telecentric Lens			
Illumination	LED (Surface Ring / Transmitted / Coaxial)			
Options	Adjustable ergonomic work station including a compact control panel, CNC rotary axis fixtures Renishaw touch probe kits and changing racks, Calibration standards, Part fixtures and work holding devices			



AV/AV+ Automatic Vision Metrology



AV450



Freit





Part Holding Fixtures

High resolution, excellent illumination, mechanically precise platforms plus MetLogix M3 DXF/FOV/CNC touchscreen metrology software combine to deliver fast, automated and reliable 2D and 3D (with add-on Renishaw touch probe) measurement and documentation. QC-CAL SPC can be added (option).

* FOV models available with 7 interchangeable and 1 fixed telecentric lens.





Renishaw Changer Rack

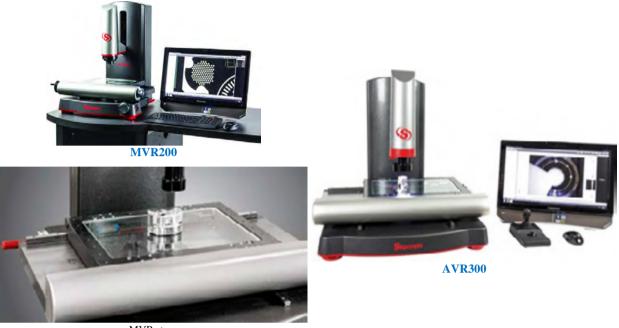


	AV350	AV450				
System	CNC Z-Axis Measuring with Vertical Pa	rt View Orientation with CNC X-Y Stage				
X x Y x Z Travel in mm	350x350x200	450x350x200				
E2 X,Y Accuracy	2.5+5L/	1000µm				
E1 Z Accuracy	2.5+5L/	1000µm				
Scale Resolution	0.1	μm				
Multi-Sensor Compatible	Optic & Te	ouch Probe				
Base	Granite					
Control System / Display	MetLogix M3 / 24" Touchscreen PC					
Zoom Optics - Standard	6.5:1 (31X to 198X)	; 12:1 (26X to 310X)				
Digital Video Camera	1.3MP Dig	tial Colour				
Illumination	LED or Fibre Optic (Surface Ring	/ Transmitted / Optional Coaxial)				
Common Options		ture / Renishaw Touch Probe / Part Fixturing / mination (LED only)				
Video Pixel Cal Standard	Op	tion				
Calibration Artefact Options	Calibration Standard; and FOV,	Linear, 2D Calibration Standard				
Туре	Floor Standing with Machine Pedestal a	and Point of Control Cart/Arm provided				
Dimensions WxDxH in mm	872x1143x1044					
Gross / Net Weight	579kg	/ 185kg				

¹ Workstation with swing arm may be purchased locally.



AVR CNC / MVR Manual Vision Metrology



MVR stage

Ultra-low 0.001% distortion telecentric FOV measurements; Stable granite base; Recirculating ball linear guides for precise stage motion; automatic CAD comparisons and minimal external wiring: makes the AVR200/300 an ideal, affordable metrology tool. The manual MVR200/300 version is useful for short run individual measurements.

* FOV models available with 7 interchangeable and 1 fixed telecentric lens.

	MVR200	MVR300	AVR200	AVR300	
System	Vertical Part V	iew Orientation Bench	Top System with Option	nal Workstation	
X x Y x Z Travel	200x100x200mm	200x100x200mm 300x200x200mm		300x200x200mm	
E2 X,Y Accuracy	2.5+5L/	1000µm	1.9+5L/	1000µm	
E1 Z Accuracy		2.5+5L/	/1000µm		
Scale Resolution	0.5	μm	0.1	μm	
Base		Gra	nite		
Control System / Display		MetLogix M3 / 21	.5" Touchscreen PC		
Zoom Optics – Standard	6.5	5:1	6.5:1 – 2 LED	; 12:1 – 3 LED	
Digital Video Camera	1	.3MP Colour Standard	: 2.0MP with Telecentri	c	
Surface Ring Illumination					
Transmitted Illumination		LED		LED or Fibre Optic	
Coaxial Illumination Option					
Auxiliary Lens Options		0.5X, 1.	5X, 2.0X		
AVR Options	N	/A		e / Dark Field Quadrant only)/ Rotary Fixture	
Common Options	Workstation Base, Extension and Swing Arm / Part Fixturing / Video Pixel Calibration Standard / Calibration Standards / FOV, Linear and 2D Calibration Standards				
Dimensions W x D x H	411 x 679 x 585mm	541 x 884 x 683mm	520 x 685 x 863mm	740 x 890 x 865mm	
Gross / Net Weight	115kg / 90kg	135kg / 113kg	115kg / 66kg	135kg/ 102kg	

Optical Parameter	Telecentric Lenses						AVR Zoom Optics		MVR	Zoom Optics
Optical Farameter	recentric Lenses						12:1	6.5:1		5:1
Optical Magnification on CCD	0.30x	0.50x	0.80x	1.0x	2.0x	4.0x	1.4x to 4.7x	0.47 to 3.0x 0.7 to 4.5		0.7 to 4.5x
Total Magnification on Monitor	13x	22x	36x	45x	89x	178x	26x to 310x	31 to 200x		200x
Field of View Width	24mm	14mm	9mm	7mm	3.5mm	1.8mm	11 to 1.2mm	10 to 1.6mm		.6mm
Working Distance	110mm			86mm	88mm		nm			
CCD Camera Array		1/1.8"				1/.	3"		1/1.8"	



AVR FOV 0.14 CNC FOV Model



AVR FOV 0.14







A precision mechanical bearing X-Y-Z stage and column along with interchangeable telecentric lenses gathers data accurately and with repeatability via the MetLogix software. The compact bench top AVR FOV 0.14 is a rapid videobased FOV CNC measurement system that reduces measurement time and is ideal for quality assurance, inspection labs, manufacturing, assembly and research facilities.

	AVR FOV 0.14		
System	Bench Top System		
X x Y x Z Travel	300x200x200mm		
E2 X,Y Accuracy	3.0+5L/1000µm		
E1 Z Accuracy	3.5+5L/1000µm		
Scale Resolution	0.1µm		
Base	Granite		
Control System / Display	MetLogix M3 / 24" Touchscreen PC		
Digital Video Camera	6.0MP Monochrome		
Illumination	LED (Surface Ring / Transmitted / Coaxial)		
Options	Rotary Fixture, Renishaw Touch Probe, Workstation Base, Extension and Swing Arm, Pa Fixturing, Video Pixel Calibration Standard, Calibration Standards		

MVR/AVR FOV Specifications - with 2MP Camera and 24" Monitor and M3 Software

Telecentric Magnification	0.14x	0.3x	0.5x	0.8x	1.0x	2.0x	4.0x	
Telecentric FOV	50x38mm	23x18mm	14x10mm	9x6.5mm	7x5.3mm	3.5x2.6mm	1.8x1.3mm	
Optical Line Resolution on Monitor (Lines/mm)	20.1	17.9	14.3	11.3	8.0	5.0	4.0	
Accuracy ¹	15.7µm	7.3µm	4.4µm	2.8µm	2.2µm	1.1µm	0.6µm	
Magnification on Monitor	6.2x	13.2x	22x	35x	44x	89x	177x	
Telecentric Working Distance			110	mm (All Len	ses)			
6.5:1 Manual Zoom Optics Mag	0.7x	1.0x	2.0x	3.0x	4.0x	4.5x		
Zoom FOV	9.6x8.90mm	7.2x6.1mm	3.7x3.0mm	2.4x2.0mm	1.8x1.4mm	1.5x1.3mm		
Magnification on Monitor ²	29x	39x	80x	112x	160x	188x		

¹ Accuracy results are dependent on many variables. ² Screen magnification is variable based on Best Fit setting in M3 software.



KMR Video Inspection Metrology



• 6 versatile, affordable inspection and metrology models

- Ideal for incoming QC, manufacturing, assembly and documentation
- Small features within FOV can be measured by software gauging without applying the 200mm stage motion for larger parts
- MetLogix M3 software with PC and 24" touchscreen monitor
- LED surface and transmitted illumination
- Small footprint

Model Type	-200-M3	-Zoom-M3	-FOV-M3-0.3x	-FOV-M3-0.5x	-FOV-M3-1.0x	-FOV-M3-0.14x				
Optics	6.5:1	Zoom								
CCD Sensor	1.33	MP		2.02MP		5MP				
Camera Interface		USB Cable								
Computer		PC								
Software			Metlogiz	х тм МЗ						
Video Screen			24" Touchsci	reen Monitor						
Screen Resolution			1920 x	x 1080						
Lens Magnification	0.7x to 4.5x	Zoom Lens 0.3x 0.5x 1.0x				0.14x				
Screen Magnification	31x to	200x	13x	22x	45x	4.7x				
Auxiliary Lenses	0.5x	, 2x		-	-					
Field of View Width	1.4mm to	o 9.0mm	24 mm	14mm	7.1mm	60mm				
Field of View Height	1.1mm to	o 7.4mm	19mm	11mm	5.8mm	51mm				
X-Y Stage Motion	200 x 100m			-						
Z Travel	125mm			-						
Metrology Means	X and Y Encoders		Ν	A3 FOV Software	2					
Measurement Resolution	0.5µm		Up to	2μm*		Up to 3µm*				
Meas. Accuracy	2.5µm+5L/1000		Up to ±	2.5µm*		Up to ±3µm*				
Basic Stand			Standard			Milled				
Boom Stand	N/A	Optional		-	-					
LED Back Light			Standard			Narrow Angle				
LED Ring Light			Standard			Dome				
Lighting Control		Via M3 Software								
Video Inspection			Ye	es						
Basic Dimensions		Yes, VED- FOV Stage Measurement								
Geometric Constructs		Yes								
Image Annotation		Yes								
Image Archiving			Ye	es						
Video Edge Detection			Ye	es						

* Best value achievable; actual values depend on zoom lens setting / selected telecentric lens.

Digital Video Comparators



HVR-FLIP Digital Video Metrology NEW!



HVR-FLIP Vertical format



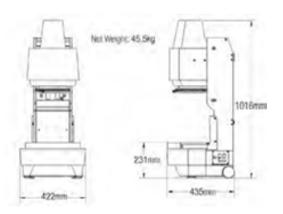
Horizontal format

• Flips between vertical and horizontal stand up depending on application

- Rapidly measure a single feature, an entire part, or multiple parts up to 3.65×3 " with the HVR-Flip's large FOV and working distance of 10"
- Metlogix M3 one-touch feature measurement with auto-detect part recognition, DXF import and export and "Part View" constructions
- Option modules: Profile fitting, wire insulation and thread measurement
- Compare complex profiles with discreet data points and CAD
- · Geometric tolerancing with flexible report content and formatting
- Multi-language support



HVR 100							
Field of View / Field of View Accuracy	92.7mm x 76.2mm / 0.01mm						
Optical Magnification	0.090X						
Total Magnification on Monitor	3X						
Working Distance	254mm						
Camera	5MP 2/3" CCD Monochromatic						
Lighting	LED						
Software	MetLogix M3 on Windows [®] operating system incl. 24" touchscreen monitor						
Shipping Dimensions / Weight / Net Weight	122 x 66 x 78cm / 94kg / 45.5kg						





HDV Series High Productivity Digital Video Comparator

- Supercharges traditional horizontal projector with new Field of View lens technology plus digital software gauging for highest productivity with accuracy
- Based on Starrett's renowned horizontal projector on rigid steel workstage
- Large FOV telecentric lens (62 x 47mm, $7\mu m$ res, better than 0.001% optical distortion) and mounted 5MP digital video camera for precise measurements
- MetLogix M3 software on Windows® 10 64-bit PC with 24" colour touchscreen
- All features in the FOV are digitally measured in split seconds!
- DXF file import for CAD nominal vs Video edge inspected image comparison





	HDV300	HDV400	HDV500 CNC		
System	Bench To	p, with Horizontal Part View O	rientation		
X x Y Measuring Range	300 x 150mm	500 x 200mm			
CNC	Opt	tion	Standard		
X,Y Accuracy		3.0+L/33µm			
Scale Resolution		0.5µm			
Base		Steel			
Control System		MetLogix M3			
Display	24" Tou	chscreen	42" Monitor		
Telecentric Optics Choices	4.0X, 2.0X, 1.0X, 0.80X, 0.50	0.24X, 0.16X and 0.11X			
Telecentric Optics Choices	lenses (Option	interchangeable lenses			
Digital Video Camera		5MP Black and White			
Illumination	LED (Surface	Ring Illumination / Transmittee	l Illumination)		
Options	Part Fixturing / Video Pixel Calibration Standard / Calibration Standards / FOV, Linear 2D Calibration Standards / Cabinet Stand (Only HDV300 & 400)				
Workstage / Max Load Capacity	540 x 130	mm / 50kg	540 x 130mm / 150kg		
Gross / Net Weight	195kg / 118kg	200kg / 118kg	635kg / 600kg		

		Telecentric Lenses						6.5:1 Zo	om Lens
Optical Magnification	0.14x	0.30x	0.50x	0.80x	1.0x	2.0x	4.0x	0.7x	4.5x
Magnification on 24" Monitor	8.6x	18.5x	21x	49x	62x	124x	247x	58x	363x
Field of View Width	63mm	29mm	15mm	11mm	9mm	4.3mm	2.3mm	11mm	1.5mm
Working Distance		110mm N/A					N/A	881	nm
Optical Distortion	0.0	0.001% 0.002% 0.005% 0.006				0.006%	N	/A	



VB300 / 400 / HB / HD / HE400 Bench Top Profile Projectors



HB400

- · Classic bench-top projectors with rigid, inherently stable construction for optimal performance and accuracy, expanded travel and measuring capacity
- New Measurement Functionalities and Efficiency from MetLogix Software
- Fully usable Ø 400mm screen with integral hood
- Precision workstage with machine slots for fixturing (horizontal projectors)
- Dual mirror design for vertically corrected image
- · Rotary workstage helix adjustment/Fully retractable fibre optic surface illumination system/Dual fan-cooled lamps for VB400
- · Fine adjustment all axes, zero back-lash, fast X-Axis traverse (HE/HB/HD/VB400)
- · Motorised/CNC workstage options and wide choice of lenses and accessories









HE400

VB400

	HE400	HB400	HD400	VB400	VB300		
Image Projection		Horizontal		Ver	tical		
Screen Diameter		Ø 40	0mm		Ø 300mm		
X x Y Measuring Range	250x100mm	300x150mm	100x100mm	200x100mm	100x100mm		
X x Y Measuring Range Option	N/A	400x150mm		N/A			
Linear Glass Scale Encoder		Stan	dard on X and Y-	Axis			
Motorized X-Y Axis / CNC Control	N/A	Opti	onal	N	/A		
Focus Range	30mm	501	nm	100mm	90mm		
Work Stage	475 x 120mm	540 x 1	130mm	400 x 225mm	225 x 225mm		
Load / Max Load	6.8kg / 25kg	10kg	/ 50kg	10kg / 22.7kg	5kg / 6.8kg		
Profile / Surface Illumination			Standard				
Quick Change Lens Mount	Sin	gle	Dual	Single			
Collimating Condenser		Standard	d with Yellow/Gre	en Filter			
Control System	M1, M2	M1, M	I2, M3	M1,	, M2		
Display	(also		hscreen PC, M1 w PC or 24" Monito	ith 7" tablet r for HB400 & HI	D400)		
Lenses – Screen Magnification	10X, 20X	X, 25X, 31.25X, 50	0X, 100X	10X, 20X, 25X, 50X, 100X	10X, 20X, 25X, 50X		
	Optical Edge Detection / Precision Centers and Vees / Cabinet Stand 23" / Canopy and Curtains (except VB300)						
Options	on Rotary Base / Work Holder /	Precision Rotary Precision Fixed V Cabinet Stand 32" a System (except I	Helix Center Support System / Precision Rotary Work Stage	N/A			

Lens Specifications / Screen Mag	10X	20X	25X	31.25X	50X	100X
Field of View Diameter	40mm	20mm	16mm	13mm	8mm	4mm
Working Distance	80mm	76mm	62mm	57mm	50mm	41mm



VF / HF / HS600 / HF / HS750 Floor Standing Profile Projectors



HS600





HF600

VF600

	VF600	HF600	HS600	HS750	HF750	
Image Projection	Vertical	Horizontal				
Screen Mounting	Vert	ical	Side	e Bed	Vertical	
Screen Diameter		Ø 600mm		Ø 75	0mm	
X x Y Measuring Range	200 x 100mm		300 x 200mm (50	0 x 200mm Option)		
Linear Glass Scale Encoder		Star	ndard on X and Y-	Axis		
Motorized X-Y Axis	Optional		Star	ndard		
CNC Control	N/A	Optional				
Focus Range / Work Stage in mm	100 / 400 x 225	75 / 630 x 230				
Load / Max Load	10kg / 30kg	50kg / 150kg				
Quick Change Lens Mount	3 Lens Turret	4 Lens	Turret	3 Lens	Turret	
Control System / Display		M2, M3 / 21"	Touchscreen PC of	or 24" Monitor		
Lenses – Screen Magnification		10X	, 20X, 25X, 50X,	100X		
Standard	Profile/Surface II	lum., Canopy/Cur	tains, Collimating	Condenser with Yel	llow/Green Filter	
		Optical Edge De	tection / Precision	Centers and Vees		
Optional Helix Center Support/Precision Digital Video Camera System / Iris Diaphragm / Fixed Vise / Vee Block on Rotary Base / Glass				1 0	~	

Lens Specifications	VF600, HF600 and HS600			HS600			750/HS7	/50		
Screen Magnification	10X	20X	25X	50X	100X	10X	20X	25X	50X	100X
Field of View Diameter	60mm	30mm	24mm	12mm	6mm	75mm	37.5mm	30mm	15mm	7.5mm
Working Distance	138mm	127mm	103mm	88mm	44mm	151mm	101mm	92mm	60mm	48mm



Optional Accessories

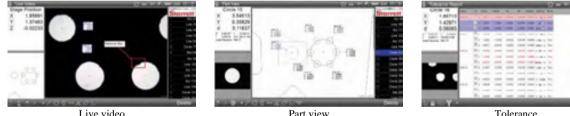
- A Large Centers and Vees
- B, K, N Rotary Vise
- C Magnification Checking Graticule
- **D**, **E**, **G** Centers and Vees
- **F** Helix Center Support Fixture
- $\boldsymbol{H}, \boldsymbol{J}-Vertical$ Glass Plate Holder
- M Rotary Work-stage
- P Universal Vee Block on Rotary Base
- \mathbf{S} Cabinet Stand
- \mathbf{T} Canopy and Curtains (* not shown)

Mx Series *NEW!* Simple and Innovative Readout (Mx100 / Mx200)

- · Simple and durable interface with large rubber buttons and intuitive operation
- · Graphics-rich display providing instant information on feature form, tolerances, and measurement data on 7" color screen
- Optical edge detection on Mx200 provides better throughput and removes operator subjectivity
- MetLogixTM control readouts provide a broad range of powerful, user-friendly functions on a compact, icon-based touchscreen interface in place of the traditional control

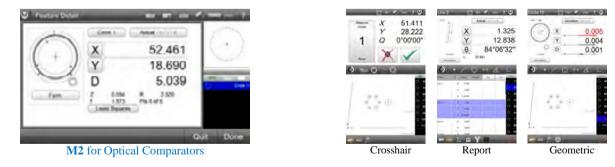
MetLogix M3 Touchscreen Software for Vision Systems

- Windows®-based multi-touch screen pinch, swipe or touch to pan and zoom
- Works with active part views and live video feeds
- · Advanced Video tool probe box, Edge touch and "Vtouch" video touch probe
- "Eye Measure" captures complex edges generated by touchscreen finger path
- · "Measure Logic" instant touch feature determination and measurement
- "Quick Annotate" displays data with smart marquee feature selection
- · Industry-standard stage and camera calibration methods





MetLogix M1/M2 for Optical Comparators



- · Touchscreen, large icon buttons and intuitive operation. Mounts and displays vertically/horizontally
- X and Y Linear Axes and Q angular screen rotation Display. Easy part alignment and datum function
- · Geometric tolerance and measurements: point, line, angle, distance, radius and diameter
- Teaching part programming visually guides operators through repeated part measurements
- Optical edge detection (option) reduces operator subjectivity
- · Advanced crosshair "auto edge" probe toolbox captures points on edges automatically upon crossing
- M2 utilizes a Windows[®]-based operating system for flexible data export and interface capability
- M1 utilizes an AndroidTM operating system and a Bluetooth[®] connection to the host Optical Comparator



Mx200





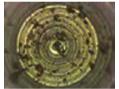


Recorded

iNEXIV VMA Versatile Multi-Sensor Metrology



- Generous 3D volume from wide 13x10mm FOV at 0.35x (for easy search and alignments),73.5mm robust working distance, 200mm Z-Axis stroke for large step heights to cover tall bosses or deep holes
- Available in 3 models covering 250x200mm to 650x550mm X-Y Range; Option for Renishaw® touch probe
- 10x zoom for high res accurate measurements. Excellent high 0.11 NA low distortion Apochromat objective lens
- Episcopic (top), diascopic (bottom) and 8-segment-ring (18° oblique angle) LED illumination for detecting low contrast edges. Factory Option for extended 1.5x magnification for minute parts
- Nikon's VMA AutoMeasure Software for easy setup, teaching, measurements and evaluations



Highly repeatable vision AF



Intelligent search

	VMA-2520		VMA-4540		VMA-6555	
Measurement Range in mm	XY	Z	XY	Z	XY	Z
Measurement Range TP20	200 x 200	166	400 - 400	166	600 x 550	166
Measurement Range TP200	200 x 200	170	400 x 400	400 X 400 170		170
Measurement Range Vision AF	250 x 200	200	450 x 400	200	650 x 550	200
Measurement Range MCR20 ¹ TP20	175 - 200	166	225 - 400	166	525 - 550	166
Measurement Range MCR20 ¹ TP200	175 x 200	170	325 x 400	170	525 x 550	170
Measurement Range MCR20 ¹ Vision AF	225 x 200	200	375 x 400	200	575 x 550	200
Minimum Readout			0.1	μm		
Max Workpiece / Guaranteed Acc. Weight	15kg	15kg / 5kg 40kg / 20kg		50kg / 30kg		
Measurement Uncertainty ² E _{UX} /E _{UY}	2+8L/1	2+8L/1000 μm 2+6L/1000μ			000µm	
Measurement Uncertainty ² E _{UXY}	3+8L/1	000 µm	3+6L/1000µm			
Measurement Uncertainty ² E _{UZ}	3+L/5	0 μm ³	3+L/100µm ³			
Camera		1/3" 3CCI	O color; Progre	essive scan (B/	W Option)	
Working Distance		7	3.5mm (63mm	with Laser A	F)	
Magnification		Optical	: 0.35 to 3.5x;	On screen: 12	to 120x	
Field of View			13.3x10mm	to 1.33x1mm		
Auto Focus			Vision AF; La	ser AF Optior	1	
Illumination	Contou	r and Surface:	White LED; O	blique: 8-Seg	ment White LE	D Ring
Video Resolution			640x48	0 pixels		
Power Supply / Consumption	Single pha	se AC 100 to 2	240V±10%. Gr	rounding requi	ired. 50/60Hz. /	5 to 2.5A
Machine Dimensions WxDxH / Weight	565x690x74	0mm / 72kg	1000x1340x1	553mm/500kg	1200x1640x15	53mm/665kg
Controller Dimensions WxDxH / Weight	145x400x39	00mm / 13kg	145x400x39	0mm / 13kg	145x400x39	0mm / 14kg
Table Dimensions WxDxH / Weight	600x700x825mm / 38kg Included in Main Body Weight					t
Operational Environment		Temperat	ure: 10 to 35°C	C; Humidity: 7	0% or less	

¹ The iNEXIV dedicated MCR20 can be used for both TP20 and TP200. ² Nikon's in-house test at $20^{\circ}C\pm0.5K$, where L = Length in mm. ³ With Laser AF or Touch Probing.

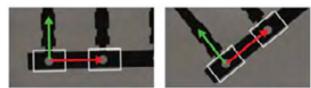
NEXIV VMZ-S Series NEW! Real-Time FOV Confocal Measurements



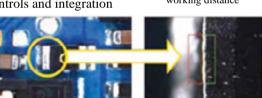


VMZ-S4540

- Measure various samples in the expanding market of in-vehicle electronic components and semiconductors, as well as in precision machined and molded parts
- Nikon's proprietary linear encoder with $0.01 \mu m$ resolution, built as standard into all axes to accurately detect linear position
- Improved measurement efficiency with image processing program and high-performance electric motor stage
- Eliminate operator measurement variations with highly repeatable measurements independent of operator subjectivity and experience
- Highly accurate, high speed height measurements made possible with the high accuracy TTL laser AF capable of high-speed scanning at 1000points/s
- · Detect difficult edges and features with multiple illuminations
- Non-stop automatic measurements for various samples
- Easy to use, streamlined NEXIV AutoMeasure software suite
- · Automation of the production floor with multiple NEXIV controls and integration



Non-stop automatic measuring



Possible to measure difficult samples

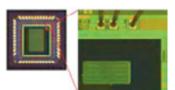
	VMZ-S3020	VMZ-S4540	VMZ-S6555			
Stroke XxYxZ Standard	300x200x200mm	450x400x200mm	650x550x200mm			
Stroke XxYxZ TZ at Low Mag	250x200x200mm	400x400x200mm	600x550x200mm			
Minimum Readout	0.01µm					
Maximum Workpiece Weight in kg	20 (Accuracy guaranteed: 5)	20 (Accuracy guaranteed: 5) 40 (Accuracy guaranteed: 20) 50 (Accuracy guaranteed:				
Measurement Uncertainty ¹ E _{UX} /E _{UY}		$1.2+4L/1000\mu m$				
Measurement Uncertainty ¹ E _{UXY}		2+4L/1000µm				
Measurement Uncertainty ¹ E _{UZ}		1.2+5L/1000µm				
Probing Error ^{1, 2}	MPE P _{F2D} 0.8µm					
Probing Error of Imaging Probe ^{1,2}	MPE P _{Fv2D} 0.3μm					
Camera	Black & white / Colour 1/3 CMOS Camera					
Working Distance	Types 1-3: 50mm / Type 4: 30	0mm / Type TZ: 11mm / Type	A: 73.5mm (63mm Laser AF)			
Autofocus	Laser	AF (Option for Type A) / Ima	ge AF			
Laser AF Repeatability Range ^{1, 3}		$2\sigma \le 0.5 \mu m$				
Types 1, 2, 3 Illumination	Episcopic, diascopic	e, and 8-segment ring with 3 an	gles *All white LED			
Type 4 / A Illumination	Episcopic, diascopic	c, and 8-segment ring with 1 ar	ngle *All white LED			
Type TZ Illumination	Episcopic/darkfield for bot	h Left/Right objective lens. Al	so diascopic for Right lens.			
Power Source / Consumption	A	C 100 to 240V, 50/60Hz / 4 to 2	2A			
Dimensions WxDxH / Weight	700x730x1793mm / 265kg	1000x1340x1818mm / 510kg	1200x1640x1818mm / 740kg			
Controller Dimensions/Weight		190x450x450 / 12kg				
Footprint	2700x2400mm	3000x3000mm	3200x3300mm			

¹ Determined by Nikon in-house measurement method. ² With 15x Type 2 head. ³ Workpiece: Chrome on calibration plate, without Type A head. ⁴ Includes maintenance space.





Significantly improved measurement efficiency



Capable of high resolutions at long working distance





NEXIV VMZ-H3030 High Precision NEXIV Model

Achieves Measurement at the Highest Precision of the NEXIV Series; Advanced Usability and Performance.



VMZ-H3030

- Highest precision NEXIV model at 0.6+2L/1000µm
- 5 types of optical zoom systems for different fields of view and resolution requirements
- 8-segment white LED ring illuminator with 3 incident angles to accurately capture edges
- Easy to use, streamlined software with customizable GUI and versatility
- Applications include molds, mechanical parts (household, automobile), PCB, electronic parts, ceramic parts, electronic parts, high density package substrate, and wafer pattern

X x Y x Z Stroke	300 x 300 x 150mm			
Minimum Readout	0.01µm			
Maximum Sample Weight	30 kg (Accuracy guaranteed: 10kg)			
	Eux,мре, Euy,мре: 0.6 + 2L / 1000µm			
Maximum Permissible Error (Samples <20kg)				
	E _{UZ,MPE} : 0.9+L / 15μm			
Accuracy Guaranteed Temperature	$20^{\circ}C \pm 0.5K$			
Maximum Driving Speed XY, Z	100mm/s, 50mm/s			
Minimum Driving Speed XY, Z	0.01mm/s, 0.001mm/s			
Camera	1/3" Black and White CCD, 1/3" Color CCD			
Camera	* Color camera option is available only with Type 1, 2 and 3			
Working Distance	Type 1, 2, 3: 50mm (10mm when using 75° LED illumination) / Type 4: 30mm			
Working Distance	Type TZ: 31mm (low magnification), 11mm (high magnification)			
	Type 1: 0.5-7.5x/9.33 x 7.01-0.622 x 0.467mm			
	Type 2: 1-15x/4.67 x 3.5-0.311 x 0.233mm			
Magnification and FOV	Type 3: 2-30x/2.33 x 1.75-0.155 x 0.117mm			
	Type 4: 4-60x / 1.165 x 0.875-0.078 x 0.058mm			
	Type TZ: 1-120x/4.67 x 3.5-0.039 x 0.029mm			
Autofocus	Vision AF, Laser AF			
	Type 1, 2, 3, and 4 Episcopic, diascopic, and 8-segment ring with 3 angles			
Illumination	* All white LED/Type 4 has only 1 angle			
	Type TZ: Episcopic, diascopic, darkfield			
Power Source	AC 100 to 240V ± 10% 50/60Hz			
Power Consumption	5 to 2.5A			
Dimensione (Wer Der II) / Weischt	Main body with table: 1000 x 1125 x 1750mm / ~500kg			
Dimensions (W x D x H) / Weight	Controller: 190 x 450 x 440mm / ~15kg			
Footprint (W x D)	3000 x 2800mm			

VMZ-H3030 Specifications



NEXIV VMZ-K Real-Time FOV Confocal Measurements

Multi-functional confocal video measuring with leading opto-mechatronics, brightfield with 15x zoom and TTL Laser AF for exceptionally fast and accurate 2D/3D inspections!



- · Simultaneous wide-area height measurements. 2D measurement with 15x brightfield zoom optics
- Handles 300mm Semicon wafers at fabs; measures complex structures such as bump heights on advanced IC packages. probe cards, precise glass micro lens, contact lens, laser marks on semicon wafers, MEMS, Wire bonding, etc.
- NWT-300 automatic 300mm wafer handling and OHT/RGV compatible - bumps and laser marks with on-line host coms; wafer retention via edge clamp or rear side vacuum method

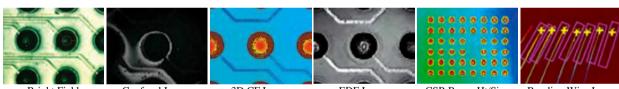


VMZ-K6555

Original low flare confocal optics

Z scan images reconstructed real time into 3D contour map and EDF images

Confocal Optics Principle – Light passing through a pinhole on a spinning Nipkow disk is reflected by the workpiece at the focal point back through the pinhole and detected as a very narrow DOF confocal image by the camera. Multiple images sampled as the focal plane is moved vertically are combined into a confocal image with height information via interpolation technology.



Bright Field

Confocal Image

3D CF Image

EDF Image

CSP-Bump Ht/Size

Bonding Wire-Loop Ht

VMZ-K3040 / K6555 Specifications

Objectives	3x	7.5x	15x	30x	
Objective Lens Working Distance	24mm	5mm	20mm	5mm	
Confocal Optics Field of View	4x3mm	1.6x1.2mm	0.8x0.6mm	0.4x.3mm	
Confocal Height Measure Repeatability (20)	0.35µm	0.25µm	0.25µm	0.20µm	
Confocal Height Measurement Resolution		0.01	μm		
Brightfield Optics 2D Measure Zoom Method		Motorized 5	5-step zoom		
Brightfield Optics Field of View	4x3 to 0.27x0.2mm	1.6x1.2 to 0.11x0.08mm	1.26x0.95 to 0.1x0.074mm	0.63x0.47 to 0.05x0.04mm	
Illumination	White LED diascopic and episcopic illuminator for all types, White LED ring light for type 3x and 7.5x				
Auto Focus	Visio	n AF and TTL laser.	AF (Scan Mode avai	lable)	
X x Y x Z Stroke/Load Capacity		800 x 400 x 150mm / 800 x 400 x 150mm /		· · · · · · · · · · · · · · · · · · ·	
Measurement Uncertainty 1 EUX/EUY		1.5+4L/	1000µm		
Measurement Uncertainty 1 EUXY		2.5+4L/	1000µm		
Measurement Uncertainty 1 EUZ		1+L/10)00µm		
Machine Footprint / Weight	VMZ-K3040: 2500 x 1600mm / 850kg VMZ-K6555: 2500 x 1900mm / 830kg				
Power Supply / Consumption	Single phase AC 100 to 240V±10%. Grounding required. 50/60Hz. / 13 to 6.5A				
Operating Conditions	Temp	perature: $20^{\circ}C \pm 0.5$	K, Humidity: 70% or	r less	

¹All measurement uncertainties are given in MPE per ISO 10360.



ECLIPSE LV-N Industrial Microscopes

- Modular industrial applications including semiconductor devices, packaging, FPDs, electronic components, materials, and precision moulds
- New optical system and evolutionary features
- Four motorized and three manual dedicated reflected illumination and combined reflected/transmitted illumination observation types
- Nikon's unique high Numerical Aperture with long Working Distance now evolved with chromatic aberration correction and lighter weight
- Digital Sight System Camera 8.4" HD touch panel monitor allows digital image acquisition without a PC or computer monitor
- · Option: nosepiece motorization for efficient image capture and observation
- Observation via brightfield, darkfield, polarizing, differential interference, epi-fluorescence and two-beam interferometry



Universal standard objectives for brightfield, darkfield, simple/sensitive polarizing, differential interference, epi-flourescence



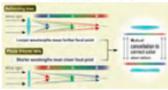


Objective lenses with glass thickness correction for high contrast observation of cells or patterns, unaffected by glass substrate



Eclipse LV100ND

Phase Fresnel Lens



Colour abberation correction with phase Fresnel lens enable longer working distances than with conventional lenses

	LV150N	LV150NA	LV100ND	LV100NDA		
Max Sample Height	38mm (LVNU5AI U5AI nosepiece + LV-S32 3x2/LV-S64 6x4 stage) 73mm (one column riser)		38mm (LVNU5 U5 nosepiece + LV-S32 3x2/LV-S64 6x4 stage)	33mm (LVNU5AI U5AI nosepiece + LV-S32 3x2/LV-S64 6x4 stage)		
Illumination		12V/50W Precentered lamphouse				
Base Unit	Left: coarse and fine adjustment; Right: fine adjustment, 40mm stroke; Coarse adjustment: 14mm/tu (with torque adjustment, refocusing mechanism); Fine adjustment: 0.1mm/turn (1µm/graduation)					
Nosepieces	C-N6 ESD; LV-NU5; LV-NBD5 BD; LV- NU5I	LV-NU5A; LV-NU5AC	C-N6 ESD; LV-NU5; LV-NBD5 BD; LV- NU5I; D-ND6	LV-NU5AI		
Episcopic Illuminator	LV-UEPI-N	; LV-UEPI2	LV-UEPI-N; LV-UEPI2	LV-UEPI2A		
Diascopic Illuminator		-	LV-LH50PC			
Eyepiece Tubes	LV-TI3; LV-TT2 TT2	2; C-TB; P-TB; P-TT2	LV-TI3; LV-TT2 TT2; P-TB; P-TT2			
Stages	LV-S32 3x2; LV-S	64 6x4; LV-S6 6x6	LV-S32 3x2; LV-S32SGH; LV-S64 6x4; LV-SRP P; NIU-CSRR2 Ni-U; C-SR2S			
Condensers		-	LWD Achromat, LV-CUD U dry, Achromat 2 to 100x slide, DF dry			
Eyepieces		CFI eyep	iece series			
Objective Lenses	Industrial Microscope CF	160-2/CFI60 series objecti	ve lens: Combination in ac	cordance with the method		
ESD Performance	10	000 to 10V within 0.2sec (e	excluding certain accessori	es)		
Power Consumption		1.2A/75W		1.2A/90W		
Weight	8.6kg	8.7kg	9.5kg	10kg		

ECLIPSE MA100N/MA200 Flexible, Modular, Inverted Microscope

- Strong, compact, robust construction with dedicated LED illuminator providing long life, low power consumption and diffused illumination
- Long working distance as standard with CFI60-2 phase Fresnel lens
- Colour aberration correction for greatly reduced colour distortion and excellent image quality with CFI60-2
- Materials cast iron analysis according to JIS G5502, ASTM A247-06 and ISO945-1 standards with NIS-Elements Software
- Grain size analysis according to JIS G0551, ASTM E112-13, E1382-97, ISO643 and GB/T 6394 standards with NIS-Elements Software
- · Ideal for metallurgical material inspection in many industrial applications



Nikon

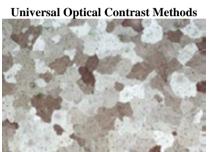
Nikon ECLIPSE MA100N



Modular Component Accessories

Nikon CFI60-2 Optical Series





Selected optical components match the user's applications

Provides long working distance capability with an advanced chromatic aberration correction system

Reflected light: brightfield, darkfield, polarising and differential interference contrast without the need for sample levelling

	MA100N	MA200
Optics	CFI60/CFI60-2 system	CFI60 /CFI60-2 system
Observation Image	Reversed image	Surface Image
Observation Method	Brightfield and polarization (with MA P/A simple polarizer/analyzer set)	Bright/Darkfield/Simple Polarizing/DIC/Epi-Fluorescence
Focusing	Focusing nosepiece (Fixed stage), coaxial coarse/fine adjustment knob with 8.5-mm stroke (Coarse adjustment of 37.7mm per turn, fine adjustment of 0.2mm per turn)	Focusing nosepiece (Fixed stage) Coaxial coarse/fine adjustment knob (torque adjustable) (Coarse adjustment of 4.0 mm per turn, fine adjustment of 0.2 mm per turn)
Nosepiece	Brightfield 5-position nosepiece	MA2-NUI5: Bright/Darkfield/ DIC 5 position nosepiece, LV-NU5A: Motorized Bright/Darkfield/DIC 5 position nosepiece/D-NID6: Brightfield 6 position nosepiece (Intelligent), D-NI7: Brightfield 7 position nosepiece (Intelligent)
Stage	MA-SR-N; MA-SP-N; TS2-S-SM	MA-SR
Illuminator	Internal power supply white LED light source, condenser built-in (lever operated), Ø25mm filter can be inserted	With flare prevention, Built-in UV cut filter Field diaphragm, Filter, Fluorescence filter blocks
Light distribution	-	Eyepiece tube/Back port: 100/0, 55/45
Binocular Body	Built-in Siedentopf binocular, 45 inclination angle and 50 to 75-mm interpupillary adjustment, attachable camera port, eyepiece/Port: 100/0:0/100	-
Trinocular Eyepiece		Siedentopf, interpupillary distance adjustment 50-75mm
Power Input		100-240 V, 50-60 Hz
Power Consumption	Max 15W	1.2A, 75W
External Dimensions	229x551x404mm (WxDxH)	439x521x428mm (WxDxH)
Weight	Approx. 10kg	Approx. 26 kg (depends on combination)

Cairnhill Metrology

SMZ Versatile to Advanced Stereo Microscopes

- · High mag hi-res observation of minute structures
- Improved chromatic aberration correction for bright, sharp images throughout viewfield through use of semi-Apochromat optics
- · Ergonomic parallel optics to accommodate various observation attachments
- Wide zoom ratio of 8:1 for high res observation of 640LP/mm with high numerical aperture ED Plan Apo 2x/WF at max zoom
- Objectives available: From high-NA, high-res wide-viewfield Plan Apo WF with superior image and chromatic aberration correction to 0.75x low mag
- Double nosepiece for easy on-axis imaging, for observation of bottom of holes and distortion-free extended depth-of-focus imaging
- Wide range of accessories and controls
- Highest-in-class 12.7x zoom for low mag. wide view field observation of a whole 35mm petri dish (with 1x objective at lowest mag) during screening and high-magnification observation of minute cell structures
- New WF objectives for uniformly bright images even at low magnification and wide viewfield observation when used with the SMZ1270/1270i
- New 0.75x objective, expanding the low magnification objectives lineup
- · Apochromat optics for sharp images without blur or colour fringe
- On-axis observation with nosepiece. Ergonomic expandability with a wide range of accessories. OCC high contrast illumination of transparent samples
- Intelligent status readout calibration automatically follows magnification changes to display correct scale and measured results on the images



moox x63.0



SMZ1270i

	SMZ1270	SMZ1270i	SMZ800N	
Optical System	Pa	rallel-optics type (zooming typ	be)	
Zoom Ratio	12.	7:1	8:1	
Zoom Range	0.63	to 8x	1 to 8x	
Total Magnification ¹	3.15 to	o 480x	5 to 480x	
With Co-ax Episcopic Illumination	15 to	22.5 to 540x		
Tubes	20° P-B Binocular Tube, 15° P-TL100 Trinocular Tube, 0 to 30° T-TERG 100 Trinocular Tilting Tube, P-TERG 50 Trinocular Tilting tube			
Eyepiece	C-W10xB (F.N. 22), C-V	W15x (F.N. 16), C-W20x (F.N	. 12.5), C-W30x (F.N. 7)	
Objectives	Plan Apo (0.5x/WF, 0.75x/WF, 1x/WF), ED Plan (1.5x/WF, 2x/WF)		Plan Apo (0.5x/WF, 0.75x/WF, 1x/WF), ED Plan (1.5x/WF, 2x/WF, 0.75x) Plan 1x, Achro 0.5x	
Working Distance	70mm (with Plan Apo 1x/WF)		78mm (with Plan 1x)	
Machine Approx. Weight	9.8kg with Binocular Tube + LED diascopic stand	11.9kg with Trinoculor tilting tube + LED diascopic stand	6.8kg with Binocular tube + plain stand	

¹Depends on eyepiece and objectives.









0.618



SMZ745 / 745T / 445 / 460 Long Working Distance and Wide FOV

Features (for both SMZ745 / SMZ745T)

- 7.5x extremely high zoom range for broad observation
- Superior 115mm working distance with high zoom ratio and magnification
- SMZ745T Trinocular optical head ideal for monitoring and digital imaging
- Airtight, anti-mold, anti-electrostatic design for robust environments
- SMZ445 (0.8 to 3.5x zoom magnification) or SMZ460 (0.7x to 3.0x zoom magnification), inclination angles of 45° or 60° respectively
- Diascopic/episcopic LED Stand to observe a wide range of specimens, from Petri dishes to plants, insects, small animals and minerals
- Auxiliary objective lens for a wider field of view and longer working distance -0.5x (WD 181mm) and 0.7x (WD 127.5mm)
- · Mold-resistant lens finish to withstand even hot, humid environments
- New All-In-One LED Stand. Other stand options: plain and diascopic stand S
- · Achieve high quality images with superior flatness
- · Multicoatings on lens surfaces provide clear, bright and high contrast images
- · Long 100mm working distance for safe focusing of uneven specimens

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	2	3

SMZ745/SMZ745T



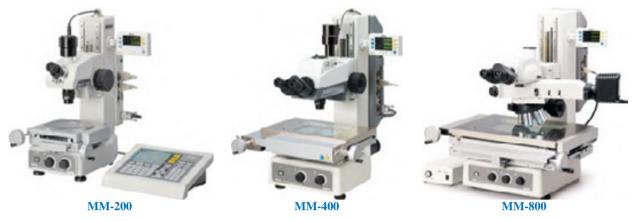
SMZ445/SMZ460

	SMZ745	SMZ745T	SMZ445	SMZ460
Optical System	Greenough Type (Zooming Type)	Greenough Type (Zooming Type), Trinocular Tube	erect image, 12° inne adjustment of right and	ve optical system. True er bevel, independent left eyepieces, and 54 to llary adjustment
Zoom Ratio	7.	5:1	4.4:1	4.3:1
Zoom Range	0.67-5x (with 0.6	7/1/2/3/4/5x stops)	0.8x to 3.5x	0.7x to 3x
Total Magnification ¹		on eyepiece and auxiliary ve used)	8x to 35x (4x to 70x by replacing eyepiece and/or auxiliary objective lens)	7x to 30x (3.5x to 60x by replacing eyepiece and/or auxiliary objective lens)
Straight Tube	-	Built-in C-mount 0.55x magnification lens, compatible with 2/3 in. or smaller CCD		-
Eyepiece Inclination		45°		60°
Eyepiece	C-W 10xB, C-W 152	x, C-W 20x, C-W 30x	SM 10xB eyepieces eyepieces (F.N.14), SM 2	(F.N. 21), SM 15xB 20xB eyepieces (F.N. 12)
Auxiliary Objective Lens	G-AL 0.5x, G-AL 0.7x, G-AL 1.5x, G-AL 2x, G- AL ERG 0.77-1.06x		G- AL0.5x, 0.7x Option	
Working Distance	115mm			figuration), 127.5mm mm (AL0.5x)
Zooming Body Weight	1.6kg	1.8kg	Approx	x. 1.0kg

¹ Depends on eyepiece and objectives.



MM Next-Generation Measuring Microscopes



 Accuracy; Digital Imaging and Vision Processing Metrology. Improved Body Strength for Larger Workpiece Stages. 3 Model Sizes for 2D or 3D, Monocular, Trinocular or Video Head, Z-Axis scale (manual or motorized), Variable Magnification, High Magnification and with choice of Nikon or third-party DRO or Software

o Non-Contact Z-height Measurements; Coordination with Data Processing Systems

o Optional TTL Laser AF and new Focusing Aid for more accurate Z-Axis focus and measurement

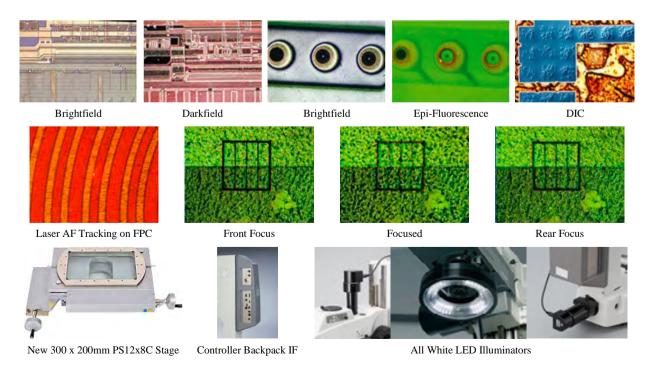
o Nikon Digital Camera Image Capture with E-Max auto-edge detection Metrology Software

o Stands with Integrated Controller interface to DP-E1 Data Processor, SC counters and E-Max software

o Choice of Manual or Motorized Illuminators with 12V/50W Halogen light option, 8-Segment LED Ring Light

LV-U EPI1Universal Epi-Illuminator for brightfield, darkfield, simple polarizing, and DIC observationsLV-U EPI21Universal Epi-Illuminator auto sets optimum illumination through shutter field and aperture diaphragm linkLV-U EPI2A1Motorized Epi-Illuminator allows optimum image capture conditionsLV-U EPI FAUniversal Epi-Illuminator with Focusing Aid provides for greater Z-Axis accuracyLV-EPI LEDWhite LED Illuminator maintains constant colour temperature to prevent adverse effects on measurement

¹TI-PS100W power supply required





2D MM Series Measuring Microscopes Summary

MM-200 Compact, cost-effective, with monocular optical or C-mount video head						
MM-800/400 Popular Sizes, with monocular/trinocular optical head						
MM-800/400U	High Power Magnification for measuring fine geometries					

* MM800/400/S instead of MM800/400 available for use with third party DRO (Quadra-Chek, MetLogix)

MM-200 Compact Shop Floor Measuring Microscopes

	MM-200							
Optical Head	Monocular Eyepiece Tube	C-Mount Video Head						
X x Y x Z Stroke	50x50x110mm							
Stage Accuracy	2.5+L/50µm (with LEC), 3+L/50µ	2.5+L/50µm (with LEC), 3+L/50µm (L=measurement length in mm)						
Scale Resolution	0.01/0.1(default)/1/10µm							
Max Sample Weight	2kg for guaranteed accu	2kg for guaranteed accuracy, 5kg for operation						
Magnification Accuracy	0.1	%						
Objective Lenses (WD)	Standard: 3x (75.5mm), Optional: 1	Standard: 3x (75.5mm), Optional: 1x (79mm), 5x (64mm), 10x (48mm)						
Illumination	Standard: diascopic/episcopic (white LED), O	Optional: 8-segmented ring light (white LED)						

MM800/400 and /U Measuring Microscopes

	MM-800/400	MM-800/400/U				
Description / Application	Cost performance model for dies and molds, stamped parts, fine machined parts	High power magnification models for Semicon packages, MEMS, FPD, HDD				
Z-Axis Movement	Manual (dual side co	parse/fine focus knob)				
MM Controller Backpack I/F	Built-in					
Optical Heads	Monocular or Trinocular optical head	C-TB binocular tube, LV-T13 trinocular eyepiece tube, LV-TT2 tilting trinocular eyepiece tube with built-in reticle				
Eyepiece (all Field No 20)	Dedicated 10x	CFI10x, CFI10x CM				
Objective	Measuring microscope objectives	CFI60-2 TU Plan Fluor EPI and Fluor BD series, and CFI60 L Plan EPI CR series				
Diascopic Illumination	LED diascopic illuminator (standard),	12V/50W halogen light source (option) ¹				
Episcopic Illumination	LED episcopic illuminator	LV-EPI LED, LV-U EPI2A ¹ , LV-U EPI2 ¹ , U- EPI ¹ and LV-U EPI FA				

^{1.}TI-PS100W power supply needed.

MM – Basic Dimensions and Stages (2D and 3D)

	MM-200	MM-400	MM-800
Workpiece Measuring Height	110mm	150mm	200mm
Machine Dimensions ¹ W x D x H	316 x 455 x 533mm	300 x 600 x 638mm	385 x 785 x 725mm
Machine Weight	40kg	50kg	72kg

Stages	PS 2x2B	PS 4x4B	PS 6x4B	PS 8x6B	PS 10x6B	PS 12x8C	
Applicable Models	MM-200, MM-	400 and only MN	1-800LV/LVFA	All MM-800 Models			
X x Y Travel Stroke	50 x 50mm	100 x 100mm	150 x 100mm	200 x 150mm	250 x 150mm	300 x 200mm	
Glass Stage Area	Ø 107mm	160 x 160mm	210 x 160mm	255 x 190mm 305 x 190mm		330 x 230mm	
X-Y Table Surface	Ø 174mm	284 x 230mm	350 x 230mm	348 x 260mm	448 x 320mm		
Scale		Linear En	coder, 0.0001mm	n Resolution (Min	n reading)		
Swivel Plate Rotation	360°	N	/A		±3°		
Tool Installation	6-M6 depth 7	8-M6 depth 10		10-M6 depth 10	12-M6 depth 10	16-M6 depth 10	
Max Sample Weight	5kg	15	kg		20kg		
Approx. Stage Weight	15.5kg	23.5kg	27.5kg	49kg	49kg 52kg		

¹Dimensions are approximate, varying depending on stage selected. Applicable for both 2D and 3D Measuring Microscope systems.



3D MM Measuring Microscopes Summary

MM-800/400L Built-in Z-Axis scale and Optional Focussing Aid						
MM-800/400LU	Universal Epi-Illuminator and Optional 12V/50W halogen or LED light					
MM-800/400LM	Motorized Z-Axis scale built-in and Optional Focussing Aid					
MM-800/400LMU	High Power Magnification with Motorized Universal Epi-Illuminator					

* Additional corresponding models with additional S suffix are for use with third party DRO (Quadra-Chek, MetLogix) or software; i.e. MM800/400/SU instead of MM800/400U; SL instead of L; and SLU instead of LU.

MM800/400/L, /LV, /LVFA and /LM 3D Measuring Microscopes

	MM-800/400/L	MM-800/400/LV	MM-800/400/LVFA	MM-800/400/LM			
Z-Axis Movement	Manual (cus knob)	Motor (max 10mm/s)				
MM Controller Backpack I/F	Built-in	N/A Built					
Optical Heads	Monocular, Trinocular, Trinocular optical FA						
Z-Axis Linear Scale	Built-in	N	N/A Built-in				
Eyepiece		CFWN10x (Field No 20)					
Objective		Measuring micro	oscope objectives				
Objective Lens Mag (WD)	N/A	1x (79mm), 3x (75m (48mm), 20x (20mm (4n	N/A				
Diascopic Illumination	LED diascopic illuminator (standard), 12V/50W halogen light source (option) ¹						
Episcopic Illumination	LED episcopic illuminator						

MM800/400/LU and /LMU High Power Mag 3D Measuring Microscopes

	MM-800/400/LU	MM-800/400/LMU				
Description / Application	High power magnification models for Semicon packages, MEMS, FPD (LCM), HDD sliders					
Z-Axis Movement	Manual (dual side coarse/fine focus knob) Motor (max speed 10mm/s)					
MM Controller Backpack I/F	Built-in					
Optical Heads	C-TB binocular tube, LV-T13 trinocular eyepiece tube, LV-TT2 tilting trinocular eyepiece tube					
Z-Axis Linear Scale	Bui	lt-in				
Eyepiece (all Field No 20)	CFl10x, CFI10x (CM (Field No 20)				
Objective	CFI60-2 TU Plan Fluor EPI and TU Plan Fluor	or BD series, and CFI60 L Plan EPI CR series				
Diascopic Illumination	LED diascopic illuminator (standard), 12V/50W halogen light source (option) ¹					
Episcopic Illumination	LV-EPI LED, LV-U EPI2A ¹ , LV-U	J EPI2 ¹ , U-EPI ¹ and LV-U EPI FA				

¹ TI-PS100W power supply required.

E-Max / DP-E1 / U-DP Measuring Software / Applications



- Direct FOV measurements automated video edge detection
- Supports illumination controls, motorized nosepiece, universal epiilluminator, and TTL Laser AF controls
- · Real-time dynamic data exchange SPC



- with Graphical Feature Oriented Operation
 - Measurement results automatically saved as teaching steps
 - · Improve accuracy and efficiency
 - pixel LCD display



- Browser-based metrology software • compatible with PDAs
- · Interactive icons and navigation enable immediate operation
- 0.1 μ m reading counter on 320x240 2-1 skew alignment, point, circle and point to line distance measuring tools



Digimicro Series Digital Length Measuring System

• Available in 3 high accuracy models

		MF-1001	MF-501	MH-15M
Measurement Length		0 to 100mm	0 to 50mm	0 to 15mm
Minimum	MFC-200	0.1µm (can be switch	ned to 0.5µm or 1µm)	-
Reading	TC-200	0.01µm (can be swi	tched to 0.05µm, 0.1µm	, 0.5μm, 1μm, 5μm)
Guaranteed	Accuracy at 20°C	3µm	3μm 1μm	
Max Speed		500r	100mm/s	
Measuring Force		Down 1.23 to 1.81N Down 1.13 to 1.62N Lateral 0.64 to 1.23N Lateral 0.64 to 1.23N		Up 0.25N Down 0.64N Lateral 0.44N
Operating T	emperature		0 to 40°C	
Weight		480g 310g		220g
Compatible Counters		MFC-200, TC-200		TC-200
Compatible	Stands	MS-12C, MS-22S,	MS-51C	



Digital Sight 1000 NEW! All-in-One, High-Definition Model

- · Equipped with 2MP CMOS sensor, displays at 30fps, captures, and saves FHD 1920x1080px images to the built-in SD card slot
- · Built-in overlay scales and reticles
- · Control and view easily with NIS-Elements L (tablet PC version)
- PC-Free Operation
- Standard functions: side by side image comparison, circle distance, parallel line, polygon display, calibration, scale bar, angles, concentric circles, freehand line, rectangle, coordinate data, measurement result storage, perpendicular distance, and line and circle display

DS-Fi3 Digital Cameras for Microscopes

- High resolution images with CMOS high density 5.9MP sensor
- USB3.0 data transfer for fast focusing with high resolution, and easy image capture in all types of observation contrast methods such as brightfield, darkfield, differential interference, and phase contrast
- · Interfaces with PC computers via a USB3.0 interface directly to the camera head with NIS-Elements series software for image acquisition

Digital Sight 10 Wide FOV at Ultra-High Definition 6K Resolution

- · Enables unprecedented 6K ultra-high definition, capturing microscopic images at up to 6000x3984 pixels (23.9MP)
- · Achieves up to 357fps directly from sensor area
- · Easy switching between colour and monochrome modes using the imaging software by a motorized hands-free process



Digital Sight 1000



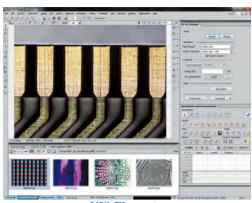


Digital Sight 10

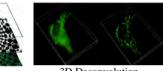


NIS-Elements Total Software Solution for Image Capture, Archiving, Analysis

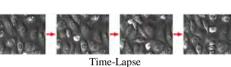
- Integrated Nikon comprehensive microscope control, image capture, analysis, documentation and data management
- Intuitive feature set / large multi-dimensional image files database
- 3 Packages: 1) AR for Advanced Research applications: 2) BR for Basic Research applications; and 3) D for colour Documentation for bioresearch, clinical and industrial applications
- Multi-layer structure for non-destructive archiving of image date
- · Combine X, Y, Z, Wavelength, Time, and Multi Stage Points within one integrated platform for multi-dimensional imaging
- High accuracy Time Lapse Imaging capture without focus drift even for long experiments with motorized inverted microscope
- Large Image Acquisition generates high-mag wide FOV images via automatic stitching of multiple adjacent frames acquired with a motorized stage or from images captured from previous sessions
- · High Dynamic Range Image Acquisition creates images with appropriate dark and bright regions brightness by combining images with different exposures or using multiple images
- · Deconvolution options to remove fluorescence image haze and blur
- · Dedicated High-Content Acquisition and Analysis Module for automated acquisition and analysis of multiple high-content, multidimensional images via integrated control of high-speed motorized focus, Ti-E inverted stage, camera and peripheral devices



NIS-Elements

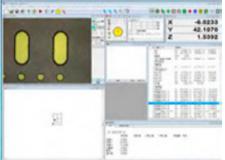


3D Deconvolution Multi-layer document structure



AutoMeasure Measurement and Control Software for NEXIV/iNEXIV

- Interactive, customizable measurement and teach wizards with online CAD interface. CAD data can be read into a Virtual Video Window on separate PC for off-line teach programming without actual workpiece
- NEXIV Profiler allows you to measure and judge 2D profile shapes in a workpiece that cannot be measured in the normal geometric mode
- VMR Report Generator (AutoMeasure compatible) for quick, powerful inspection reports generation in standard or customizable formats
- VMR Control for multiple teach files to sequentially measure different workpieces continuously. Separable system admin and inspector environments for dates of manufacture and inspection, lot number, etc.



Measurement wizards



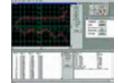
Main program layout



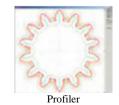
NEXIV Virtual AutoMeasure



Digital Chart Comparator



Constant pitch profiling (XY plane)





CAD graphic window



3D Metrology Simulator

AutoMeasure



Vertical Profile Projectors with Superb Image Accuracy!



- Focusing mechanism by up/down moving of objective Large effective Ø 500mm screen head for long cross travel up to 250x150mm with adjustable base 2mm from surface to isolate vibration
- Max workpiece height of 100mm
- Built-in digital counter and protractor and rotating or Built-in half mirror eliminates adjusting illumination fixed screen selections
- · Erect and unreversed images as sharp as reversed
- Built-in vertical/oblique switchable surface illumination for improved edge detection in resin, etc.
- 4-step zoom condenser lens controls light to suit the projection lens mag (DIA required for 200/500X mag)



- Built-in digital counter and protractor
- Par focal long working distances projection lenses (5, 10, 20, 50, 100X)
- for each magnification change
- · Excellent improved images at eye-point height
- . Up to 20kg workpiece for 10x6 stage with 250x150mm measurable range
- Stage Adapter S to mount other than the 10x6 Stage

	V-12B	V-20B		
Туре	Bench	Floor Standing		
Screen Diameter and Image	Ø 305mm, erect and unreversed	Ø 500mm, inverted and reversed		
Screen Type	DC/D: Digital protractor with etched center crossline, 360° rotation, 1min arc fine knob SC/S: fixed screen without rotation	protractor screen; inclined 8°		
Lens Mount	3-lens turret mount; clamping	3-lens turret mount; screw type		
Projection Lens	5/10/20/25/50/100/200/500x	5/10/20/50/100x		
Magnification Accuracy (Illumination Dependent)	±0.1% for oblique surface/contour; ±0.15% for vertical surface	$\pm 0.1\%$ for contour; $\pm 0.15\%$ for surface		
Illumination	Bright 24V/150W halogen f	or both Contour and Surface		
Max Workpiece Height	100mm (70mm for 10x6 Stage)	150mm		
Stages	10x6, 8x6, 6x4, 4x4, 03L or 2x2. V-20B: 10x6 direct mountable; Rest mountable adapter. For V-12B all direct mount			
XY Counter	DC and SC – Built-in (1.0/0.5µm selectable); D/S Not provided	Built-in digital counter		
Power Supply	AC 100 to 120V, 22	0 to 240V, 50/60Hz		
Machine Dimensions W x D x H	409 x 648 x 970 to 1070mm	570 x 1200 x 1900mm		
Machine Weight	Approx. 80kg	260kg		



GTR-Series Double Flank Gear Rolling Testers



GTR-4LS

- Efficient and fast measuring of total accuracy of various sizes of gears such as fine pitch gears and small and medium size gears with center distances of 11 to 130mm, applicable to cameras, clocks, computer peripherals, printers and audio devices
- Windows[®] 10 software for computing tooth-to-tooth composite error, total composite error, tooth bearing, nick, run-out and backlash in both analogue and digital grading. Compliance with ISO, JIS and AGMA standards
- Linear scale for setting distance between two centers and measuring a test radius. Various outputs including linear and circular graphs. Optional Accessories master gear, gear with shaft measuring/bevel gear equipment.

	GTR-4LS	GTR-25	GTR-60	GTR-30					
Measuring Item		Do	uble Flank Rolling	Гest					
Gears to be Measured		Spur and Helical Gear / Ring Gear, Gear with Shaft							
with Optional Equipment	Bev	Bevel Gear / Cross Axis / Worm and Worm Wheel / Internal Gear							
Center Distance	11 to 130mm	105 to 250mm	110 to 400mm	120 to 600mm	58 to 300mm				
	N/A	25 to 170mm 30 to 320mm		40 to 520mm	38 to 300mm				
with Optional Equipment	N/A	70 to 215mm	75 to 365mm	85 to 565mm	N/A				
Measuring Pressure	±600g		-10 to +2.5kg		0 to 2.5kg				
Spindle Motor Drive	N/A	0.5 to	9rpm	0.4 to 4rpm	6rpm				
Machine Basic Size in mm	470 x 230 x 391	925 x 456 x 472 1010 x 540 x 460		2060 x 918 x 1071	830 x 325 x 360				
Machine Weight	50kg	300kg 450kg 2200kg 120kg							
Power Supply / Consumption	Single	Single phase AC 100V±10%. Grounding required. 50/60Hz±1Hz. / 1kVA							

Master Gears												
Module	0.2	0.25	0.3	0.35	0.4	0.45	0.5	0.6	0.7	0.8	0.9	1.0
P.C.D. mm	38.0	38.0	38.4	38.5	38.4	38.2	38.0	38.4	38.5	38.4	37.8	38.0
Inner Dia/Tooth Width		12.7/12.7mm										
Outer Ø in mm	38.4	38.5	39.0	39.2	39.2	39.1	39.0	39.6	39.9	40.0	39.6	40.0
No of Teeth	190	152	128	110	96	85	76	64	55	48	42	38

AG-230 Automatic Gear Selecting Machine

Digital display of OK/NG for measuring value of double flank rolling test against pre-set tolerance for nick, runout and size in real-time basis with high accuracy.

 Master Gears

 For standard use pressure angle 20° or 14.5°. Inner Diameter Ø 32 with tooth width 20

 Module
 No of Teeth
 P C D

Module	No of Teeth	P.C.D.	Module	No of Teeth	P.C.D.
1.75	45	78.75	3.0	38	114.0
2.0	40	60.0	3.5	32	112.0
2.25	36	81.0	4.0	28	112.0
2.5	32	80.0	5.0	30	150.0
2.75	42	115.5	6.0	26	156.0





CLP Series CNC Gear Measuring Instrument NEW!



- Newest Type F models with 60% reduced pitch measuring time with the new DSA-60R2 detector by measuring left and right within one rotation gear
- Newest Detector DSA-60R2 with optical encoder built-in to improve detection sensitivity
- Full CNC model for measuring tooth profile, lead, pitch, etc.
- CLP-35SF/DDSF CNC Gear Measuring Instruments for efficient, reliable measurement of tooth profile, lead, pitch and runout of gears for high performance transmissions and powdered metallic or precision plastic gears
- Fully automated from measurement to analysis of results. Windows[®] 10 based software for measurement of pitch and profile deviation and helix form deviation and various other gear measurement applications















Internal Gears

Shaving Cutters Master Gears

Worms

Worm Wheels

Plastic Gears

	CLP-15SF	CLP-35SF	CLP-35HF	CLP-65F	
Measuring Item/Number of Teeth	Tooth profile, lead, pitch (single, adjacent, cumulative), runout (spur and helical gear including internal gear)/10 to 500				
Module	M0.2 to 5	M0.5 to 12		M0.5 to 20	
Max Gear Outer Diameter	Ø 150mm	Ø 350mm		Ø 650 (Ø 850) mm	
Base Circle Diameter / Option	Ø 0 to 130mm	Ø 0 to 300mm		Ø 0 to 600/ to 800mm	
Max Tooth Width	oth Width 200mm 400mm		400mm		
Profile Measurement Tangent Length	±50mm	±120mm		±200mm	
Helix Angle	0° to $\pm 65^{\circ}$ ($\pm 65^{\circ}$ to $\pm 90^{\circ}$ with optional equipment)				
Gear Shaft Length / Extension Option	0 to 300/ to 500mm	50 to 600/ to 800mm		50 to 800/ to 1000mm	
Resolution	0.0001mm				
Machine Weight / Max Gear Weight	0.8ton / 20kg	1.5ton	/ 50kg	2.0ton / 200kg	
Dimensions W x D x H mm	842.5 x 893 x 1670	1133 x 1071 x 1995 / 1133 x 1071 x 2104		1500 x 1266 x 2118 / 1655 x 1268 x 2338	
Power Supply / Consumption	Single phase AC 100V±10%. Grounding required. 50/60Hz±1Hz. / 2kVA				

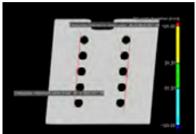


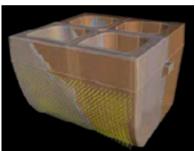
VGStudio Max CT Visualisation and Analysis Software

VGStudio is the industry-leading Computed Tomography analysis and visualisation software, processing voxel and mesh data using Windows[®] 11 multi-processor/multi-core PCs linked directly to CT scanners.

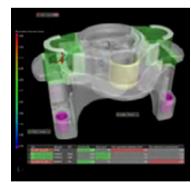
VGStudio MAX add-on modules: Coordinate Measurement, Nominal/Actual Comparison, Porosity/Inclusion Analysis, Wall Thickness Analysis, Fibre Composite Material Analysis, CAD Import with optional Product and Manufacturing Information (PMI), Foam Structure Analysis, Transport Phenomena and more!

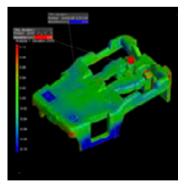
New and Improved Features in VGStudio Max 2022





- Shape-Following Adaptive Measurement Templates
- Chebyshev Fit Option for Point, Line, and Torus Geometry Elements and Combined Elements
- Color Support in STL Import and Export
- Wall Thickness Analysis Detecting Maximum Material Accumulation
- Manufacturing Geometry Correction Locking Areas during Mesh Compensation and Faster Uniform Control Point Calculation
- Structural Mechanics Simulation Importing External FE Results and Submodeling of Complicated or Large Parts
- Reporting and Traceability Comparison Tables for Coordinate Measurement Results and Absolute Reference Support for Info Fields
- Manufacturing Geometry Correction where the visualization of compensated points provides visual feedback on the results when compensating a geometry, for better interpretation of used parameters
- Compensation Mesh for Additive Manufacturing for the difference between the actual object and a reference object
- Porosity/Inclusion Analysis
- · Improved Reporting and Traceability with new integrated reporting
- Nominal/Actual Comparison with automated annotations for min./max. Deviations





MyVGL Viewer



- Free powerful CT data viewer with interactive visualisation and detailed analysis of .vgl projects created with VGStudio MAX and VGStudio.
- Analysis and annotations can be moved over entire component surface.
- Pack & Go reduces file sizes by up to 90% to allow CT data analysis results to be shared with customers and colleagues.
- myVGL import assistant options to intelligently reduce dataset size for very large data sets to be visualized on computers with limited resources

3D Analysis and Visualisation Software for CT Data

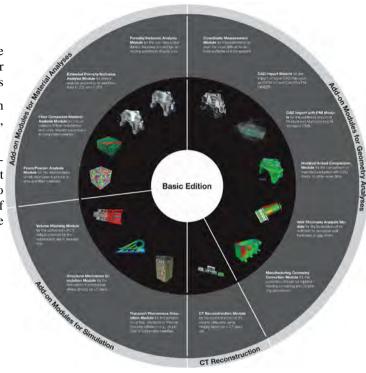


VGStudio Max Modules

Basic Edition starting point: offers innovative measuring functions, visualization and tools for manual inspections, reporting and presentations

Add-on Modules – wide and growing selection for material analysis, geometry analysis, simulation and CT reconstruction

Packages and Bundles – VGStudio MAX pre-. configured packages tailored to the most common application. Includes a VGStudio MAX license. Bundles consist of a selection of add-on modules and a one-year update/service agreement.



VG InLine Automating CT Inspections and Analyses



VG InLine - serial testing and automatic good/bad decisions

- Brings VGStudio MAX features to fully/semiautomated industrial CT in-line / at-line inspections
- Understands all reconstructed CT volumes, including older and proprietary formats of existing CT systems
- Uses VGStudio MAX macros for automated jobs and analyses incoming CT datasets from dedicated directory
- Software of choice for quick and easy part inspection with recurring analysis/visualization patterns
- Cost-effective for quality labs with growing need for an inspection solution that can handle small batch series

• Precise picture of all objects' surfaces - saves in new,

No trade-off between file size and quality of information
VGStudio MAX's full metrology and GD&T functions
Measures on voxel data, point clouds, meshes and CAD

· Easy-to-use, universal metrology solution

very compact .mvgl format

VGMetrology Maximum Precision, Minimal CT Data Set Sizes



VGMetrology



data





Wide Range of Dial Gauges Since 1916





Range: 0.8mm

Res: 0.001mm Range: 0.16mm



107-BL Res: 0.01mm Range: 10mm



Res: 0.01mm Range: 66 to 80mm



Res: 0.01mm Range: 0 to 160mm

Thickness Gauges / LA Dial Calipers / Cylinder Gauges



Res: 0.01mm Range: 0 to 10mm

G-2 Res: 0.01mm Range: 0 to 20mm



LA-7

Res: 0.01mm; Range: 0 to 60mm

Throat depth: 85mm

CC-01



Standard Digital Gauge / Digital Thickness Gauges





DG-205



G2-205



Res: 0.01mm; Range: 12.5mm Res: 0.001mm; Range: 25mm Res: 0.001mm; Range: 20mm Res: 0.001mm; Range: 20mm

Linear Gauges / Digital Counters







C-500 (Simple type) C-700 (Multi type) Displayed digits: selection of 10µm / 1µm Displayed digits: selection of 10µm / 1µm Resolution: 0.01mm; Range: 100mm

Cairnhill Metrology



Food, Pharmaceuticals and Industrial Solutions



Anritsu X-Ray Systems



Anritsu Metal Detectors



Cassel Metal Detectors



Anritsu Checkweighers



Portable Solutions



Hexagon Portable Measuring Arm







Leica Laser Tracker



OUR MANAGEMENT COMMITMENT

Our **Vision** is to be your trusted metrology solutions partner of choice via our **Mission** to support your quality quests with appropriate metrology solutions and competent pre- and post-sales technical support throughout the solutions' useful lives.

Pre- and Post-Sales Support includes: -

- Software Applications & Measuring Related Services
- Preventive Maintenance and Repairs
- · Retrofits and Upgrades of Pre-Owned Machines
- Performance Verification and Calibration

ISO/IEC 17025 CALIBRATION LABORATORY ACCREDITATION

We are certified to ISO/IEC 17025:2005 Laboratory Accreditation in Singapore, Malaysia, Thailand and Philippines by SAC-Singlas and in Indonesia by Komite Akreditasi Nasional for the calibration in general of CMMs (contact and non-contact), Surface Roughness, Contour and Roundness Testers, Profile Projectors and Universal Length Metroscopes.

Our calibration labs in Thailand, Philippines and Indonesia are also accredited for Portable Coordinate Measuring Machines complying with B89 standard, and ISO10360-12 standard for the latest model. We are also accredited for the calibration of Checkweighing systems in Singapore, Malaysia and Indonesia..

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About ISO/IEC 17025

ISO/IEC 17025 is the international standard for the competence of testing and calibration laboratories, which include meeting the requirements of ISO9001 for management system plus technical competence in testing and calibration. Calibration reports issued under the standard includes a proper evaluation of all risks and uncertainties including a budget statement of the expanded uncertainty of measurement of calibrations performed.

Our Service Department Goals

We believe that equipment maintenance is primarily our customers' responsibility while our responsibility is to support our customers. Our Service Department goals are to help ensure minimum downtime on all equipment serviced by us and deliver customer satisfaction. To do this, we identify tasks that customers can perform themselves and help them to do this; for example, by providing basic preventive maintenance training to our customers to perform first-level and urgent repairs or rectifications by themselves. This relieves us for more advanced work that customers cannot perform, where we constantly work to improve our competences and levels of capabilities in these tasks.

In this way, we walk the quality journey with our customers and so hope to become their trusted partner of choice.

Length – metre (m): the path length travelled by light in vacuum during a time interval of 1/299792458 of a second; commonly realised through the wavelength of the 633nm radiation from a helium-neon laser stabilised against a spectral line of iodine molecules, based on the formula $\lambda o = c/v$ where *c* is the speed of light in vacuum defined at 299792458 m/s and v is the measured frequency of the radiation used.

Mass – **kilogram** (**kg**): the unit of mass, equal to the international prototype of the kilogram, made of platinumiridium and kept at the International Bureau of Weights and Measures (BIPM) in Paris. International standardisation is carried out using precision comparators, combinations and sub-multiples of the 1kg masses of similar materials.

Time – seconds (s): the duration of 9192631770 periods of the radiation corresponding to the transition between the two hyperfine levels of the ground state of the caesium-133 atom; realized using caesium atomic clocks, where quantized caesium energy levels provide a source of resonance frequency, which is then phase-locked to a quartz oscillator to produce a very precise frequency (with a good long-term stability) to define the second.

Thermodynamic temperature – Kelvin (K): the unit of thermodynamic temperature (symbol T), is the fraction of 1/273.16 of the thermodynamic temperature of the triple point of water. T at 273.16 K, also defined as 0.01°C in Celsius temperature (symbol t), is realised by the use of the water triple point cells, from which other temperatures are related through the International Temperature Scale of 1990 (ITS-90).

Electric current – **ampere** (A): that constant current which, if maintained in two straight parallel conductors of infinite length, of negligible circular cross-section, and placed 1 metre apart in vacuum, would produce between these conductors a force equal to $2 \times 10-7$ Newton per metre of length; realised through the *volt* and the *ohm* representations determined using the Josephson effects of super-conductivity and the quantised Hall resistance (von Klitzing constant) respectively.

Amount of substance – mole (mol): the amount of substance which contains as many elementary entities as there are atoms in 0.012kg of carbon 12. The elementary entities must be specified and may be atoms, molecules, ions, electrons, other particles, or specified groups of such particles. The mole is most accurately realised through the determination of the Avogadro Constant by primary methods such as isotope dilution mass spectrometry.

Luminous intensity – **candela (cd)**: the luminous intensity in a given direction of a source that emits monochromatic radiation of frequency 540 x 1012 hertz and has a radiant intensity in that direction of 1/683watt per steradian; realised using a cryogenic radiometer that measures optical radiant power based on the thermo-equivalence of the heating effect of optical radiant power with that of electrical power. A solid-state photometer with a relative spectral responsivity simulating the spectral efficiency function V (λ) of the human eye, calibrated directly against the cryogenic radiometer, is used to evaluate light of other frequencies in the visible spectral region.

20 May 2019 Redefinition of the SI Units

From 20 May 2019, the SI units will be revised in terms of 7 defining constants that describe the natural world:

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 Constant Values
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Base Unit	Defining Constant		Constant Values	Unit
Kilogram kg	Planck Constant	h	6.62607015x10 ⁻³⁴	Js
Meter m	Speed of Light in Vacuum	с	299 792 458	m/s
Seconds s	Unperturbed ground state hyperfine transition freq. of Cs133 atoms	$\Delta v Cs$	9 9192 631 770	Hz
Ampere A	Elementary Charge	e	1.602176634x10 ⁻¹⁹	С
Kelvin K	Boltzmann Constant	Κ	1.380649x10 ⁻²³	J/K
Mole mol	Avogadro Constant	N ^A	6.02214076x10 ²³	mol ⁻¹
Candela cd	Luminous efficacy of monochromatic radiation of freq. $540 \times 10^{12} Hz$	K _{cd}	683	lm/W

The SI base units will then be derived from the defining constants or from 22 important derived units derived from the constants and maintained for consistency per the ISO/IEC 80000 International System of Quantities (ISQ).

The highest-level experimental methods used for the realization of units by the equations of physics are now known as primary methods. The new definitions allow freedom to choose equations of physics for the realization with the defined constants of unit quantities to be measured for limitless improvements in measurement accuracies.